

## **Series** PROFITEST MASTER PROFITEST MBASE+, MTECH+, MPRO, MXTRA, SECULIFE IP Test Instruments for IEC 60364 / DIN VDE 0100

3-349-647-03 13/10.15







![](_page_1_Figure_2.jpeg)

#### Key

#### **Test Instrument and Adapter**

- 1 Control panel with keys and display panel with detent for ideal viewing angle
- 2 Eyelets for attaching the shoulder strap
- 3 Rotary selector switch
- 4 Measuring adapter (2-pole)
- 5 Plug insert (country specific)
- 6 Test plug (with retainer ring)
- 7 Alligator clip (plug-on)
- 8 Test probes
- 9 ▼ key ON/START \*
- 10 I key  $I\Delta_N$ /compens./Z<sub>0FFSET</sub>
- 11 Contact surfaces for finger
- contact 12 Test plug holder
- 13 Fuses
- 14 Holder for test probes (8)

#### Connections for Current Clamp, Probe and PRO-AB Adapter

- 15 Current clamp connection 1
- 16 Current clamp connection 2
- 17 Probe connection

#### Interfaces, Charger Jack

- 18 Bluetooth<sup>®</sup>
- 19 USB slave for PC connection
- 20 RS 232 for connecting barcode scanner or RFID reader
- 21 Jack for Z502P charger Attention! Make sure that no batteries are inserted before connecting the charger.
- 22 Battery Compartment Lid (compartment for batteries and replacement fuses)

# Please refer to section 17 for explanations regarding control and display elements.

\* Can only be switched on with the key on the instrument

![](_page_2_Figure_28.jpeg)

#### **Overview of Device Settings and Measuring Functions**

SETUP       Pith       Brightness, contrast, time/date, Bluetonho Language (D, 6P, Pp, profiles (EIC, PS3, PC.doc Language (D, 6P, Pp, profiles (EIC, PS3, PC, doc Language (D, 6P, profiles (EIC, PS3, PS3, profiles))         Wint	Switch Setting, Descr. on	Picto- graph	Device Sett Measuring	ings Functions
Page 8       Image (0, 68, P), profiles (EC, PS3, PC.doc	SETUP	плп	SETTING	Brightness, contrast, time/date, Bluetooth®
page 8       Local Lettings         Measurements with line voltage       Single-phase measurement U <sub>L-N-PE</sub> U       Single-phase measurement U <sub>L-N-PE</sub> U.N       Voltage between L and PE         U.PE       Voltage between L and L1         U.1-12       Voltage between L and L2         U.2-13       Voltage between L and L1         U.2-14       Voltage between L and L2         U.2-15       Voltage between L and L3         f       Frequency         3-phase measurement U <sub>3</sub> .       ULA         U.1-12       Voltage between L3 and L1         U.1-12       Voltage between L3 and L1         U.2-13       Voltage between L3 and L1         U.2-14       Voltage between L3 and L1         U.2-15       Voltage between L3 and L1         U.2-16       Phase sequence         Appears for all meas.       U/A       Line requency / nominal line voltage         appe 20       RE       Earth resistance       Earth resistance         FL       U/A       Contact voltage      <		Ϋ́Ă.	ତ୍ରଳ	Language (D, GB, P), profiles (ETC, PS3, PC.doc)
page 8 <ul> <li></li></ul>				SETTING Default settings
page 8       Retary switch balancing, battery switch balancing, battery test.>         Measurements with line voltage       Single-phase measurement U <sub>L-N-PE</sub> U       Vitage between L and PE         U-PE       Voltage between L and PE         U.PE       Voltage between N and PE         U.PE       Voltage between L and L1         UU-PE       Voltage between L3 and L1         UL-12       Voltage between L3 and L1         UL-12       Voltage between L3 and L1         UL-14       Voltage between L3 and L1         UL-12       Voltage between L3 and L1         UL-14       Voltage between L3 and L1         UL-14       Voltage between L3 and L1         UL-15       Voltage between L3 and L1         UL-14       Voltage between L3 and L1         UL-15       Voltage between L3 and L1         UL-14       Voltage between L3 and L1         UL-15       Voltage between L3 and L1         UL-14       Voltage between L3 and L1         UL-15       Voltage between L3 and L1         UL-15       Voltage between L3 and L1         UL-14       Voltage between L3 and L1         UL-15       Voltage between L3 and L1         UL-14       Voltage between L3 and L1         UA			TESTS	< Test: LED, LCD, acoustic signal
Measurements with line voltage       Single-phase measurement U <sub>L-N-PE</sub> U       Single-phase measurement U <sub>L-N-PE</sub> UV       Voltage between L and PE         UVE       Voltage between L and PE         UN       UN       Voltage between L and PE         VI.N       U.N       Contact voltage         VI.N       U.N       Contact voltage         IF <th< td=""><td>page 8</td><th></th><td><math>\otimes \land \triangleleft</math></td><td>Rotary switch balancing,</td></th<>	page 8		$\otimes \land \triangleleft$	Rotary switch balancing,
Wreasurements with mile voltage         U       Supervised         Supervised       Supervised         U-N       Voltage between L and N         U-PE       Voltage between L and PE         UN-PE       Voltage between N and PE         US-PE       Voltage between L and N         UL3-L1       Voltage between L3 and L1         UL3-L1       Voltage between L2 and L3         f       Frequency         Contact voltage       Ine frequency / nominal line voltage         IAN       Contact voltage         IAN       Stort-circuit current         RE       RE         IAN       Stort-c	Mooeuron	nonto with	lino voltogo	ballery lest >
0       Single-Priaze interast intereast intereast interast interast interast interast in			Cinglo phor	a maaauramant II
U-N       Volage between L and PE         UN-PE       Volage between N and PE         US-PE       Volage between N and PE         US-PE       Volage between L and PE         f       Frequency         3-phase measurement U <sub>3</sub> .       UL3-L1         UL3-L1       Volage between L3 and L1         UL1-L2       Volage between L3 and L1         ULAN       Contact voltage         L4       Tripping time         Page 20       ULAN         Contact voltage       LA         RE       Earth resistance         IF -       UAN         Contact voltage       Volage between L2 and L3         IA       Residual current         RE       ZL-PE         L2-PE       Loop impedance         IK       Short-circuit current	U	ഹ്	Single-phas	
UN-PE       Voltage between N and PE         US-PE       Voltage between N and PE         IUS-PE       Voltage between N and PE         J-Plase measurement Ug_       UL3-1         UL3-1       Voltage between L3 and L1         UL1-12       Voltage between L3 and L1         UL2-13       Voltage between L3 and L3         IA       Exercise         Appears for all meas.       U/U <sub>k</sub> LAN       Exercise         IA       Residual current         Page 20       Exercise         IA       Residual current         Page 26       IK         Short-circuit current       Exercise         IX-N       Exercise Short         Page 26       IK         RE       Exercise Short         IK       Short-circuit current         Page 26       IK         RE		뽀		Voltage between L and PE
Winter       Voltage between probe and PE         f       Frequency         3-phase measurement U			ULIN-PE	Voltage between N and PE
F       Frequency         3-phase measurement U <sub>3</sub> UL3-L1       Voltage between L3 and L1         UL2-L3       Voltage between L2 and L3         f       Frequency         compare to rail meas.       U/U <sub>1</sub> shown below.       U/U <sub>1</sub> LAN       U/U <sub>1</sub> apge 16       Frequency         f       Frequency         apge 18       Image 20         UAN       Contact voltage         ta       Tripping time         page 20       Image 20         UAN       Contact voltage         MAN       Contact voltage         LA       Residual current         page 26       Image 26         Image 27       Image 26         Image 28       ZL-N         Image 28       ZL-N         Image 28       ZL-N         Image 28       Image 29         RE       Fig.         Image 29       ZL-N         Image 20       Image 20         Image 21       ZL-N         Image 28       ZL-N         RE       Fig.         Image 29       ZL-N         Image 20       Image 20 <td></td> <th></th> <td>US-PF</td> <td>Voltage between probe and PE</td>			US-PF	Voltage between probe and PE
3-phase measurement U3_         UL3-11       Voltage between L3 and L1         UL1-12       Voltage between L3 and L3         IL1-12       Voltage between L2 and L3			f	Frequency
ul.3-L1       Voltage between L3 and L1         ul.1-L2       Voltage between L3 and L1         ul.2-L3       Voltage between L1 and L2         ul.2-L3       Voltage between L2 and L3         f       Frequency         Appears for all meas.       U/U <sub>N</sub> LAN       UIAN         Appears for all meas.       U/U <sub>N</sub> LAN       UIAN         age 18       Tripping time         Rege 20       Earth resistance         IF       UIAN         page 20       Earth resistance         ZL-PE       UIAN         page 28       ZL-PE         Lan       Earth resistance         IK       Short-circuit current         page 28       ZL-N         Line impedance       IK         IK       Short-circuit current         page 28       Z-PE         LI       EP         Selective measurement (ground loop) RE(L         IF       Selective measurement (ground loop) RE(L         IF       Selective measurement (ult current clamp senter)         IF       Selective measurement (with current clamp senter)         IF       Selective measurement         MPRO)       MIN			3-phase me	easurement U <sub>3~</sub>
ull-l-2       Voltage between L1 and L2         ull-l-2       Voltage between L2 and L3         f       Frequency         c)       Phase sequence         Appears for all meas.       U/U <sub>N</sub> Line voltage / nominal line voltage         page 18       Image 10       Image 10         page 18       Image 10       Image 10         page 20       Image 10       Image 10         FF_       Image 10       Image 10         page 20       Image 10       Re Earth resistance         IL-PE       Image 20       Image 20         ZL-PE       Image 20       Image 20         RE       ZL-PE       Loop impedance         IK       Short-circuit current         Page 28       Image 20       Image 20         RE       Image 20			UL3-L1	Voltage between L3 and L1
uL2-L3       Voltage between L2 and L3         page 16       f       Frequency         Appears for all meas. shown below:       U/U <sub>N</sub> Line voltage / nominal line voltage f / f <sub>N</sub> LAN       ULAN       Contact voltage         page 18       ULAN       Contact voltage         IAN       ULAN       Contact voltage         page 20       ULAN       Contact voltage         IF			<b>U</b> L1-L2	Voltage between L1 and L2
page 16       f       Frequency         Appears for all meas.       U/U <sub>N</sub> Line voltage / nominal line voltage         page 18       I/T <sub>N</sub> Line frequency / nominal line frequency         page 18       IIII       UIAN       Contact voltage         page 18       IIIIIIIIIIIIIIIIIIIIIIIIIIIIIIIIIIII			UL2-L3	Voltage between L2 and L3
page 16       Image sequence         Appears for all meas.       U / U <sub>N</sub> Line voltage / nominal line voltage         shown below:       f / f <sub>N</sub> Line voltage / nominal line voltage         tax       Tripping time         page 18       ULAN       Contact voltage         tax       Tripping time         page 18       ULAN       Contact voltage         IF	nono 10		f	Frequency
Appears for all meas. shown below:       U / U <sub>N</sub> Line voltage / nominal line voltage f / f <sub>N</sub> LAN       ULAN       Contact voltage         page 18       Image for all meas.       ULAN         Page 18       Image for all meas.       ULAN         Page 20       Image for all meas.       ULAN         Contact voltage       Image for all meas.       Image for all meas.         Page 20       Image for all meas.       ULAN         Contact voltage       Image for all meas.       Image for all meas.         Page 20       Image for all meas.       Image for all meas.         Image 20       Image for all meas.       Image for all meas.         Image 20       Image for all meas.       Image for all meas.         Image 28       Image for all meas.       Image for all meas.         RE       Image for all meas.       Image for all meas.         Image 30       Image for all meas.       Image for all meas.         Measurements at voltage for all meas.       Image for all meas.       Image for all meas.         Image 37       Image for all mea	page 16		ō	Phase sequence
Situation       F1/T <sub>N</sub> Line frequency / nominal line frequency         IAN       Image 18       Image 18       Image 18         IF_       Image 18       Image 18       Image 18       Image 18         IF_       Image 18       Image 18       Image 18       Image 18         IF_       Image 20       Image 18       Image 18       Image 18         IF_       Image 20       Image 20       Image 20       Image 20         Image 20       Image 20       Image 20       Image 20       Image 20         Image 20       Image 20       Image 20       Image 20       Image 20         Image 20       Image 20       Image 20       Image 20       Image 20         Image 20       Image 20       Image 20       Image 20       Image 20         Image 20       Image 20       Image 20       Image 20       Image 20         Image 20       Image 20       Image 20       Image 20       Image 20         Image 20       Image 20       Image 20       Image 20       Image 20       Image 20         Image 20       Image 20       Image 20       Image 20       Image 20       Image 20       Image 20       Image 20       Image 20       Image 20       Image 20 </td <td>Appears for</td> <th>all meas.</th> <td>U/U<sub>N</sub></td> <td>Line voltage / nominal line voltage</td>	Appears for	all meas.	U/U <sub>N</sub>	Line voltage / nominal line voltage
LΔN       ULAN       Contact voltage         page 18       Image 20       Image 20       Image 20       Image 20         IF and page 20       Image 20       Image 20       Image 20       Image 20       Image 20         ZL-PE page 26       Image 20       Image		w.	t/t <sub>N</sub>	Line frequency / nominal line frequency
page 18       Impung unite         RE       Earth resistance         ulan       Contact voltage         page 20       Impung unite         RE       Earth resistance         ZL-PE       Impung unite         page 26       Impung unite         ZL-PE       Impung unite         page 26       Impung unite         ZL-N       Impung unite         page 28       ZL-N         RE       Impung unite         Page 28       ZL-N         Impung unite       ZL-N         Impung unite       ZL-N         Impung unite       ZL-N         Impage 28       ZL-N         RE       Impung unite         Impung unite       ZL-N         Impage 28       ZL-N         RE       Impung unite         Impage 28       ZL-N         Impage 29       ZL-N         Impage 20       ZL-N         Impage 20       ZL-N         Impage 21       Z-pole measurement (ground loop) RE(L         Impage 20       Impage 20         Impage 20       Impage 20         Impage 21       Impage 20         Impage 37       Selective meas. with cur	IΔN	يسب	UI/AIN to	Contact Voltage
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In Contract Younge         page 20         In Residual current         RE       Earth resistance         ZL-PE       In Residual current         page 26       In Residual current         ZL-N       In Residual current         page 28       In Residual current         RE       In Residual current         page 28       In Residual current         RE       In Residual current         page 28       In Residual current         RE       In Residual current         page 28       In Residual current         RE       In Residual current         page 30       In Residual current         WE       Selective measurement (ground loop) RE(L         In Residual current       Selective meas. with current clamp senser         page 30       UE       Earth electrode voltage (probe/clamp)         Measurements at voltage-free objects       3-pole measurement         RE       In Residual current measurement       In Residual current clamp senser         (MPRO)       In RLO -       Selective measurement (earth loop res.)         page 37       In RLO -       In RLO -       In Residual current measurement         RLO -       Filon       RLO -       In Ruo +				
page 20       RE       Earth resistance         ZL-PE       ZL-PE       Loop impedance         jage 26       IK       Short-circuit current         jage 28       IK       Short-circuit current         page 30       IFF       2-pole measurement (ground loop) RE(L         IFF       IFF       3-pole measurement (2-pole with probe         IFF       IFF       Selective meas. with current clamp sens         Page 30       UE       Earth electrode voltage (probe/clamp)         Measurements at voltage-free objects       Selective measurement         MPRO) (MXTRA)       IFF       Selective measurement with current clamp sens         IFF       IFF       Selective measurement with current clamp sens         IFF       IFF       Selective measurement         (MPRO) (MXTRA)       IFF       Selective measurement with current clamp sens         IFF       IFF       Selective measurement       Selective measurement				Residual current
ZL-PE       Loop impedance         page 26       IK       Short-circuit current         page 28       IK       Short-circuit current         Page 30       IFF       2-pole measurement (ground loop) RE(L         IFF       Selective meas. with current clamp sens       Selective meas. with current clamp sens         Page 30       IFF       Selective measurement       IFF         MRE       IFF       Selective measurement       IFF         MMTRA)       IFF       Selective measurement with current clamp sens         Page 37       IFF       Selective measurement (earth loop res.)         Page 47       IFF       Selective measurement with current clamp sens         Page 47       IFF       Selective measurement (earth loop res.)         Page 47       IFF       RLO - Low-resistance with polarity reversal	page 20		RE	Earth resistance
page 26       IK       Short-circuit current         page 28       ZL-N       Line impedance         page 28       IK       Short-circuit current         RE       FE       FE       2-pole measurement (ground loop) RE(L         Page 30       2-pole measurement with country spec. pl       3-pole measurement (2-pole with probe         Page 30       UE       Earth electrode voltage (probe/clamp)         Measurements at voltage-free objects       3-pole measurement         RE       FE       Selective measurement with current clamp sens         mains       Selective measurement       4-pole measurement         (MTRA)       FE       Selective measurement with current clamp sens         page 37       Selective measurement       Selective measurement         (MTRA)       FE       Selective measurement with current clamp sens         page 37       FILO       RLO - Low-resistance with polarity reversal         RLO + RLO -       RUS - RINS       Insulation resistance         RINS       Insulation resistance       EI(NS)         page 50       Voltage at the test probes       U         UINS       Test voltage       Reade current         page 50       ZT       ZT       Standing surface insulation impedance	ZL-PE		ZL-PE	Loop impedance
page 26       ZL-N       ZL-N       Line impedance         page 28       ZL-N       Line impedance         RE       FE       2-pole measurement (ground loop) RE(L         Page 30       2-pole measurement with country spec. p         Page 30       UE       2-pole measurement (2-pole with probe         Page 30       UE       Earth electrode voltage (probe/clamp)         Measurements at voltage-free objects       3-pole measurement         RE       FE       3-pole measurement         (MPRO)       FE       3-pole measurement         (MYTRA)       FE       Selective measurement         (MYTRA)       FE       Selective measurement         (MYTRA)       FE       Selective measurement         (MYTRA)       FE       Selective measurement         (MITO)       FE       Clammea			IK	Short-circuit current
ZL-N       Line impedance         page 28       IK       Short-circuit current         RE       FE       2-pole measurement (ground loop) RE(L         Page 30       2-pole measurement with country spec. p         Impins       3-pole measurement (2-pole with probe         Selective meas. with current clamp sens       3-pole measurement (2-pole with probe         Page 30       UE       Earth electrode voltage (probe/clamp)         Measurements at voltage-free objects       3-pole measurement         RE       FE       3-pole measurement         (MPRO)       FE       Selective measurement	page 26			
Page 28       IK       Short-circuit current         RE       FE       2-pole measurement (ground loop) RE(L         Page 30       2-pole measurement with country spec. pl         Measurements at voltage-free objects       Selective meas. with current clamp sens         ME       FE       3-pole measurement         (MPR0)       FE       3-pole measurement         (MPR0)       FE       3-pole measurement         (MPR0)       FE       3-pole measurement         (MPR0)       FE       3-pole measurement         (MTRA)       FE       Selective measurement         (MTRA)       FE       Selective measurement         (MTRA)       FE       Selective measurement         (MTRA)       FE       Selective measurement         <	ZL-N	<u> </u>	ZL-N	Line impedance
RE       RE       RE       2-pole measurement (ground loop) RE(L         invinse       2-pole measurement with country spec. p       3-pole measurement (2-pole with probe         page 30       UE       Earth electrode voltage (probe/clamp)         Measurements at voltage-free objects       3-pole measurement         RE       RE       Selective measurement         (MPRO)       moinse       3-pole measurement         (MPRO)       Minse       2-clamp measurement         (MPRO)       RLO       Selective measurement         (MTRA)       Selective measurement       2-clamp measurement (earth loop res.)         page 37       Selective measurement (earth loop res.)         page 47       RLO       Low-resistance with polarity reversal         RLO       RLO+, RLO-       Cow-resistance         RINS       Insulation resistance       RE(INS)         Page 50       RE       L/AMP         Residual or leakage current       T/RF         TRF       Temperature/humidity (in preparation)         page 50       AU       Voltage drop measurement         SENSOR       L/AMP       Residual or leakage current         T/RF       Temperature/humidity (in preparation)       Eath electric velicles at charging stations (IEC 618	2000		IK	Snort-circuit current
RE       FE       2-pole measurement (ground loop) RE(L         Page 30       2-pole measurement with country spec. pi         Measurements at voltage-free objects       3-pole measurement (2-pole with probe         RE       RE       Selective meas. with current clamp sense         (MPR0)       mains       3-pole measurement         (MXTRA)       Selective measurement       3-pole measurement         page 37       Selective measurement       4-pole measurement         Selective measurement       Selective measurement       Selective measurement         MXTRA)       Selective measurement       Selective measurement         MXTRA)       Selective measurement       Selective measurement         Page 37       Selective measurement (earth loop res.)         page 47       RLO       Low-resistance with polarity reversal         RLO       RLO+, RLO-       Low-resistance         RISO       RINS       Insulation resistance         RINS       Insulation resistance       U         Voltage at the test probes       UINS       Test voltage         page 50       Set voltage       Ramp: triggering/breakdown voltage         SENSOR       MU       Voltage drop measurement         SENSOR       MU       Voltage drop measurement	paye 20	<b>5</b>	/	
page 30       ie-Pi == 1:0       2-pole measurement with country spec. p         page 30       UE       Earth electrode voltage (probe/clamp)         Measurements at voltage-free objects       Selective meas. with current clamp sens         RE       FE       3-pole measurement         (MPRO)       mains       3-pole measurement         (MTRA)       FE       3-pole measurement         page 37       Selective measurement         RLO       FLO       Selective measurement with current clamp sens         page 47       FLO       Selective measurement with current clamp sens         RISO       FLO       RLO       Low-resistance         RISO       FLO       RINS       Insulation resistance         RINS       Insulation resistance       U       Voltage at the test probes         UINS       Test voltage       Ramp: triggering/breakdown voltage         page 50       XIT       Standing surface insulation impedance         MU10       MD 2       Check insulation monitoring device         Ures 2       Residual voltage test       Meter start-up test, earth contact plug         Leakage current manitoring       RCM 2       Residual voltage test         MD 2       Check insulation monitoring device       Ures 2	nc	- <u>Č</u>	(2-P) =016*	2-pole measurement (ground loop) RE(L-PE
page 30       3-pole measurement (2-pole with probe         Measurements at voltage-free objects       Earth electrode voltage (probe/clamp)         Measurements at voltage-free objects       3-pole measurement         RE       FE       3-pole measurement         (MPRO)       Mins       3-pole measurement         (MYTRA)       mains       3-pole measurement         mains       FE       3-pole measurement         (MXTRA)       mains       2-clamp measurement (earth loop res.)         page 37       Selective measurement (earth loop res.)         page 47       RLO       Low-resistance with polarity reversal         RLO+, RLO-       RLO+, RLO-       Low-resistance, single-pole         RINS       Insulation resistance       U         Voltage at the test probes       UINS       Test voltage         page 50       XINS       Temperature/humidity (in preparation)         FLSO       AU       Voltage drop measurement         Voltage drop measurement       Meter start-up test, earth contact plug         uins       L/AMP       Temperature/humidity (in preparation)         Page 50       XINS       KWh test       Meter start-up test, earth contact plug         uins       L/AMP       Residual or leakage current       Standing s		<u> </u>	[2-P]⊂⊐⊉(	2-pole measurement with country spec. plug
page 30       Selective meas. with current clamp sens         Measurements at voltage-free objects       Earth electrode voltage (probe/clamp)         RE       FE       3-pole measurement         (MPRO)       mains       3-pole measurement         (MYRA)       mains       Selective measurement with current clamp sens         page 37       Selective measurement       2-clamp measurement (earth loop res.)         page 37       Selective measurement with polarity reversal         RLO       FLO       Low-resistance with polarity reversal         RLO+, RLO       Low-resistance, single-pole         RINS       FISO         RINS       INS         Page 50       Selective measurement         Voltage at the test probes       U         UINS       Test voltage         RENO       AU         Voltage drop measurement       Standing surface insulation impedance         Wh test       Meter start-up test, earth contact plug         Leakage current       Moins         Ures 2       Residual voltage test         MD 2       Check insulation monitoring device         Ures 2       Residual voltage test         PARE       PRO 2         PRO 2       PRCD 2         PRC 2 <td></td> <th>mains <math>\sim</math></th> <td>3-P 🖧 + 7</td> <td>3-pole measurement (2-pole with probe)</td>		mains $\sim$	3-P 🖧 + 7	3-pole measurement (2-pole with probe)
page 30       UE       Earth electrode voltage (probe/clamp)         Measurements at voltage-free objects       3-pole measurement         RE       FE       3-pole measurement         (MPRO)       Mains       Selective measurement         MXTRA)       RE       FE       3-pole measurement         mains       Selective measurement (earth loop res.)       Selective measurement (earth loop res.)         page 37       Selective measurement (earth loop res.)       Selective measurement (earth loop res.)         page 37       FLO       Low-resistance with polarity reversal         RLO       RLO+, RLO-       Low-resistance, single-pole         page 47       RINS       Insulation resistance         RINS       Insulation resistance       IINS         page 50       AU       Voltage at the test probes         UINS       Test voltage       Ramp: triggering/breakdown voltage         SENSOR       AU       Voltage drop measurement       Standing surface insulation impedance         Wh test       IL       Voltage drop measurement       Voltage drop measurement         EXTRA       AU       Voltage drop measurement       Check insulation monitorin device         IND       Common       AU       Voltage drop measurement       Check insulation imped			SEL 3-P 😭	Selective meas, with current clamp sensor
Measurements at voltage-free objects         RE (MPRO) (MXTRA)       FE (MPRO) (MXTRA)       3-pole measurement         mains - Solar       3-pole measurement         yage 37       Selective measurement with current clamp sen (2-clamp measurement (earth loop res.)         page 37       Soil resistivity ρE         RLO       FLO- Page 47       RLO         RISO RINS       FLO- FLO- Page 44       RLO         Page 47       FLO- Page 47       RLO- RINS         RINS       Insulation resistance RE(INS)       Insulation resistance RE(INS)         Page 44       FLO- RE(INS)       Earth leakage resistance U         Voltage at the test probes       U         UIINS       Test voltage Ramp: triggering/breakdown voltage         SENSOR       L/AMP         TRE       Temperature/humidity (in preparation)         Page 50       AU         Voltage drop measurement ZST       Voltage drop measurement Standing surface insulation impedance Wheter start-up test, earth contact plug IL         MD 2       Check insulation monitoring device         IND 2       Check insulation monitoring device         IND 2       Check insulation monitoring device         IND 2       Check insulation from thoring device         IND 2       Check insulation from thoring device	page 30		UE	Earth electrode voltage (probe/clamp)
RE (MPRO) (MXTRA)       FE       3-pole measurement         page 37       4-pole measurement         Selective measurement with current clamp sen         page 37       Soil resistivity ρE         RLO       Low-resistance with polarity reversal         Page 47       RLO +, RLO - Low-resistance, single-pole         Page 47       RINS         Page 47       RINS         Page 47       RINS         Page 50       FISO         Page 50       RE(INS)         EXTRA       AU         Voltage drop measurement       Standing surface insulation impedance         MWh test       Meter start-up test, earth contact plug         IND *       Check insulation monitoring device         Ures *       Residual voltage test         IND *       Check insulation monitoring device         IND *       RCM *         RCM *       RCM * <td>Measuren</td> <th>nents at vo</th> <td>Itage-free ob</td> <td>ijects</td>	Measuren	nents at vo	Itage-free ob	ijects
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1	Scope of delivery
1 1 1 1 1 1 1 1 1 1 1	Test instrument Earthing contact plug insert (country-sp 2-pole measuring adapter and 1 cable 3-pole adapter (PRO-A3-II) Alligator clips Shoulder strap Compact Master Battery Pack (Z502H) Charger Z502R DAkkS calibration certificate USB cable Condensed operating instructions Supplement Safety Information Detailed operating instructions for down at www.gossenmetrawatt.com
2	Applications
Th me vo tria reą Th pli	e <b>PROFITEST MASTER</b> and <b>SECULIFE IP</b> mea ents allow for quick and efficient testing of accordance with DIN VDE 0100, part 600 tage installations; tests – initial tests), as w a), NIV/NIN SEV 1000 (Switzerland) and of gulations. e test instrument is equipped with a mici- es with IEC 61557/EN 61557/VDE 0413

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asuring and test instruof protective measures 0:2008 (Erection of lowell as ÔVE-EN 1 (Ausother country-specific

#### roprocessor and comregulations:

- Part 1: General requirements
- Part 2: Insulation resistance
- Part 3: Loop resistance
- Part 4: Resistance of earth connection and equipotential bonding
- Part 5: Earth resistance
- Part 6: Effectiveness of residual current devices (RCD) in TT, TN and IT systems
- Part 7: Phase sequence
- Part 10: Electrical safety in low-voltage systems up to 1000 V AC and 1500 V DC - Equipment for testing, measuring or monitoring of protective measures
- Part 11: Effectiveness of type A and type B residual current monitors (RCMs) in TT, TN and IT systems

The test instrument is especially well suited for:

- System setup
- Initial start-up
- Periodic testing
- Troubleshooting in electrical systems •

All of the values required for approval reports (e.g. for ZVEH) can be measured with this instrument.

All acquired data can be archived, in addition to the measurement and test reports which can be printed out at a PC. This is of special significance where product liability is concerned.

The applications range of the test instruments covers all alternating and three-phase current systems with nominal voltages of 230 V / 400 V (300 V / 500 V) and nominal frequencies of  $16^{2}/_{3}$  / 50 / 60 / 200 / 400 Hz.

The following can be measured and tested with the instruments:

- Voltage / frequency / phase sequence
- Loop impedance / line impedance
- Residual current devices (RCDs)
- Insulation monitoring devices (IMDs) (only MXTRA & SECULIFE IP)
- Residual current monitoring devices (RCMs) (only MXTRA)
- Earthing resistance / earth electrode potential .
- Standing surface insulation resistance / insulation resistance
- Earth leakage resistance
- Low-value resistance (potential equalization) •
- Leakage currents with current transformer clamp
- Residual voltage (only MXTRA)
- Voltage drop
- Leakage current with leakage current adapter
- Meter start-up (not SECULIFE IP)
- Cable length

Refer to section 21.3 regarding testing of electrical machines in accordance with DIN EN 60204.

Refer to section 21.4 regarding periodic testing in accordance with DGUV provision 3 (previously BGV A3).

#### 2.1 Using Cable Sets and Test Probes

- 2 or 3-pole measuring adapter included
- 2-pole measuring adapter with 10 m cable as optional accessory: PRO-RLO II (Z501P)
- KS24 cable set as optional accessory (GTZ3201000R0001)

Measurements per DIN EN 61010-031 may only be performed in environments in accordance with measuring categories III and IV with the safety cap attached to the test probe at the end of the measurement cable.

In order to establish contact inside 4 mm jacks, the safety caps have to be removed by prying open the snap fastener with a pointed object (e.g. the other test probe).

#### 2.2 Overview of Features Included with PROFITEST MASTER & SECULIFE IP Device Variants

PROFITEST					₽
(Article Number)	0 <b>S)</b> #	(NO	‡ 🕯	A 0P)	ЩЭ
	ABASI M52(	APRO M52(	ATEC M52	AXTR/ M52(	ECU M52
Testing of residual current devices (RCDs)	25	22	22	22	<i>ω</i> =
U <sub>B</sub> measurement without tripping RCD	1	1	1	1	1
Tripping time measurement	1	1	1	1	1
Measurement of tripping current I <sub>F</sub>	1	1	✓ ✓	1	<ul> <li>Image: A state</li> </ul>
Selective, SRCDs, PRCDs, type G/R	1	1			
Testing of IMDs			✓ 	✓ ✓	✓ ✓
Testing of RCMs		_		· ·	-
Testing for N-PE reversal	1	1	1	1	1
Measurement of loop impedance Z <sub>L-PE</sub> / Z <sub>L-N</sub>					
Fuse table for systems without RCDs	1	1	1	1	1
Without tripping the RCD, fuse table			1	1	1
With 15 mA test current ' without tripping the RCD	1	1	1	1	1
Earthing resistance R <sub>E</sub> (mains operation) I-U measuring method (2/3-wire measuring method via measuring adapter: 2-wire/2-wire + probe)	1	1	1	1	1
Earthing resistance R <sub>E</sub> (battery operation) 3 or 4-wire measurement via PRO-RE adapter		1	_	1	_
Soil resistivity ρ <sub>E</sub> (battery operation) (4-wire measurement via PRO-RE adapter)		1	_	1	_
Selective earthing resistance R <sub>E</sub> (mains opera- tion) with 2-pole adapter, probe, earth electrode and current clamp sensor (3-wire measuring	1	1	~	1	1
Method) Selective earthing resistance R <sub>E</sub> (battery operation) with probe, earth electrode and current clamp sensor (4-wire measuring method via PRO-RE edepter and europet clamp economic		1	_	1	_
Earth loop resistance R <sub>ELOOP</sub> (battery operation) with 2 clamps (current clamp sensor direct and current clamp transformer via PRO-RE/2 adapter)		1	_	1	_
Measurement of equipotential bonding R <sub>L0</sub> , automatic polarity reversal	1	1	1	1	1
Insulation resistance R <sub>INS</sub> , variable or rising test voltage (ramp)	1	1	~	1	1
Voltage U <sub>L-N</sub> / U <sub>L-PE</sub> / U <sub>N-PE</sub> / f	1	1	1	1	1
Special measurements					
Leakage current (with clamp) $I_L$ , $I_{AMP}$	1	1	1	1	✓
Phase sequence	1	1	1	1	1
Earth leakage resistance R <sub>E(ISO)</sub>	1		<i>\</i>	<ul> <li></li> <li></li> </ul>	<ul> <li>Image: A state of the state of</li></ul>
Voltage drop (AU)					
Stanuing-surface insulation 2 <sub>ST</sub>	<i>v</i>				
Leakage current with PRO-AB adapter (IL)	-	-	-	✓ ✓	1
Residual voltage test (Ures)		_	_	1	-
Intelligent ramp (ta + $\Delta l$ )	—	-	—	1	-
Electric vehicles at charging stations (IEC 61851)		-	1	1	_
Report generation of fault simulations on PRCDs with PROFITEST PRCD adapter		_	_	1	_
Features					
Selectable user interface language $^{2}$	1	1	1	1	1
Memory (database for up to 50,000 objects)	1	1	1	1	1
Automatic test sequence function	✓ <sup>2</sup>	1	1	1	1
KS 232 port for RFID/barcode scanner	1	<ul> <li>Image: A state</li> <li>Image: A state<td>1</td><td>1</td><td>/</td></li></ul>	1	1	/
USB port for data transmission	1	1			<i>✓</i>
Interface for Bluetooth®	-	-			
Measuring category: CAT III 600 V / CAT IV	~	<b>v</b>	~	~	~
300 V DAkkS calibration					

The so-called live measurement is only advisable if there is no bias current within the system. Only suitable for motor circuit breaker with low nominal current

<sup>2</sup> currently available languages: D, GB, I, F, E, P, NL, S, N, FIN, CZ, PL

#### 3 Safety Features and Precautions

This instrument fulfills all requirements of applicable European and national EC directives. We confirm this with the CE mark. The relevant declaration of conformity can be obtained from GMC-I Messtechnik GmbH.

The electronic measuring and test instrument is manufactured and tested in accordance with safety regulations IEC 61010-1/ EN 61010-1/VDE 0411-1 and EN 61557.

Safety of the operator, as well as that of the instrument, is only assured when it is used for its intended purpose.

# Read the operating instructions thoroughly and carefully before using your instrument. Follow all instructions contained therein. Make sure that the operating instructions are available to all users of the instrument.

#### Tests may only be executed by a qualified electrician.

Grip and hold the test plug and test probes securely when they have been inserted, for example, into a socket. Danger of injury exists if tugging at the coil cord occurs, which may cause the test plug or test probes to snap back.

#### The measuring and test instrument may not be placed into service:

- If the battery compartment lid has been removed
- If external damage is apparent
- If connector cable or measuring adapters are damaged
- If the instrument no longer functions flawlessly
- After a long period of storage under unfavorable conditions (e.g. humidity, dust, temperature)

#### **Exclusion of Liability**

When testing systems with RCCBs, the latter may switch off. This may occur even though the test does not normally provide for it. Leakage currents may be present which, in combination with the test current of the test instrument, exceed the shutdown threshold value of the RCCB. PCs which are operated in proximity to such RCCB systems may switch off as a consequence. This may result in inadvertent loss of data. Before conducting tests, precautions should therefore be taken to ensure that all data and programs are adequately saved, and the computer should be switched off if necessary. The manufacturer of the test instrument assumes no liability for any direct or indirect damage to equipment, computers, peripheral equipment or data bases when performing tests.

#### Opening of Equipment / Repair

The equipment may be opened only by authorized service personnel to ensure the safe and correct operation of the equipment and to keep the warranty valid.

Even original spare parts may be installed only by authorized service personnel.

In case the equipment was opened by unauthorized personnel, no warranty regarding personal safety, measurement accuracy, conformity with applicable safety measures or any consequential damage is granted by the manufacturer.

Any warranty claims will be forfeited when the warranty seal has been damaged or removed.

Warning concerning a point of danger (Attention, observe documentation!)

#### Meaning of Symbols on the Instrument

 $\Lambda$ 

Protection class II device

![](_page_5_Picture_27.jpeg)

 Charging socket for extra-low direct voltage (charger Z502R) Attention!

Only rechargeable batteries may be inserted when the charger is connected.

![](_page_5_Picture_30.jpeg)

This device may not be disposed of with the trash. Further information regarding the WEEE mark can be accessed on the Internet at www.gossenmetrawatt.com by entering the search term "WEEE".

EC mark of conformity

![](_page_6_Picture_0.jpeg)

Any warranty claims will be forfeited when the warranty seal has been damaged or removed.

Calibration Seal (blue seal):

XY123-	Consecutive number
D-K-	Deutsche Akkreditierungsstelle GmbH – calibration lab
15080-01-01	Registration number
2012-06	Date of calibration (year – month)

See also "Recalibration" on page 96.

#### Data Backup

We advise you to regularly transmit your stored data to a PC in order to prevent potential loss of data in the test instrument. We assume no responsibility for any data loss.

We recommend the following PC software programs for data processing and management:

- ETC
- E-Befund Manager (Austria)
- Protokollmanager
- PS3 (documentation, management, report generation and monitoring of deadlines)
- PC.doc-WORD/EXCEL (report and list generation)
- PC.doc-ACCESS (test data management)

#### 4 Initial Start-Up

#### 4.1 Preparation for use

Before putting the test instrument into service and using it for the first time, the lamination sheets must be removed from the two sensor surfaces (finger contacts) of the test plug in order to ensure that contact voltage is reliably detected.

#### 4.2 Installing or Replacing the Battery Pack

#### Attention!

Before opening the battery compartment, disconnect the instrument from the measuring circuit (mains) at all poles!

#### 🐼 Note

∕!∖

See also section 20.2 on page 87 concerning charging the Kompkt Akku Pack Master (Z502H) and the battery charger Z502R.

Use Kompakt Akku Pack Master (Z502H), if possible, which is either included in the standard equipment or available as an accessory, with heat-sealed battery cells. Do not use any battery holders which can be filled with individual batteries. This ensures that always a complete set of batteries is replaced and all rechargeable batteries are inserted with correct polarity in order to prevent leakage from the batteries.

**Only use commercially available battery packs if you charge them externally.** The quality of these sets cannot be verified and this may, in unfavourable cases, lead to heating and deformation (during the charging in the device).

Dispose the battery packs or the individual rechargeable batteries in an environmentally sound fashion when their service life has nearly expired (approx. 80% charging capacity).

- Loosen the slotted screw for the battery compartment lid on the back and remove the lid.
- Remove the discharged battery pack or the battery holder.

![](_page_6_Picture_27.jpeg)

### Attention!

When Using a Battery Holder: It is imperative that you pay attention to the correct polarity when inserting the rechargeable batteries. If a battery has been inserted with incorrect polarity, it is not detected by the instrument and may lead to battery leak-

age.

Individual rechargeable batteries may only be charged externally.

- Slide the new battery pack/filled battery holder into the battery compartment. The holder can only be inserted to its proper position.
- Replace the lid and re-tighten the screw.

#### 4.3 Switching the Instrument On/Off

The test instrument is switched on by pressing the **ON/START** key. The menu which corresponds to the momentary selector switch position is displayed.

The instrument can be switched off manually by simultaneously pressing the **MEM** and **HELP** keys.

After the period of time selected in the **SETUP** menus has elapsed, the instrument is switched off automatically (see "Device Settings", section 4.6.

#### 4.4 Battery Test

If battery voltage has fallen below the permissible lower limit, the pictograph shown at the right appears. "Low Batt!!!" is also displayed along with a battery symbol. The instrument does not function if the batteries have been depleted excessively, and no display appears.

#### 4.5 Charging the Battery Pack in the Tester

#### Attention!

Use only the charger Z502R to charge the **Kompakt Akku-Pack Master (Z502H)** which has already been inserted into the test instrument.

Make sure that the following conditions have been fulfilled before connecting the charger to the charging socket:

- Kompakt Akku-Pack Master (Z502H) has been installed, no commercially available battery packs, no individual rechargeable batteries, no standard batteries
- The test instrument has been disconnected from the measuring circuit at all poles
- The instrument must remain off during charging.

Refer to section 20.2.1 with regard to charging the battery pack which has been inserted into the tester.

# If the batteries or the battery pack have not been used or recharged for a lengthy period of time (> 1 month), thus resulting in excessive depletion:

Observe the charging sequence (indicated by LEDs at the charger) and initiate a second charging sequence if necessary (disconnect the charger from the mains and from the test instrument to this end, and then reconnect it).

Please note that the system clock stops in this case and must be set to the correct time after the instrument has been restarted.

#### SETUP Menu Selection for Operating Parameters $(\mathbf{0})$ TESTS ват 🔝 LED and LCD test menu l⊗ ∝ ∢ MEM []]] Rotary switch balancing 08:01:33 TESTS 2 Display: date / time and battery test menu 14.09.2011 8 🚳 Brightness/contrast menu Display: automatic shutdown SETTING ាះ 3 0a ଢ଼ଇ Time, language, profiles of the tester after 60 s. 60 s Display: automatic shutdown SM-INFO Software revision level Ob 4 LCD of display illumination after 15 s. 15 s CALIB. Calibration date Select inspector John ₽»» logged in test technician 5 Smith (change via ETC) LED tests LCD and Acoustic Signal Tests 1 TEST Cell test Return to main menu ESC |≫ ∞ ⊲ 0 00 Inverse cell test MAINS LED: test green MAINS • • • MAINS LED: test red Hide all pixels MAINS 0 00 Show all pixels UL/RL LED: test red UL/RL 0 00 Acoustic signal test RCD-FI LED: test red D. RCD-FI Bluetooth<sup>®</sup> and Brightness Plus Contrast Settings Time, On-Time and Default Settings 3 SETTING Set time $\rightarrow$ (**3a**) Return to main menu ESC Set date $\rightarrow$ 3b 15:22:11 User interface Increase brightness 21.03.2012 language $\rightarrow$ D (3c) Profiles for PROFILES Bluetooth<sup>®</sup> submenu $\rightarrow$ **3h** distribution structures $\rightarrow$ **3d** On-time MEN SET DB-MODE submenu $\rightarrow$ (30) тхт 꼯 for display illumination / tester **d**GOME Brightness/contrast submenu $\rightarrow$ (3f Default settings $\rightarrow$ (**3e**) $\mathbf{e}$ SETTING **Display Illumination On-time** Test Instrument On-Time SET Return to submenu ESC 30 s꼯 10 s 60 s Ôb 0a 15 s 120 s LCD LCD

20 s

30 s

5 min

>>>>

![](_page_8_Figure_0.jpeg)

#### Significance of Individual Parameters

### **Oa** Test Instrument On-Time

The period of time after which the test instrument is automatically shut off can be selected here. This selection has a considerable influence on the service life and the charging status of the batteries.

### **Ob** On-Time for LCD Illumination

The period of time after which LCD illumination is automatically shut off can be selected here. This selection has a considerable influence on the service life and the charging status of the batteries.

#### Submenu: Rotary Switch Balancing

![](_page_9_Figure_6.jpeg)

Proceed as follows in order to precision adjust the rotary switch:

- 1 Press the TESTS Rotary Switch / Battery Test softkey in order to access the rotary switch balancing menu.
- 2 Then press the softkey with the rotary switch symbol.
- 3 Turn the rotary switch clockwise to the next respective measuring function (IDN first after SETUP).
- 4 Press the softkey which is assigned to the rotary switch at the LCD. After pressing this softkey, the display is switched to the next measuring function. Labeling in the LCD image must correspond to the actual position of the rotary switch.

The level bar in the LCD image of the rotary switch should be located in the middle of the black field, and is supplemented at the right-hand side with a number within a range of -1 to 101. This value should be between 45 and 55. In the case of -1 or 101, the position of rotary knob does not coincide with the measuring function selected at the LCD.

5 If the displayed value is not within this range, readjust the position by pressing the readjust softkey. A brief acoustic signal acknowledges readjustment.

#### 🔊 Note

If labeling in the LCD image of the rotary switch does not correspond with its actual position, a continuous acoustic signal is generated as a warning when the readjust softkey is pressed.

- 6 Return to point 2 and continue. Repeat this procedure until all rotary switch functions have been tested, and if necessary readjusted.
- Press ESC in order to return to the main menu.

#### Submenu: Battery Level Query

![](_page_9_Picture_19.jpeg)

#### **Measuring Sequence**

If battery voltage drops to below 8.0 V during the course of a measuring

sequence, this is indicated by means of

![](_page_9_Picture_22.jpeg)

a pop-up window only. Measured values are invalid. The measurement results cannot be saved to memory. Press ESC in order to return to the main menu.

#### Attention!

Data and sequences are lost when the language, the profile or DB mode is changed, or if the instrument is reset to default values!

Back up your structures, measurement data and sequences to a PC before pressing the respective key. The prompt window shown at the right asks you to confirm deletion.

![](_page_9_Picture_28.jpeg)

#### 3c User Interface Language (CULTURE)

Select the desired country setup with the appropriate country code. Attention: all existing structures, data and sequences are deleted, see note above!

### **3d** Profiles for Distributor Structures (PROFILES)

The profiles are laid out in a tree structure. The tree structure for the utilized PC evaluation program may differ from that of the **PROFITEST MASTER**. For this reason, the **PROFITEST MASTER** pro-

vides the user with the opportunity of adapting this structure. Selecting a suitable profile

ESC ETC PC.doc PS3/vFM EManager Variable CAD

PROFILES]

determines which object combinations are made possible. For example, this makes it possible to

create a distributor which is subordinate to another, or to save a measurement to a given building.

- Select the PC evaluation program you intend to use.
  - Attention: all existing structures, data and sequences are deleted, see note above!

If you have not selected a suitable PC evaluation program and, for example, if measured value storage to the selected location within the structure is not possible, the pop-up window shown at the right appears.

![](_page_9_Picture_40.jpeg)

#### 3e Default Settings (GOME SETTING)

The test instrument is returned to its original default settings when this key is activated.

Attention: all existing structures, data and sequences are deleted, see note above!

#### (3f) Adjusting Brightness and Contrast

![](_page_9_Figure_45.jpeg)

30 DB MODE – Presenting the Database in Text Mode or ID Mode

The DB MODE functions are available as of firmware version 01.05.00 of the test instrument and as of ETC version 01.31.00.

![](_page_10_Figure_2.jpeg)

only)

#### **Creating Structures in TXT MODE**

By default, the database in the test instrument is set to text mode, "TXT" is indicated in the header. You can create structural elements in the test instrument und add designations in plain text, e. g. Customer XY, Distributor XY and Electrical Circuit XY.

#### **Creating Structures in ID MODE**

Alternatively, you can work in the ID mode. "ID" is indicated in the header. You can create structural elements in the test instrument which can be labelled with ID numbers at your discretion.

#### Note 🖉

When data are transferred from the test instrument to the PC or ETC, ETC always retains the presentation (TXT or ID mode) selected in the test instrument.

When data are transferred from the PC or ETC to the test instrument, the test instrument always retains the presentation selected in ETC.

So, the respective receiver of the data always adopts the presentation of the sender.

#### 🐼 Note

In the test instrument, structures can either be created in text mode or in ID mode.

In the ETC software, however, designations and ID numbers are always allocated.

If no texts or ID numbers have been allocated when creating the structures in the test instrument, ETC generates the missing entries automatically. They can be subsequently edited in the ETC software and transferred back to the test instrument if required.

![](_page_10_Figure_15.jpeg)

3h Switching Bluetooth<sup>®</sup> 0n/Off (MTECH+/MXTRA/SECULIFE IP

If your PC is equipped with a *Bluetooth*<sup>®</sup> interface, wireless communication is possible between the **MTECH+**, **MXTRA or SECULIFE IP** and ETC user software for the transfer of data and test structures. One-time only authentication of the respective PC with the test instrument is a prerequisite for wireless data exchange. The function selector switch must be in the SETUP position to this end. The correct *Bluetooth*<sup>®</sup> COM port must also be selected in ETC before each data transmission sequence.

#### 🐼 Note

Activate the *Bluetooth*<sup>®</sup> interface at the test instrument during data transmission only. Interface power consumption reduces battery service life when activated continuously.

If several test instruments are within range during authentication, the respective name should be changed in order to rule out the possibility of a mix-up. Blanks may not be used. The default pin code, namely "0000", can be changed, but this is unnecessary as a rule. As shown in figure 3, the MAC address of the test instrument is displayed in the footer as hardware information.

Render your test instrument visible prior to authentication, and subsequently invisible for security reasons.

#### **Steps Required for Authentication**

Make sure that the test instrument is within range of the PC (roughly 5 to 8 meters). Activate  $Bluetooth^{(R)}$  at the test instrument (see figure 1) and at your PC.

The function selector switch must be in the SETUP position to this end.

Make sure that the test instrument (see figure 3) and your PC are visible for other  $\textit{Bluetooth}^{\textcircled{B}}$  devices:

In the case of the test instrument, the word "visible" must be displayed underneath the eye symbol.

Use your *Bluetooth*<sup>®</sup> PC driver software to add a new *Bluetooth*<sup>®</sup> device. In most cases, this is accomplished with the help of the "Add new connection" or "Add *Bluetooth*<sup>®</sup> device" button.

The following steps may vary, depending on which *Bluetooth*<sup>®</sup> PC driver software is used. Basically, a PIN code must be entered at the PC. The default setting for the PIN code is "0000", and is displayed in the main *Bluetooth*<sup>®</sup> menu (see figure 1) at the test instrument. Subsequently, or previously, an authentication message must be acknowledged at the test instrument (see figure 4).

If authentication has been successful, a corresponding message appears at the test instrument. Furthermore, the authenticated PC is displayed in the "Trusted Devices" menu at the test instrument (see figure 2).

The **MTECH+**, **MXTRA** or the **SECULIFE IP** should now also be listed as a device in your *Bluetooth*<sup>®</sup> PC driver software. Further information is also provided here regarding the utilized COM port. With the help of your *Bluetooth*<sup>®</sup> PC driver software, you'll need to find out which COM port is used for the *Bluetooth*<sup>®</sup> connection. This port is frequently displayed after authentication, but if this is not the case, this information provided by your *Bluetooth*<sup>®</sup> PC driver software.

ETC includes a function for automatically ascertaining the utilized COM port after successful authentication has been completed (see screenshot below).

If the test instrument is within range of your PC (5 to 8 meters), wireless data exchange can now be initiated with the help of ETC by clicking *Bluetooth*<sup>®</sup> in the "Extras" menu. The number of the correct COM port (e.g. COM40) must be entered to ETC when data exchange is started (see screenshot below).

Alternatively, the COM port number can be selected automatically by clicking the "Find Bluetooth Device" item in the menu.

![](_page_11_Picture_12.jpeg)

#### Firmware Revision and Calibration Information (example)

4	SM-INF(	)
	DEVICE TYPE SERIAL NUMBER	MS20P NoSerial
	SW1 00.00.00 HW SW2 03.13.461 HW SW3 05.65.33 HW	1 00.00.00 2 946.10.4 3 948.10.04
	SW4 04.09.02 HW	4 950.10.04
	CALIBRATION DATE	06.07.2011
	ADJUSTMENT DATE	06.07.2011

Press any key in order to return to the main menu.

#### Firmware Update with the MASTER Updater

The layout used for the entire range of the test instruments makes it possible to adapt instrument software to the latest standards and regulations. Beyond this, suggestions from customers result in continuous improvement of the test instrument software, as well as new functions.

In order to assure that you can take advantage of all of these benefits without delay, the MASTER Updater allows you to quickly and completely update your test instrument software on-site. The user interface can be set to either English, German or Italian.

#### 🐼 Note

![](_page_11_Figure_20.jpeg)

#### **5** Entering and Selecting a New Inspector

![](_page_11_Figure_22.jpeg)

See also section 5.7 page 15 regarding the entry of a text.

#### 5 General Notes

#### 5.1 Connecting the Instrument

For systems with earthing contact sockets, connect the instrument to the mains with the test plug to which the appropriate, country-specific plug insert is attached. Voltage between phase conductor L and the PE protective conductor may not exceed 253 V!

Poling at the socket need not be taken into consideration. The instrument detects the positions of phase conductor L and neutral conductor N and automatically reverses polarity if necessary. This does not apply to the following measurements:

- Voltage measurement in switch position U
- Insulation resistance measurement
- Low-value resistance measurement

The positions of phase conductor L and neutral conductor N are identified on the plug insert.

If measurement is to be performed at three-phase outlets, at distribution cabinets or at permanent connections, the measuring adapter must be attached to the test plug (see also table 16.1). Connection is established with the test probes: one at PE or N and the other at L.

The 2-pole measuring adapter must be expanded to 3 poles with the included measurement cable for the performance of phase sequence testing.

Contact voltage (during RCCB testing) and earthing resistance can be, and earth-electrode potential, standing surface insulation resistance and probe voltage must be measured with a probe. The probe is connected to the probe connector socket with a 4 mm contact protected plug.

#### 5.2 Automatic Settings, Monitoring and Shut-Off

The test instrument automatically selects all operating conditions which it is capable of determining itself. It tests line voltage and frequency. If these lie within their valid nominal ranges, they appear at the display panel. If they are not within nominal ranges, prevailing voltage (U) and frequency (f) are displayed instead of  $U_N$  and  $f_N$ .

**Contact voltage** which is induced by test current is monitored for each measuring sequence. If contact voltage exceeds the limit value of > 25 V or > 50 V, measurement is immediately interrupted. The U<sub>L</sub>/R<sub>L</sub> LED lights up red.

If **battery voltage** falls below the allowable limit value the instrument cannot be switched on, or it is immediately switched off.

The measurement is interrupted automatically, or the measuring sequence is blocked (except for voltage measuring ranges and phase sequence testing) in the event of:

- Impermissible line voltages (< 60 V, >253 V / >330 V / >440 V or >550 V) for measurements which require line voltage
- Interference voltage during insulation resistance or low resistance measurements
- Overheating at the instrument.

As a rule, excessive temperatures only occur after approximately 50 measurement sequences at intervals of 5 seconds, when the rotary selector switch is set to the  $Z_{L-PE}$  oder  $Z_{L-N}$  position.

If an attempt is made to start a measuring sequence, an appropriate message appears at the display panel.

The instrument only switches itself off automatically after completion of an automatic measuring sequence, and after the predetermined on-time has expired (see sectionI 4.3). On-time is reset to its original value as defined in the setup menu, as soon as any key or the rotary selector switch is activated.

The instrument remains on for approximately 75 seconds in addition to the preset on-time for measurements with rising residual current in systems with selective RCDs.

The instrument always shuts itself off automatically!

#### 5.3 Measurement Value Display and Memory

The following appear at the display panel:

- Measurement values with abbreviations and units of measure
- Selected function
- Nominal voltage
- Nominal frequency
- Error messages

Measurement values for automatic measuring sequences are stored and displayed as digital values until the next measurement sequence is started, or until automatic shut-off occurs. If the upper range limit is exceeded, the upper limit value is displayed and is preceded by the ">" symbol (greater than), which indicates measurement value overrun.

#### 🐼 Note

The depiction of LEDs in these operating instructions may vary from the LEDs on the actual instrument due to product improvements.

#### 5.4 Testing Earthing Contact Sockets for Correct Connection

The testing of earthing contact sockets for correct connection prior to protective measures testing is simplified by means of the instrument's error detection system.

The instrument indicates improper connection as follows:

- Impermissible line voltage (< 60 V or > 253 V): The MAINS/NETZ LED blinks red and the measuring sequence is disabled.
- Protective conductor not connected or potential to earth  $\geq$  50 V at  $\geq$  50 Hz (switch position U single-phase measurement): If the contact surfaces are touched (finger contact\*) while PE is being contacted (via the country-specific plug insert, e.g. SCHUKO, as well as via the PE test probe at the 2-pole adapter) PE appears (only after a test sequence has been started). The U<sub>L</sub>/R<sub>L</sub> and RCD/FI LEDs light up red as well.
  - \* for reliably detecting the contact voltages, both sensor surfaces at the test plug must be touched directly with the finger/palm without any skin protection applied, see also section 4.1.
- Neutral conductor N not connected (during mains dependent measurements):

The MAINS/NETZ LED blinks green.

One of the two protective contacts is not connected: This is checked automatically during testing for contact current  $U_{I\Delta N}$ . Poor contact resistance at one of the contacts leads to one of the following displays, depending upon poling of the plug:

 Display at the connection pictograph: PE interrupted (x), or underlying protective conductor bar interrupted with reference to keys at the test plug Cause: voltage measuring path interrupted

**Cause:** voltage measuring path interrupted **Consequence:** measurement is disabled

![](_page_12_Figure_45.jpeg)

#### - Display at the connection pictograph:

Overlying protective conductor bar interrupted with reference to keys at the test plug

![](_page_12_Picture_48.jpeg)

Cause: current measuring path interrupted Consequence: no measured value display

#### 🐼 Note

See also "LED Indications, Mains Connections and Potential Differences" beginning on page 73.

#### Attention!

Reversal of N and PE in a system without RCCBs cannot be detected and is not indicated by the instrument. In a system including an RCCB, the RCCB is tripped during "contact voltage measurement without RCCB tripping" (automatic  $Z_{L-N}$  measurement), insofar as N and PE are reversed.

#### 5.5 Help Function

The following information can be displayed for each switch position and basic function after it has been selected with the rotary selector switch:

- Wiring diagram
- Measuring range
- Nominal range of use and measuring uncertainty
- Nominal value
- Press the **HELP** key in order to query online help:
- If several pages of help are available for the respective measuring function, the HELP key must be pressed repeatedly.
- Press the **ESC** key in order to exit online help.

#### 5.6 Setting Parameters or Limit Values using RCD Measurement as an Example

![](_page_13_Figure_10.jpeg)

HELP

![](_page_13_Figure_11.jpeg)

- 1 Access the submenu for setting the desired parameter.
- 2 Select a parameter using the  $\uparrow$  or  $\downarrow$  scroll key.
- 3 Switch to the setting menu for the selected parameter with the  $\rightarrow$  scroll key.
- 4 Select a setting value using the  $\uparrow$  or  $\downarrow$  scroll key.
- 5 Acknowledge the setting value with the ↓ key. This value is transferred to the setting menu.
- 6 The setting value is not permanently accepted for the respective measurement until ✓ is pressed, after which the display is returned to the main menu. You can return to the main menu by pressing ESC instead of ✓, without accepting the newly selected value.

#### Parameter Lock (plausibility check)

Individually selected parameter settings are checked for plausibility before transfer to the measurement window.

If you select a parameter setting which doesn't make sense in combination with other parameter settings which have already been entered, it's not accepted. The previously selected parameter setting remains unchanged.

Remedy: Select another parameter setting.

#### 5.7 Freely Selectable Parameter Settings or Limit Values

In addition to fixed values, other values can be freely selected within predefined limits for certain parameters, if the symbol for the EDIT menu (3) appears at the end of the list of setting values.

#### Freely Selecting a Limit Value or Nominal Voltage

![](_page_14_Figure_3.jpeg)

- 1 Open the submenu for setting the desired parameter (no figure, see section 5.6).
- 2 Select parameter ( $\textbf{U}_{L})$  using the  $\uparrow$  or  $\downarrow$  scroll key (no figure, see section 5.6).
- 3 Select a setting value with the help of the  $\mathbf{E}$  icon and the  $\uparrow$  or  $\downarrow$  scroll key.
- 4 Select the edit menu: Press the key with the icon.
- 5 Select the desired value or unit of measure with the LEFT or RIGHT scroll key. The value or unit of measure is accepted by pressing the → key. The entire value is acknowledged by selecting ✓ and then pressing the → key. The new limit value or nominal value is added to the list.

#### Note Note

Observe predefined limits for the new setting value. New, freely selected limit values or nominal values included in the parameters list can be deleted/edited at the PC with the help of ETC software. When the upper limit value is exceeded, this value is accepted (in the example: 65 V), when the limit value is fallen short of, the predefined lower limit value (25 V) is

accepted.

#### 5.8 2-Pole Measurement with Fast or Semiautomatic Polarity Reversal

Fast, semiautomatic polarity reversal is possible for the following measurements:

- Voltage U
- Loop impedance Z<sub>LP-E</sub>
- Internal line resistance measurement Z<sub>L-N</sub>
- Insulation resistance, R<sub>INS</sub>

#### Fast Polarity Reversal at the Test Plug

The polarity parameter is set to AUTO.

Fast and convenient switching amongst all polarity variants, or switching to the parameter settings submenu, is possible by pressing the  $I_{AN}$  key at the instrument or the test plug.

![](_page_14_Picture_21.jpeg)

![](_page_14_Figure_22.jpeg)

#### Semiautomatic Polarity Reversal in Memory Mode

The polarity parameter is set to AUTO.

If testing is to be conducted with all polarity variants, automatic polarity changing takes place after each measurement when the **"Save"** button is pressed.

Polarity variants can be skipped by pressing the  $I_{\Delta N}$  key at the instrument or the test plug.

![](_page_14_Figure_27.jpeg)

### 6 Measuring Voltage and Frequency

#### **Select Measuring Function**

![](_page_15_Picture_2.jpeg)

#### Switch Between Single and 3-Phase Measurement

![](_page_15_Picture_4.jpeg)

Press the softkey shown at the left in order to switch back and forth between single and 3-phase measurement. The selected phase measurement is displayed inversely (white on black).

#### 6.1 Single-Phase Measurement

![](_page_15_Figure_7.jpeg)

![](_page_15_Figure_8.jpeg)

A probe must be used in order to measure probe voltage  $U_{S-PF}$ .

6.1.1 Voltage Between L and N (U<sub>L-N</sub>), L and PE (U<sub>L-PE</sub>) and N and PE (U<sub>N-PE</sub>) with Country-Specific Plug Insert, e.g. SCHUKO

![](_page_15_Picture_11.jpeg)

Press the softkey shown at the left in order to switch back and forth between the country-specific plug insert, e.g. SCHUKO, and the 2-pole adapter. The selected connection type is displayed inversely (white on black).

![](_page_15_Figure_13.jpeg)

## 6.1.2 Voltage between L – PE, N – PE and L – L with 2-Pole Adapter Connection

![](_page_15_Picture_15.jpeg)

Press the softkey shown at the left in order to switch back and forth between the country-specific plug insert, e.g. SCHUKO, and the 2-pole adapter. The selected connection type is displayed inversely (white on black).

Refer to section 5.8 regarding 2-pole measurement with fast or semiautomatic polarity reversal.

![](_page_15_Figure_18.jpeg)

![](_page_15_Figure_19.jpeg)

## 6.2 3-Phase Measurement (line-to-line voltage) and Phase Sequence

RE

adapter to 3 poles.

Right rotation

.....

Left rotation

in in

For determination of phase

sequence expand the 2-pole

#### Connection

The measuring adapter (2-pole) is required in order to connect the instrument, and can be expanded to a 3-pole measuring adapter with the included measurement cable.

♀ Press softkey U3~.

UL3-L1 401 V UL1-L2 403 V UL2-L3 403 V f5 0.0 Hz

#### A clockwise phase

sequence is required at all 3-phase electrical outlets.

- Measurement instrument connection is usually problematic with CEE outlets due to contact problems.
   Measurements can be executed quickly and reliably without contact problems with the help of the Z500A variable plug adapter set available from GMC.
- Connection for 3-wire measurement, plug L1-L2-L3 in clockwise direction as of PE socket

Direction of rotation is indicated by means of the following displays:

![](_page_16_Picture_10.jpeg)

![](_page_16_Picture_11.jpeg)

#### 🐼 Note

See section 18 regarding all indications for the mains connection test.

#### **Voltage Polarity**

If the installation of single-pole switches to the neutral conductor is prohibited by the standards, voltage polarity must be tested in order to assure that all existing single-pole switches are installed to the phase conductors.

#### 7 Testing RCDs

The testing of residual current devices (RCDs) includes:

- Visual inspection
- Testing

1

Measurement

Use the test instrument for testing and measurement.

#### **Measuring Method**

The following must be substantiated by generating a fault current downstream from the RCD:

- That the RCD is tripped no later than upon reaching its nominal fault current value
- That the continuously allowable contact voltage value U<sub>L</sub> agreed upon for the respective system is not exceeded

This is achieved by means of:

- Contact voltage measurement, 10 measurements with full-waves and extrapolation of  ${\rm I}_{\Delta N}$ 

![](_page_16_Figure_28.jpeg)

• Substantiation of tripping within 400 ms or 200 ms with  $I_{AN}$ 

![](_page_16_Figure_30.jpeg)

• Substantiation of tripping with current rising residual current: This value must be between 50% and 100% of I\_{\Delta N} (usually about 70%).

![](_page_16_Figure_32.jpeg)

• No premature tripping with the test instrument, because testing is begun with 30% residual current (if no bias current occurs within the system).

RCD/FI Table	Type of Differential Current	Correct RCD/RCCB Function			
		Type AC	Type A, F	Type B*/ B+*	Type EV*
Alternating current	Suddenly occurring Slowly rising	~	~	~	~
Pulsating di- rect current	Slowly rising		~	~	~
Direct current	$\square$			~	~
Direct current up to 6 mA					~

\* PROFITEST MTECH+, PROFITEST MXTRA & SECULIFE IP

#### **Test Standard**

The following must be substantiated per DIN VDE 0100 part 600: 2008:

- Contact voltage occurring at nominal residual current may not exceed the maximum allowable value for the system.
- Tripping of the RCCB must occur within 400 ms (1000 ms for selective RCDs) at nominal residual current.

#### Important Notes

- The **PROFITEST MASTER** allows for simple measurements at all types of RCDs. Select RCD, SRCD, PRCD etc.
- Measurement must be executed at one point only per RCD (RCCB) within the connected electrical circuits. Low-resistance continuity must be substantiated for the protective conductor at all other connections within the electrical circuit ( $R_{LO}$  or  $U_B$ ).
- The measuring instruments often display a contact voltage of 0.1 V in TN systems due to low protective conductor resistance.
- Be aware of any bias currents within the system. These may cause tripping of the RCDs during measurement of contact voltage U<sub>B</sub>, or may result in erroneous displays for measurements with rising current:

Display =  $I_F - I_{bias_current}$ 

- Selective RCDs identified with an  $\underline{S}$  can be used as the sole means of protection for automatic shutdown if they adhere to the same shutdown conditions as non-selective RCDs (i.e.  $t_a < 400$  ms). This can be substantiated by measuring shutdown time.
- Type B RCDs may not be connected in series with type A RCDs.

#### 🐼 Note

#### **Bias Magnetization**

Only AC measurements can be performed with the 2pole adapter. Suppression of RCD tripping by means of bias magnetization with direct current is only possible via a country-specific plug insert, e.g. SCHUKO, or the 3pole adapter.

#### Measurement With or Without Probe

Measurements can be performed with or without a probe.

Measurements with probe require that the probe and reference earth are of like potential. This means that the probe must be positioned outside of the potential gradient area of the earth electrode ( $R_E$ ) in the RCD safety circuit.

The distance between the earth electrode and the probe should be at least 20 m.

The probe is connected with a 4 mm contact protected plug. In most cases this measurement is performed without probe.

### <u>/!</u>

Attention!

The probe is part of the measuring circuit and may carry a current of up to 3.5 mA in accordance with VDE 0413.

Testing for the absence of voltage at the probe can be performed with the  $U_{\text{PROBE}}$  function (see also section 6.1 on page 16).

7.1 Measuring Contact Voltage (with reference to nominal residual current) with <sup>1</sup>/<sub>3</sub> Nominal Residual Current and Tripping Test with Nominal Residual Current

Select Measuring Function

![](_page_17_Figure_25.jpeg)

#### Connection

![](_page_17_Figure_27.jpeg)

#### Set Parameters for $\mathbf{I}_{\Delta \mathbf{N}}$

![](_page_17_Figure_29.jpeg)

![](_page_17_Figure_30.jpeg)

#### 1) Measuring Contact Current Without Tripping the RCD

#### **Measuring Method**

The instrument uses a measuring current of only 1/3 nominal residual current for the determination of contact voltage  $U_{l\Delta N}$  which occurs at nominal residual current. This prevents tripping of the RCCB.

This measuring method is especially advantageous, because contact voltage can be measured quickly and easily at any electrical outlet without tripping the RCCB.

The usual, complex measuring method involving testing for the proper functioning of the RCD at a given point, and subsequent substantiation that all other systems components requiring protection are reliably connected at low resistance values to the selected measuring point via the PE conductor, is made unnecessary.

#### **N-PE Reversal Test**

Additional testing is conducted in order to determine whether or not N and PE are reversed. The pop-up window shown at the right appears in the event of reversal.

![](_page_18_Picture_7.jpeg)

#### Attention!

/Ì\

Execute a data backup before starting measurement and switch off all consumers in order to prevent the loss of data in data processing systems.

#### Start Measurement

![](_page_18_Figure_11.jpeg)

Amongst other values, contact voltage  $U_{|\Delta N}$  and calculated earthing resistance  $R_F$  appear at the display panel.

#### 🔊 Note

The measured earthing resistance value  $R_E$  is acquired with very little current. More accurate results can be obtained with the selector switch in the  $R_E$  position. The DC + function can be selected here for systems with RCCBs.

#### Unintentional Tripping of the RCD due to Bias Current within the System

If bias currents should occur, they can be measured with the help of a current clamp transformer as described in section 13.1 on page 50. The RCCB may be tripped during the contact voltage test if extremely large bias currents are present within the system, or if a test current was selected which is too great for the RCCB. After contact voltage has been measured, testing can be performed to determine whether or not the RCCB is tripped within the selected time limits at nominal residual current.

### Unintentional Tripping of the RCD due to Leakage Current in the Measuring Circuit

Measurement of contact voltage with 30% nominal residual current does not normally trip an RCCB. However, the trip limit may be exceeded as a result of leakage current in the measuring circuit, e.g. due to interconnected power consumers with EMC circuit, e.g. frequency converters and PCs.

#### 2) Tripping Test after the Measurement of Contact Voltage

 $\Rightarrow$  Press the I<sub>AN</sub> key.

![](_page_18_Figure_21.jpeg)

#### If the RCCB is tripped at nominal residual current,

the MAINS/NETZ LED blinks red (line voltage disconnected) and time to trip  ${\sf t}_a$  and earthing resistance  ${\sf R}_{\sf E}$  appear at the display panel.

If the RCCB is not tripped at nominal residual current,

the RCD/FI LED lights up red.

#### **Contact Voltage Too High**

If contact voltage  $U_{I\Delta N},$  which has been measured with 1/3 nominal residual current  $I_{\Delta N}$  and extrapolated to  $I_{\Delta N},$  is >50 V (>25 V), the  $U_L/R_L$  LED lights up red.

If contact voltage  $U_{\text{I}\Delta N}$  exceeds 50 V (25 V) during the measuring sequence, safety shut-down occurs.

#### 🐼 Note

**Safety Shut-down:** At up to 70 V, a safety shut-down is tripped within 3 seconds in accordance with IEC 61010.

Contact voltages of up to 70 V are displayed. If contact voltage is greater than 70 V,  $U_{l\Delta N}$  > 70 V is displayed.

#### Limit Values for Allowable, Continuous Contact Voltage

The limit for allowable, continuous contact voltage is  $U_L = 50$  V for alternating voltages (international agreement). Lower values have been established for special applications (e.g. medical applications:  $U_L = 25$  V).

### Attention!

If contact voltage is too high, or if the RCCB is not tripped, the system must be repaired (e.g. earthing resistance is too high, defective RCCB etc.)!

#### **3-Phase Connections**

For proper RCD testing at three-phase connections, the tripping test must be conducted for one of the three phase conductors (L1, L2 and L3).

#### **Inductive Power Consumers**

Voltage peaks may occur within the measuring circuit if inductive consumers are shut down during an RCCB trip test. If this is the case, the test instrument may display the following message: No measured value (---). If this message appears, switch all power consumers off before performing the trip test. In extreme cases, one of the fuses in the test instrument may blow, and/or the test instrument may be damaged.

#### 7.2 Special Testing for Systems and RCCBs

#### 7.2.1 Testing Systems and RCCBs with Rising Residual Current (AC) for Type AC, A/F, B/B+ and EV/MI RCDs

#### **Measuring Method**

The instrument generates a continuously rising residual current of (0.3 to 1.3) • I<sub> $\Delta N$ </sub> within the system for the testing of RCDs. The instrument stores the contact voltage and tripping current values which were measured at the moment tripping of the RCCB occurred, and displays them.

One of contact voltage limit values, U<sub>L</sub> = 25 V or U<sub>L</sub> = 50 V/65 V, can be selected for measurement with rising residual current.

#### Select Measuring Function

![](_page_19_Figure_6.jpeg)

Connection

![](_page_19_Figure_8.jpeg)

![](_page_19_Figure_9.jpeg)

#### Set Parameters for I<sub>F</sub>∠

![](_page_19_Figure_11.jpeg)

![](_page_19_Figure_12.jpeg)

![](_page_19_Figure_13.jpeg)

![](_page_19_Figure_14.jpeg)

#### **Measuring Sequence**

After the measuring sequence has been started, the test current generated by the instrument is continuously increased starting at 0.3 times nominal residual current, until the RCCB is tripped. This can be observed by viewing gradual filling of the triangle at I $\Delta$ . If contact voltage reaches the selected limit value (U<sub>L</sub> = 65 V, 50 V or 25 V) before the RCCB is tripped, safety shut-down occurs. The U<sub>L</sub>/R<sub>L</sub> LED lights up red.

#### 🐼 Note

**Safety Shut-down:** At up to 70 V, a safety shut-down is tripped within 3 seconds in accordance with IEC 61010.

If the RCCB is not tripped before the rising current reaches nominal residual current  $I_{\Delta N}$ , the RCD/FI LED lights up red.

#### Attention!

If bias current is present within the system during measurement, it is superimposed onto the residual current which is generated by the instrument and influences measured values for contact voltage and tripping current. See also section 7.1.

#### Evaluation

According to DIN VDE 0100, Part 600, rising residual current must, however, be used for measurements in the evaluation of RCDs, and contact voltage at nominal residual current  $I_{\Delta N}$  must be calculated from the measured values.

The faster, more simple measuring method should thus be taken advantage of (see section 7.1).

#### 7.2.2 Testing Systems and RCCBs with Rising Residual Current (AC) for Type B/B+ and EV/MI RCDs (nur MTECH+, MXTRA & SECULIFE IP)

In accordance with VDE 0413, part 6, it must be substantiated that, with smooth direct current, residual operating current is no more than twice the value of rated residual current  $I_{\Delta N}$ . A continuously rising direct current, beginning with 0.2 times rated residual current  $I_{\Delta N}$ , must be applied to this end. If current rise is linear, rising current may not exceed twice the value of  $I_{\Delta N}$  within a period of 5 seconds.

Testing with smoothed direct current must be possible in both test current directions.

#### 7.2.3 Testing RCCBS with 5 • $I_{\Delta N}$

The measurement of time to trip is performed here with 5 times nominal residual current.

#### Note Note

Measurements performed with 5 times nominal fault current are required for testing type **S** and G RCCBs in the manufacturing process. They are used for personal safety as well.

Measurement can be started with the positive half-wave at "0°" or with the negative half-wave at "180°".

Both measurements must nevertheless be performed. The longer of the two tripping times is decisive regarding the condition of the tested RCCB. Both values must be less than 40 ms.

#### Select Measuring Function

![](_page_20_Figure_7.jpeg)

#### Set the Parameter - Start with Positive or Negative Half-Wave

![](_page_20_Figure_9.jpeg)

#### Set the Parameter – 5 Times Nominal Current

![](_page_20_Figure_11.jpeg)

#### Note Note

The following restrictions apply to the selection of tripping current multiples relative to nominal current: 500 mA: 1 x, 2 x  $I_{AN}$ 

#### Start Measurement

![](_page_20_Picture_15.jpeg)

#### 7.2.4 Testing of RCCBs which are Suited for Pulsating DC Residual Current

In this case, RCCBs can be tested with either positive or negative half-waves. The standard calls for tripping at 1.4 times nominal current.

#### Select Measuring Function

![](_page_20_Figure_19.jpeg)

#### Set the Parameter - Positive or Negative Half-Wave

![](_page_20_Figure_21.jpeg)

#### Set the Parameter – Test With and Without "Non-Tripping Test"

![](_page_20_Figure_23.jpeg)

#### Non-Tripping Test

If, during the non-tripping test which lasts for 1 second, the RCD trips too early at 50%  $I_{\Delta N}$ , i.e. before the actual tripping test starts, the pop-up window shown at the right appears.

![](_page_20_Picture_26.jpeg)

#### 🐼 Note

The following restriction applies to the selection of tripping current multiples relative to nominal current: Double and five-fold nominal current is not possible in this case.

#### Note 🐼

According to DIN EN 50178 (VDE 160), only type B RCCBs (AC-DC sensitive) can be used for equipment with > 4 kVA, which is capable of generating smooth DC residual current (e.g. frequency converters). Tests with pulsating DC fault current only are not suitable for these RCCBs. Testing must also be conducted with smooth DC residual current in this case.

#### Note 🐼

Measurement is performed with positive and negative half-waves for testing RCCBs during manufacturing. If a circuit is charged with pulsating direct current, the function of the RCCB can be executed with this test in order to assure that the RCCB is not saturated by the pulsating direct current so that it no longer trips.

#### 7.3 **Testing for Special RCDs**

#### 7.3.1 System. Type RCD-S Selective RCCBs

Selective RCDs are used in systems which include two series connected RCCBs which are not tripped simultaneously in the event of a fault. These selective RCDs demonstrate delayed response characteristics and are identified with the S symbol.

#### Measuring Method

The same measuring method is used as for standard RCCBs (see sections 7.1 on page 18 and 7.2.1 on page 20).

If selective RCDs are used, earthing resistance may not exceed half of the value for standard RCCBs.

For this reason, the instrument displays twice the measured value for contact voltage.

#### Select Measuring Function

![](_page_21_Figure_8.jpeg)

#### Set Parameter - Selective

![](_page_21_Figure_10.jpeg)

#### Start Measurement

![](_page_21_Picture_12.jpeg)

![](_page_21_Picture_13.jpeg)

100mA

#### **Tripping Test**

Ď Press the  $I_{\Lambda N}$  key. The RCCB is tripped. Blinking bars appear at the display panel, after which time to trip t<sub>A</sub> and earthing resistance  $R_F$  are displayed.

The tripping test need only be performed at one measuring point for each RCCB.

![](_page_21_Picture_17.jpeg)

#### Note

Selective RCDs demonstrate delayed response characteristics. Tripping performance is briefly influenced (up to 30 s) due to pre-loading during measurement of contact voltage. In order to eliminate pre-charging caused by the measurement of contact voltage, a waiting period must be observed prior to the tripping test. After the measuring sequence has been started (tripping test), blinking bars are displayed for approximately 30 seconds. Tripping times of up to 1000 ms are allowable. The tripping test is executed immediately after once again pressing the  $I_{AN}$ key.

#### 7.3.2 PRCDs with Non-Linear Type PRCD-K Elements

The PRCD-K is a portable RCD with electronic residual current evaluation laid out as an in-line device which switches all poles (L, N and PE). An undervoltage trigger and protective conductor monitoring are additionally integrated into the PRCD-K.

The PRCD-K is equipped with an undervoltage trigger, for which reason it has to be operated with line voltage, and measurements may only be performed in the on state (PRCD-K switches all poles).

#### Terminology (from DIN VDE 0661)

Portable protective devices are circuit breakers which can be connected between power consuming devices and permanently installed electrical outlets by means of standardized plug-andsocket devices.

A reusable, portable protective device is a protective device which is designed such that it can be connected to movable cables.

Please be aware that a non-linear element is usually integrated into PRCDs, which leads to immediate exceeding of the greatest allowable contact voltage during  $U_{IA}$  measurements ( $U_{IA}$  greater than 50 V).

PRCDs which do not include a non-linear element in the protective conductor must be tested in accordance with section 7.3.3 on page 23.

#### **Objective (from DIN VDE 0661)**

Portable residual current devices (PRCDs) serve to protect persons and property. They allow for the attainment of increased levels of protection as provided by protective measures utilized in electrical systems for the prevention of electrical shock as defined in DIN VDE 0100, part 410. They are to be designed such that they can be installed by means of a plug attached directly to the protective device, or by means of a plug with a short cable.

#### **Measuring Method**

The following can be measured, depending upon the measuring method:

- Time to trip  $t_A$ : tripping test with nominal residual current  $I_{\Delta N}$  (The PRCD-K must be tripped at 50% nominal current.)
- Tripping current  ${\sf I}_\Delta$ : testing with rising residual current  ${\sf I}_{\sf F\_}$

or

#### **Select Measuring Function**

![](_page_22_Figure_5.jpeg)

![](_page_22_Figure_6.jpeg)

#### Connection

![](_page_22_Figure_8.jpeg)

#### Set the Parameter - PRCD with Non-Linear Elements

![](_page_22_Figure_10.jpeg)

![](_page_22_Figure_11.jpeg)

#### 7.3.3 SRCD, PRCD-S (SCHUKOMAT, SIDOS or comparable)

RCCBs from the SCHUKOMAT SIDOS series, as well as others which are of identical electrical design, must be tested after selecting the corresponding parameter.

Monitoring of the PE conductor is performed for RCDs of this type. The PE conductor is monitored by the summation current transformer. If residual current flows from L to PE, tripping current is cut in half, i.e. the RCCB must be tripped at 50% nominal residual current  $I_{\Delta N}$ .

Whether or not PRCDs and selective RCDs are of like design can be tested by measuring contact voltage  $U_{I\Delta N}$ . If a contact voltage  $U_{I\Delta N}$  of greater than 70 V is measured at the PRCD of an otherwise error-free system, the PRCD more than likely contains a non-linear element.

#### PRCD-S

The PRCD-S (portable residual current device – safety) is a special, portable, protective device with protective conductor detection or protective conductor monitoring. The device serves to protect persons from electrical accidents in the low-voltage range (130 to 1000 V). The PRCD-S must be suitable for commercial use, and is installed like an extension cable between an electrical consumer – as a rule an electrical tool – and the electrical outlet.

#### **Select Measuring Function**

![](_page_22_Picture_19.jpeg)

![](_page_22_Picture_20.jpeg)

#### Set Parameter – SRCD / PRCD

or

![](_page_22_Figure_22.jpeg)

![](_page_22_Figure_23.jpeg)

#### 7.3.4 Type G or R RCCB

In addition to standard RCCBs and selective RCDs, the special characteristics of the type G RCCB can also be tested with the test instrument.

The type G RCCB is an Austrian specialty and complies with the ÖVE/ÖNORM E 8601 device standard. Erroneous tripping is minimized thanks to its greater current carrying capacity and short-term delay.

#### **Select Measuring Function**

![](_page_23_Figure_4.jpeg)

#### Set Parameter - Type G/R (VSK)

![](_page_23_Figure_6.jpeg)

Contact voltage and time to trip can be measured in the G/R-RCD switch position.

#### 🐼 Note

It must be observed that time to trip for type G RCCBs may be as long as 1000 ms when measurement is made at nominal residual current. Set the limit value correspondingly.

➡ Then select 5 x I<sub>ΔN</sub> in the menu (this is selected automatically for the G/R setting) and repeat the tripping test beginning with the positive half-wave at 0° and the negative half-wave at 180°. The longer of the two tripping times is decisive regarding the condition of the tested RCCB.

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Set the Falan	ielei – Slait Wi		уануе пан-туаче

		¥	(1/1)	1
	Waveform:	0°: <b> ▲</b> ↓ 1×I∆n	0*: 📥 🛶 180*: 🛶 📥	Ŧ
180°: Sta 0°: Sta	art with neg. naif-wave – art with pos. half-wave –			
Negative direct current – Positive direct current –				$\overline{\checkmark}$
			ļ	[

#### Set the Parameter – 5 Times Nominal Current

![](_page_23_Figure_14.jpeg)

#### Note

The following restrictions apply to the selection of tripping current multiples relative to nominal current: 500 mA: 1 x, 2 x  $I_{\rm AN}$ 

#### Start Measurement

![](_page_23_Picture_18.jpeg)

In both cases, tripping time must be between 10 ms (minimum delay time for type G RCCBs!) and 40 ms.

Type G RCCBs with other nominal residual current values must be tested with the corresponding parameter setting under menu item  $I_{\Delta N}$ . In this case as well, the limit value must be appropriately adjusted.

#### 🐼 Note

The RCD **S** parameter setting for selective RCCBs is not suitable for type G RCCBs.

#### 7.4 Testing Residual Current Circuit Breakers in TN-S Systems

#### Connection

![](_page_24_Figure_2.jpeg)

RCCBs can only be used in TN-S systems. An RCCB would not work in a TN-C system because PE is directly connected to the neutral conductor in the outlet (it does not bypass the RCCB). This means that residual current would be returned via the RCCB and would not generate any differential current, which is required in order to trip the RCCB.

As a rule, the display for contact voltage is also 0.1 V, because the nominal residual current of 30 mA together with minimal loop resistance results in a very small voltage value:

$$UI\Delta N = R_F \cdot I\Delta N = 1\Omega \cdot 30mA = 30mV = \dot{0},03V$$

## 7.5 Testing of RCD Protection in IT Systems with High Cable Capacitance (e.g. in Norway)

The desired system type (TN/TT oder IT) can be selected for RCD test type  $U_{I\Delta N}$  ( $I_{\Delta N}$ ,  $t_a$ ), and for earthing measurement (R<sub>E</sub>). A probe is absolutely essential for measurement in IT systems, because contact voltage  $U_{I\Delta N}$  which occurs in these systems cannot otherwise be measured.

After selecting the IT system setting, connection with probe is selected automatically.

#### Set the Parameter - Select System Type

![](_page_24_Figure_10.jpeg)

![](_page_24_Figure_11.jpeg)

#### 8 Testing of Breaking Requirements Overcurrent Protective Devices, Measurement of Loop Impedance and Determination of Short-Circuit Current (functions Z<sub>L-PE</sub> and I<sub>K</sub>)

Testing of overcurrent protective devices includes visual inspection and measurement. Use the **PROFITEST MASTER** or **SECULIFE IP** to perform measurements.

#### **Measuring Method**

Loop impedance  $Z_{L-PE}$  is measured and short-circuit current  $I_K$  is ascertained in order to determine if the breaking requirements for protective devices have been fulfilled.

Loop impedance is the resistance within the current loop (utility station – phase conductor – protective conductor) when a short-circuit to an exposed conductive part occurs (conductive connection between phase conductor and protective conductor). Short-circuit current magnitude is determined by the loop impedance value. Short-circuit current I<sub>K</sub> may not fall below a predetermined value set forth by DIN VDE 0100, so that reliable breaking of the protective device (fuse, automatic circuit breaker) is assured. Thus the measured loop impedance value must be less than the

nus the measured loop impedance value must be less than the maximum allowable value.

Tables containing allowable display values for loop impedance and minimum short-circuit current display values for ampere ratings for various fuses and circuit breakers can be found in the help texts and in section 21 beginning of page 88. Maximum device error in accordance with VDE 0413 has been taken into consideration in these tables. See also section 8.2.

In order to measure loop impedance  $Z_{L-PE}$ , the instrument uses a test current of 3.7 to 7 A (60 to 550 V) depending on line voltage and line frequency. At 16 Hz, the test has a duration of no more than 1200 ms.

## If dangerous contact voltage occurs during measurement (> 50 V), safety shut-down occurs.

The test instrument calculates short-circuit current I<sub>K</sub> based on measured loop impedance Z<sub>L-PE</sub> and line voltage. Short-circuit current calculation is made with reference to nominal line voltage for line voltages which lie within the nominal ranges for 120 V, 230 V and 400 V systems. If line voltage does not lie within these nominal ranges, the instrument calculates short-circuit current I<sub>K</sub> based on prevailing line voltage and measured loop impedance Z<sub>L-PE</sub>.

#### Measuring Method with Suppression of RCD Tripping

The **PROFITEST MXTRA** and **SECULIFE IP** provides users with the opportunity of measuring loop impedance within systems which are equipped with RCCBs.

The test instrument generates a direct current to this end, which saturates the RCCB's magnetic circuit.

The test instrument then superimposes a measuring current which only demonstrates halfwaves of like polarity. The RCCB is no longer capable of detecting this measuring current, and

![](_page_25_Figure_14.jpeg)

is consequently not tripped during measurement.

A four conductor measuring cable is used between the instrument and the test plug. Cable and measuring adapter resistance is automatically compensated for during measurement and does not effect measurement results. Select Measuring Function

![](_page_25_Picture_18.jpeg)

Connection: Schuko / 3-Pole Adapter

![](_page_25_Figure_20.jpeg)

![](_page_25_Figure_21.jpeg)

![](_page_25_Figure_22.jpeg)

#### 🐼 Note

Loop impedance should be measured for each electrical circuit at the farthest point, in order to ascertain maximum loop impedance for the system.

### Note

#### Bias Magnetization

Only AC measurements can be performed with the 2pole adapter. Suppression of RCD tripping by means of bias magnetization with direct current is only possible via a country-specific plug insert, e.g. SCHUKO, or the 3pole adapter (neutral conductor necessary).

#### 🐼 Note

Observe national regulations, e.g. the necessity of conducting measurements without regard for RCCBs in Austria.

#### **3-Phase Connections**

Measurement of loop impedance to earth must be performed at all three phase conductors (L1, L2, and L3) for the testing of overcurrent protective devices at three phase outlets.

#### 8.1 Measurements with Suppression of RCD Tripping

#### Start Measurement

#### 8.1.1 Measurement with Positive Half-Waves (only MTECH+/MXTRA/SECULIFE IP)

Measurement by means of half-waves plus direct current makes it possible to measure loop impedance in systems which are equipped with RCCBs.

For DC measurement with half-waves you can choose between two alternatives:

- **DC-L:** lower premagnetization current allowing for faster measurement
- **DC-H:** higher premagnetization current, therefore higher protection against tripping of RCD

#### Select Measuring Function

Z<sub>L-PE</sub>

#### Set Parameters

![](_page_26_Figure_10.jpeg)

Parameters used for report generation only which do not influence the measurement

![](_page_26_Figure_12.jpeg)

15 mA sinusoidal

Setting only for protocol with but how with low nominal current

DC+half-wave

Setting for electric circuits with RCD

![](_page_26_Picture_17.jpeg)

![](_page_26_Picture_18.jpeg)

Semiautomatic Measurement

#### 8.2 Evaluation of Measured Values

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The maximum allowable loop impedance  $Z_{L-PE}$ which may be displayed after allowance has been made for maximum operating measurement error (under normal measuring conditions) can be determined with the help of Table 1 on page 88. Intermediate values can be interpolated.

The maximum allowable nominal current for the protective device (fuse

![](_page_26_Picture_23.jpeg)

f.

---Hz

or circuit breaker) for a line voltage of 230 V after allowance has been made for maximum measuring error can be determined with the help of Table 6 on page 89 based upon measured short-circuit current (corresponds to DIN VDE 0100 Part 600).

#### Special Case: Suppressing Display of the Limit Value

The limit value cannot be ascertained. The inspector is prompted to evaluate the measured values himself, and to acknowledge or reject them with the help of the softkeys.

Measurement passed: key ✔

Measurement failed: X key

![](_page_26_Picture_29.jpeg)

The measured value can only be saved after it has been evaluated.

![](_page_27_Picture_1.jpeg)

8.3 Settings for Short-circuit current Calculation – Parameter I<sub>K</sub>

![](_page_27_Figure_3.jpeg)

Short-circuit current  $I_K$  is used to test shutdown by means of an overcurrent protective device. In order for an overcurrent protective device to be tripped on time, short-circuit current  $I_K$  must be greater than tripping current Ia (see table 6 in section 21.1). The variants which can be selected with the "Limits" key have the following meanings:

- $I_{K}\!\!:$  Ia The measured value displayed for  $I_{K}$  is used without any correction to calculate  $Z_{L\text{-PE}}\!\!:$
- $I_K: Ia + \Delta\%$  The measured value displayed for  $Z_{L-PE}$  is corrected by an amount equal to the test instrument's measuring uncertainty in order to calculate  $I_K$ .
- I<sub>K</sub>: 2/3 Z In order to calculate I<sub>K</sub>, the measured value displayed for Z<sub>L-PE</sub> is corrected by an amount corresponding to all possible deviations (these are defined in detail by VDE 0100, part 600, as Z<sub>s(m)</sub>  $\leq$  2/3 x U<sub>0</sub>/Ia).
- $I_{\rm K}: 3/4 \ {\rm Z} \ {\rm Z}_{\rm s(m)} \le 3/4 \ {\rm x} \ {\rm U}_{\rm 0}/{\rm Ia}$
- I<sub>K</sub> Short-circuit current calculated by the instrument (at nominal voltage)
- Z Fault loop impedance
- la Tripping current (see data sheets for circuit breakers / fuses)
- $\Delta$ % Test instrument intrinsic error

Special Case  $I_k > I_{kmax}$  see page 29.

### 9 Measuring Line Impedance (Z<sub>L-N</sub> function)

#### Measuring Method (internal line resistance measurement)

Supply impedance  $Z_{L-N}$  is measured by means of the same method used for loop impedance  $Z_{L-PE}$  (see section 8 on page 26). However, the current loop is completed via neutral conductor N rather than protective conductor PE as is the case with loop impedance measurement.

#### Select Measuring Function

![](_page_27_Figure_18.jpeg)

Connection: Schuko

![](_page_27_Figure_20.jpeg)

#### Connection: 2-Pole Adapter

![](_page_27_Figure_22.jpeg)

#### Set Parameters

![](_page_27_Figure_24.jpeg)

![](_page_27_Picture_25.jpeg)

Press the softkey shown at the left in order to switch back and forth between the country-specific plug insert, e.g. SCHUKO, and 2-pole adapter. The selected connection type is displayed inversely (white on black).

![](_page_28_Figure_0.jpeg)

#### Settings for Short-circuit current Calculation – Parameter I<sub>K</sub>

![](_page_28_Figure_2.jpeg)

Short-circuit current  $I_{K}$  is used to test shutdown by means of an overcurrent protective device. In order for an overcurrent protective device to be tripped on time, short-circuit current IK must be greater than tripping current la (see table 6 in section 21.1). The variants which can be selected with the "Limits" key have the following meanings:

- The measured value displayed for  $I_K$  is used without I<sub>K</sub>: la any correction to calculate Z<sub>L-PE</sub>.
- $I_{\text{K}}\!\!:$  Ia+ $\!\Delta\%$  The measured value displayed for  $Z_{\text{L-PE}}$  is corrected by an amount equal to the test instrument's measuring uncertainty in order to calculate I<sub>K</sub>.
- I<sub>K</sub>: 2/3 Z In order to calculate  $I_{K}$ , the measured value displayed for Z<sub>L-PE</sub> is corrected by an amount corresponding to all possible deviations (these are defined in detail by VDE 0100, part 600, as  $Z_{s(m)} \le 2/3 \times U_0/la$ ).

 $I_{\rm K}: 3/4 \ {\rm Z} \ {\rm Z}_{\rm s(m)} \le 3/4 \ {\rm x} \ {\rm U}_0/{\rm la}$ 

- $I_{K}$  Short-circuit current calculated by the instrument (at nominal voltage)
- 7 Fault loop impedance
- la Tripping current (see data sheet for circuit breakers / fuses)  $\Lambda$ %Test instrument inherent error

#### Special case $I_k > I_{kmax}$

If the value for the shortcircuit current is beyond the measured values defined in PROFITEST MASTER, it is indicated by > IK-max". In this case, it will be

necessary to evaluate the measuring result manually.

![](_page_28_Picture_14.jpeg)

### ΡË BAT 🏧 MEM [::::] ZL-N >120A IK

Start Measurement

![](_page_28_Picture_16.jpeg)

f ---Hz

IN 16A

[YP: B/I

1.5mm<sup>2</sup>

⊐⊧⊙

- TET

.imits

IK:2/3Z

L1-N

#### Display of $U_{L-N}$ ( $U_N$ / $f_N$ )

If the measured voltage value lies within a range of  $\pm 10\%$  of the respective nominal line voltage of 120 V, 230 V or 400 V, the respectively corresponding nominal line voltage is displayed. In the case of measured values outside of the ±10% tolerance, the actual measured value is displayed.

---U

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#### **Displaying the Fuse Table**

After measurement has been performed, allowable fuse types can be displayed by pressing the HELP key.

The table shows maximum allowable nominal current dependent upon fuse type and breaking requirements.

![](_page_28_Figure_22.jpeg)

Ік: 199 А				
	[к: і Ім	2/3Z  9L∕9G	In	
A : B/L: E : C/G: D : K : H :	40A 25A 20A 13A 6.0A 8.0A 50A	<5s : <0.4s: <0.2s: <1s :	25A 16A 16A 20A	

Key: la = breaking current, I<sub>K</sub> = short-circuit current,  $I_N$  = nominal current,  $t_A$  = tripping time

#### 10 Earthing Resistance Measurement (R<sub>E</sub> function)

Earthing resistance R<sub>F</sub> is important for automatic shutdown in system segments. It must have a low value in order to assure that high short-circuit current flows and the system is shut down reliably by the RCCB in the event of a fault.

#### Test Setup

Earthing resistance (R<sub>E</sub>) is the sum of the earth electrode's dissipation resistance and earth conductor resistance. Earthing resistance is measured by applying an alternating current via the earth conductor, the earth electrode and earth electrode resistance. This current, as well as voltage between the earth electrode and a probe, are measured.

The probe is connected to the probe connector socket (17) with a 4 mm contact protected plug.

#### Direct Measurement with Probe (mains powered measurement)

Direct measurement of earthing resistance R<sub>F</sub> is only possible within a measuring circuit which includes a probe. However, this means that the probe and reference earth must be of like potential, i.e. that they are positioned outside of the potential gradient area. The distance between the earth electrode and the probe should be at least 20 m.

#### Measurement without Probe (mains powered measurement)

In many cases, especially in extremely built-up areas, it is difficult. or even impossible, to set a measuring probe. In such cases, earthing resistance can be measured without a probe. In this case, however, the resistance values for the operational earth electrode R<sub>B</sub> and phase conductor L are also included in the measurement results.

#### Measuring Method (w. probe) (mains powered measurement)

The instrument measures earthing resistance R<sub>E</sub> by means of the ammeter-voltmeter test.

Resistance  $R_F$  is calculated from the quotient of voltage  $U_F$  and current I<sub>F</sub> where U<sub>F</sub> is between the earth electrode and the probe. The test current which is applied to earthing resistance is controlled by the instrument (see section 19, "Characteristic Values", beginning on page 82 for pertinent values)

A voltage drop is generated which is proportional to earthing resistance.

#### 🔊 Note

Measurement cable and measuring adapter resistance are compensated for automatically during measurement and have no effect on measurement results.

If dangerous contact voltages occur during measurement (> 50 V), the measurement is interrupted and safety shutdown occurs.

Probe resistance does not effect measurement results and may be as high as 50 k $\Omega$ .

#### Attention!

The probe is part of the measuring circuit and may carry a current of up to 3.5 mA in accordance with VDE 0413.

#### Measurement with or without earth electrode voltage depending upon entered parameters and the selected type of connection:

RANGE	Connection	Measuring Functions
xx $\Omega$ / xx k $\Omega$	(2-P) ====================================	No probe measurement No U <sub>E</sub> measurement
10 $\Omega$ / U <sub>E</sub> *	(]-P;(]=+7;;;;	Probe measurement activated U <sub>E</sub> is measured
	( <b>3-P):12*+</b> 7#)	Probe measurement activated No U <sub>E</sub> measurement
XX 52 / XX K52	SEL 3-P 📆	Clamp measurement activated No $\mathrm{U}_\mathrm{E}$ measurement

\* This parameter results in automatic selection of probe connection.

#### Measuring Method with Suppression of RCD Tripping (mains powered earthing measurement)

The test instrument I<sub>F</sub>/mA generates a direct current to this end, which saturates the RCCB's magnetic circuit. The test instrument t1 t2 then superimposes Measurement a measuring current Operation which only demonstrates half-waves **RCD Disabled!** of like polarity. The Start RCCB is no longer capable of detect-Suppression of RCCB tripping for RCCBs which ing this measuring are sensitive to pulsating current  $\ge$ current, and is con-

sequently not tripped during measurement.

A four conductor measuring cable is used between the instrument and the test plug. Cable and measuring adapter resistance is automatically compensated for during measurement and does not effect measurement results.

t3

#### Limit Values

Earthing resistance (earth coupling resistance) is determined primarily by the electrode's contact surface and the conductivity of the surrounding earth.

The specified limit value depends on the type of electrical system and its shutdown conditions in consideration of maximum contact voltage.

#### Evaluation of Measured Values

The maximum allowable displayed resistance values which assure that the required earthing resistance is not exceeded, and for which maximum device operating error has already been taken into consideration (at nominal conditions of use), can be determined with the help of Table 2 on page 88. Intermediate values can be interpolated.

#### 10.1 Earthing Resistance Measurement – Mains Operated

#### The following types of measurement or connection are possible:

- 2-pole measurement via 2-pole adapter
- 2-pole measurement via earthing contact plug (not possible in IT systems)
  - 3-pole measurement via 2-pole adapter and probe
- Selective measurement: 2-pole measurement with probe and current clamp sensor

At left in figure: 2-pole measuring adapter for contacting PE and L measuring points

At right in figure:

adapter can be

used as an alter-

measuring

native.

The PRO-Schuko

#### **Select Measuring Function**

![](_page_30_Picture_9.jpeg)

#### Select Operating Mode

![](_page_30_Picture_11.jpeg)

The selected operating mode is displayed inversely: mains~ in white against a black background.

![](_page_30_Figure_13.jpeg)

#### Battery powered measurement is not possible:

The error message shown at the left appears if the selected connection type is inappropriate for the operating mode.

### Special Case: Manual Measuring Range Selection (test current selection)

(R  $\neq$  AUTO, R = 10 k $\Omega$  (4 mA), 1 k $\Omega$  (40 mA), 100  $\Omega$  (0.4 A), 10  $\Omega$  (3.7 ... 7 A), 10  $\Omega/U_{\text{F}}$ )

#### 🐼 Note

When the measuring range is selected manually, accuracy values are only valid starting at 5% of the upper limit range value (except for the 10  $\Omega$  range; separate display for small values).

#### Set Parameters

 $\hfill\square$  Measuring range: AUTO, 10 k $\Omega$  (4 mA), 1 k $\Omega$  (40 mA), 100  $\Omega$  (0.4 A), 10  $\Omega$  (> 3.7 A)

In systems with RCCBs, resistance or test current must be selected such that it is less than tripping current (½  $I_{\Delta N}$ ).

- □ Contact voltage: UL < 25 V, < 50 V, < 65 V, see section 5.7 regarding freely selectable voltage.
- □ Transformer ratio: depends on utilized current clamp sensor
- Connection type: 2-pole adapter, 2-pole adapter + probe, 2-pole adapter + clamp meter
- □ Type of system: TN or TT

#### Test current waveform

See section 10.4 through section 10.6 regarding advisable parameters for the respective measurement and connection types.

#### Perform Measurements

See section 10.4 through section 10.6.

#### 10.2 Earthing Resistance Measurement – Battery Powered (only MPRO & MXTRA)

#### The 5 following types of measurement or connection are possible:

- 3-Pienees 3-Pole measurement via PRO-RE adapter
- H-P 4-Pole measurement via PRO-RE adapter
- SEL ..... Selective measurement with clamp meter (4-pole) via PRO-RE adapter
- 2-A A A 2-clamp measurement via PRO-RE/2 adapter
- (3) Ideasurement of soil resistivity  $\rho_{E}$  via PRO-RE adapter

#### Figure at right:

PRO-RE adapter for connecting earth electrode, auxiliary earth electrode, probe and auxiliary probe to the test instrument for 3/4-pole measurement, selective measurement and measurement of soil resistivity

![](_page_30_Picture_40.jpeg)

#### Figure at right:

PRO-RE/2 measuring adapter as accessory for connecting the E-Clip 2 generator clamp for 2-clamp measurement and earth loop resistance measurement.

#### **Select Measuring Function**

![](_page_30_Picture_44.jpeg)

#### Select Operating Mode

![](_page_30_Figure_46.jpeg)

The selected operating mode is displayed inversely: white battery icon against black background.

![](_page_30_Picture_48.jpeg)

Mains powered measurement is not possible: The error message shown at the left appears if the selected connection type is inappropriate for the operating mode.

#### Set Parameters

- $\hfill \hfill \hfill$
- Current clamp sensor transformer ratio:
- 1:1 (1 V/A,) 1:10 (100 mV/A), 1:100 (10 mV/A), 1:1000 (1 mV/A)
- $\Box$  Connection type: 3-pole, 4-pole, selective, 2-clamp,  $\rho_{\text{E}}$  (Rho)
- $\square$  Distance d (for measuring  $\rho_{\text{E}}$ ): xx m

See section 10.7 through section 10.11 regarding advisable parameters for the respective measurement and connection types.

#### Perform Measurements

See section 10.7 through section 10.11.

apter as the Er 2-clamp poop resis-

## tance measurement.

10.3 Earthing Resistance, Mains Powered – 2-Pole Measurement with 2-Pole Adapter or Country-Specific Plug (Schuko) without Probe

![](_page_31_Figure_1.jpeg)

#### Key

- R<sub>B</sub> Operational earth
- R<sub>E</sub> Earthing resistance
- R<sub>i</sub> Internal resistance
- R<sub>X</sub> Earthing resistance through equipotential bonding systems
- R<sub>S</sub> Probe resistance
- PAS Equipotential bonding busbar
- $\text{RE}_{\_\_}$  Overall earthing resistance (R\_{E1}//R\_{E2}//water pipe)

In the event that it is impossible to set a probe, earthing resistance can be estimated by means of an "earth loop resistance measurement" without probe.

The measurement is performed exactly as described in section 10.4, "Earthing Resistance Measurement, Mains Powered – 3-Pole Measurement: 2-Pole Adapter with Probe", beginning on page 33. However, no probe is connected to the probe connector socket (17).

The resistance value  $\mathsf{R}_{ELoop}$  obtained with this measuring method also includes operational earth electrode resistance  $\mathsf{R}_B$  and resistance at phase conductor L. These values must be deducted from the measured value in order to determine earthing resistance.

If conductors of equal cross section are assumed (phase conductor L and neutral conductor N), phase conductor resistance is half as great as supply impedance  $Z_{L-N}$  (phase conductor + neutral conductor). Supply impedance can be measured as described in section 9 beginning of page 28. In accordance with DIN VDE 0100, operational earth electrode  $R_B$  must lie within a range of "0  $\Omega$  to 2  $\Omega$ ".

1) Measurement:  $Z_{LN}$  amounts to  $R_i = 2 \cdot R_L$ 

2) Measurement:  $Z_{L-PE}$  amounts to  $R_{ELoop}$ 3) Calculation:  $R_{E1}$  amounts to  $Z_{L-PE} - 1/2 \cdot Z_{L-N}$ ; where  $R_B = 0$ 

The value for operational earth conductor resistance  ${\sf R}_{\sf B}$  should be ignored in the calculation of earthing resistance, because it is generally unknown.

The calculated earthing resistance thus includes operational earth conductor resistance as a safety factor.

In parameter setting **E-P - - - - -** steps 1 to 3 are performed automatically by the test instrument.

#### **Select Measuring Function**

![](_page_31_Figure_20.jpeg)

Select Operating Mode

![](_page_31_Picture_22.jpeg)

#### Set Parameters

- □ Measuring range: AUTO, 10 kΩ (4 mA), 1 kΩ (40 mA), 100 Ω (0.4 A), 10 Ω (3.7 ... 7 A). In systems with RCCBs, resistance or test current must be selected such that it is less than tripping current ( $\frac{1}{2} I_{\Delta N}$ ).
- □ Connection type: 2-pole adapter
- $\hfill\square$  Contact voltage: UL < 25 V, < 50 V, < 65 V
- □ Test current waveshape: Sinusoidal (full-wave), 15 mA sinusoidal (full-wave), DC offset and positive half-wave
- System type: TN/TT, IT
- □ Transformer ratio: irrelevant in this case

![](_page_31_Figure_30.jpeg)

#### 10.4 Earthing Resistance Measurement, Mains Powered – 3-Pole Measurement: 2-Pole Adapter with Probe

![](_page_32_Figure_1.jpeg)

#### Key

- R<sub>B</sub> Operational earth electrode
- R<sub>E</sub> Earthing resistance
- $\mathsf{R}_X$  Earthing resistance through equipotential bonding systems
- R<sub>S</sub> Probe resistance
- PAS Equipotential bonding busbar
- $RE_{1}$  Overall earthing resistance ( $R_{E1}$ // $R_{E2}$ //water pipe)

Measurement of  $R_E \left( R_{E1} = \frac{U_{Probe}}{I} \right)$ 

#### **Select Measuring Function**

![](_page_32_Picture_11.jpeg)

#### Select Operating Mode

![](_page_32_Picture_13.jpeg)

Connection

#### Set Parameters

#### □ Measuring range: AUTO,

- 10 k $\Omega$  (4 mA), 1 k $\Omega$  (40 mA), 100  $\Omega$  (0.4 A), 10  $\Omega$  (3.7 ... 7 A) In systems with RCCBs, resistance or test current must be selected such that it is less than tripping current (½  $I_{\Delta N}$ ).
- □ Connection type: 2-pole adapter + probe
- □ Contact voltage: UL < 25 V, < 50 V, < 65 V, see section 5.7 regarding freely selectable voltage.

#### Test current waveshape:

Sinusoidal (full-wave), 15 mA sinusoidal (full-wave), DC offset and positive half-wave

- □ System type: TN/TT, IT
- □ Transformer ratio: irrelevant in this case

![](_page_32_Figure_23.jpeg)

#### Start Measurement

ĒΕ

![](_page_32_Figure_25.jpeg)

🐼 Note

The following diagram appears if the 2-pole adapter is connected incorrectly.

![](_page_32_Picture_28.jpeg)

\_\_\_\_\_

![](_page_32_Picture_30.jpeg)

2-pole adapter and probe are connected

HELP

![](_page_32_Picture_32.jpeg)

10.5 Earthing Resistance Measurement, Mains Powered – Measurement of Earth Electrode Voltage (U<sub>E</sub> function)

![](_page_33_Figure_1.jpeg)

This measurement is only possible with a probe (see section 10.4). Earth electrode potential  $U_E$  is the voltage which occurs at the earth electrode between the earth electrode terminal and reference earth if a short-circuit occurs between the phase conductor and the earth electrode. Measurement of earth electrode potential is required by Swiss standard NIV/NIN SEV 1000.

#### **Measuring Method**

In order to determine earth electrode potential, the instrument first measures earth electrode loop resistance  $R_{ELoop},$  and immediately thereafter earthing resistance  $R_E.$  The instrument stores both values and then calculates earth electrode potential with the following equation:

![](_page_33_Figure_5.jpeg)

The calculated value is displayed at the display panel.

#### **Select Measuring Function**

![](_page_33_Figure_8.jpeg)

- Set Parameters  $\Box$  Measuring range: 10  $\Omega$  /  $U_E$
- Connection type: 2-pole adapter + probe
- □ Contact voltage: UL < 25 V, < 50 V, < 65 V, see section 5.7 regarding freely selectable voltage.
- □ Test current waveshape: sinusoidal only in this case (full-wave)!
- System type: TN/TT, IT
- □ Transformer ratio: irrelevant in this case

![](_page_33_Figure_15.jpeg)

![](_page_33_Figure_16.jpeg)

2-pole adapter and probe are connected.

### 10.6 Earthing Resistance Measurement, Mains Powered – Selective Earthing Resistance Measurement with Current Clamp Sensor as Accessory

As an alternative to the conventional measuring method, measurement can also be performed with a current clamp sensor.

![](_page_34_Figure_2.jpeg)

#### Key

- R<sub>B</sub> Operational earth
- R<sub>E</sub> Earthing resistance
- R<sub>L</sub> Cable resistance
- $R_X$  Earthing resistance through equipotential bonding systems
- R<sub>S</sub> Probe resistance
- PAS Equipotential bonding busbar
- RE\_\_\_\_ Overall earthing resistance (R<sub>E1</sub> // R<sub>E2</sub> // water pipe)

Measurement without clamp:  $R_E = R_{E1} // R_{E2}$ 

Measurement with clamp:

$$R_{E} = R_{E2} = \left(\frac{U_{Probe}}{I_{Clamp}}\right)$$

**Select Measuring Function** 

![](_page_34_Picture_15.jpeg)

#### Select Operating Mode

![](_page_34_Picture_17.jpeg)

Connection

![](_page_34_Figure_19.jpeg)

2-pole adapter, clamp and probe are connected.

#### >20m

#### Set Parameters at Tester

- **D** Measuring range (test current selection): 1 kΩ (40 mA), 100 Ω (0.4 A), 10 Ω (3.7 ... 7 A) In the case of systems with RCCBs, the DC + functions can be selected (only in the 10 Ω range and only with the METRAFLEX P300).
- Connection type: 2-pole adapter + clamp After parameter selection: automatic setting to 10 Ω measuring range and 1 V/A or 1000 mV/A transformer ratio
- □ Contact voltage: UL < 25 V, < 50 V, < 65 V, see section 5.7 regarding freely selectable voltage.
- □ Test current waveshape:
- Sinusoidal (full-wave), DC offset and positive half-wave System type: TN/TT, IT
- Current clamp sensor transformation ratio: see table below

#### Set Parameters at Current Clamp Sensor

□ Current clamp sensor measuring range: see table below

#### Selecting a Measuring Range at the Current Clamp Sensor

Tester	METRAFLEX P300 Clamp		Tester
Transforma- tion Ratio Parameter	Switch	Measuring Range	Measuring Range
1:1 1 V / A	3 A (1 V/A)	3 A	0.5 100 mA
1:10 100 mV / A	30 A (100 mV/A)	30 A	5 999 mA
1:100 10 mV / A	300 A (10 mV/A)	300 A	0.05 10 A

#### Important Instructions for Use of the Current Clamp Sensor

- Use only the METRAFLEX P300 or the Z3512A current clamp sensor for this measurement.
- Read and adhere to the **operating instructions** for the METRAFLEX P300 current clamp sensor, as well as the safety precautions included therein.
- Observe direction of current flow (see arrow on the current clamp sensor).
- Use the clamp in the permanently connected state. The sensor may not be moved during measurement.
- The current clamp sensor may only be used at an adequate distance from powerful extraneous fields.
- Before use, always inspect the electronics housing, the connector cable and the current sensor for damage.

- In order to prevent electric shock, keep the surface of the METRAFLEX clean and free of contamination.
- Before use, make sure that the flexible current sensor, the connector cable and the electronics housing are dry.

#### Start Measurement

![](_page_35_Figure_3.jpeg)

In the event that you have changed the transformation ratio at the test instrument, a pop-up window appears indicating that this new setting also has to be entered to the connected current clamp sensor.

![](_page_35_Picture_5.jpeg)

ON

![](_page_35_Figure_6.jpeg)

RE<sub>Clamp</sub>: Selective earthing resistance measured via clamp RE<sub>Probe</sub>: Total earthing resistance measured via probe, comparative value

#### Note Note

The following diagram appears if the 2-pole adapter is connected incorrectly.

![](_page_35_Picture_10.jpeg)
# 10.7 Earthing Resistance Measurement, Battery Operated – 3-Pole (only MPRO & MXTRA)

# 3-Wire Method





Measurement of Earthing Resistance with 3-Wire Method

# 🐼 Note

The measurement cables must be well insulated in order to prevent shunting. In order to keep the influence of possible coupling to a minimum, the measurement cables should not cross each other or run parallel to each other over any considerable distance.

## **Select Measuring Function**



# Select Operating Mode



The selected operating mode is displayed inversely: white battery icon against black background.

# Set Parameters

- $\hfill\square$  Measuring range: AUTO, 50 kΩ, 20 kΩ, 2 kΩ, 200 Ω, 20 Ω
- Connection type: 3-pole
- Transformer ratio: irrelevant in this case
- $\square$  Distance d (for measuring  $\rho_{\text{E}}$ ): irrelevant in this case

#### Start Measurement



- Position the spikes for the probe and the auxiliary electrode at least 20, respectively 40 meters from the electrode (see figure above).
- Make sure that no excessively high contact resistances occur between the probe and the ground.
- Attach the PRO-RE adapter (Z501S) to the test plug.
- Connect the probe, the auxiliary electrode and the electrode via the 4 mm banana plug sockets at the **PR0-RE adapter**. In doing so, observe labeling on the banana plug sockets. Terminal ES/P1 is not connected.

The resistance of the measurement cable to the earth electrode is incorporated directly into the measurement results.

In order to keep error caused by measurement cable resistance as small as possible, a short connector cable with large crosssection should be used between the earth electrode and terminal "E" for this measuring method.



# 10.8 Earthing Resistance Measurement, Battery Operated – 4-Pole (only MPRO & MXTRA)

## 4-Wire Method



The 4-wire method is used in the case of high cable resistance between the earth electrode and the instrument terminal.

The resistance of the cable between the earth electrode and the "E" terminal at the instrument is measured in this case.



Figure 10.8.1:Measurement of Earthing Resistance with 4-Wire Method

## Connection



- Position the spikes for the probe and the auxiliary electrode at least 20, respectively 40 meters from the electrode (see figure above).
- Make sure that no excessively high contact resistances occur between the probe and the ground.
- Attach the **PRO-RE adapter (Z501S)** to the test plug.
- Connect the probes, the auxiliary electrode and the electrode via the 4 mm banana plug sockets at the PRO-RE adapter.
   In doing so, observe labeling on the banana plug sockets.

#### Note Note

In the case of the 4-wire method, the earth electrode is connected to the "E" and "ES" terminals with two separate measurement cables, the probe is connected to the "S" terminal and the auxiliary earth electrode is connected to the "H" terminal.

# 🔊 Note



#### Select Measuring Function



#### Select Operating Mode



The selected operating mode is displayed inversely: white battery icon against black background.

#### Set Parameters

- $\Box$  Measuring range: AUTO, 50 kΩ, 20 kΩ, 2 kΩ, 200 Ω, 20 Ω
- □ Connection type: 4-pole
- □ Transformer ratio: irrelevant in this case
- $\Box$  Distance d (for measuring  $\rho_{\text{E}}$ ): irrelevant in this case

#### Start Measurement



## **Potential Gradient Area**

Information regarding suitable positioning of the probe and the auxiliary earth electrode can be obtained by observing voltage characteristics or dissipation resistance in the ground.

The measuring current from the earth tester which flows via the earth electrode and the auxiliary earth electrode causes a given potential distribution in the form of a potential gradient area (see also Figure 10.8.3: on page 39). Resistance distribution is analogous to potential distribution.

Dissipation resistance of the earth electrode and the auxiliary earth electrode differs as a rule. The potential gradient area and the resistance gradient area are thus not symmetrical.

## **Dissipation Resistance of Small Scope Earth Electrodes**

The arrangement of the probe and the auxiliary earth electrode is very important for correct determination of the dissipation resistance of earth electrodes.

The probe must be positioned between the earth electrode and the auxiliary earth electrode within the so-called neutral zone (reference earth) (see also Figure 10.8.2: on page 39).

The voltage or resistance curve is thus nearly horizontal within the neutral zone.

Proceed as follows in order to select suitable probe and auxiliary earth electrode resistances:

Drive the auxiliary earth electrode into the ground at a distance of roughly 40 meters from the earth electrode.

- Position the probe halfway between the earth electrode and the auxiliary earth electrode and determine earthing resistance.
- Reposition the probe 2 to 3 meters closer to the earth electrode, and then 2 to 3 meters closer to the auxiliary earth electrode and measure earthing resistance in each position.

If all 3 measurements result in the same measured value, this is the correct earthing resistance. The probe is in the neutral zone. However, if the three measured values for earthing resistance differ from each other, either the probe is not located in the neutral zone, or the voltage or resistance curve is not horizontal at the point at which the probe has been inserted.



Figure 10.8.2: Voltage Curve in Homogenous Earth between Earth Electrode E and Auxiliary Earth Electrode H

Correct measurements can be obtained in such cases by either increasing distance between the earth electrode and the auxiliary earth electrode, or by moving the probe to the perpendicular bisector between the earth electrode and the auxiliary earth electrode (see also Figure 10.8.3:). When the probe is moved to the perpendicular bisector, its location is removed from the sphere of influence of the two potential gradient areas caused by the earth electrode and the auxiliary earth electrode.



Figure 10.8.3: Probe Distance S Outside of the Overlapping Potential Gradient Areas on the Perpendicular Bisector of Earth Electrode E and Auxiliary Earth Electrode H

#### **Dissipation Resistance of Large Scope Earthing Systems**

Significantly large distances to the probe and the auxiliary earth electrode are required for measuring large scope earthing systems. Calculations are based on 2½ or 5 times the value of the earthing system's largest diagonal.

Large scope earthing systems of this sort often demonstrate dissipation resistances of only a few ohms, which makes it especially important to position the measuring probe within the neutral zone. The probe and the auxiliary earth electrode should be positioned at a right angle to the direction of the earthing system's largest linear expansion. Dissipation resistance must be kept small. If necessary, several earth spikes must be used at a distance of 1 to 2 m from each other and connected to this end.

However, in actual practice large measuring distances are frequently not possible to due difficult terrain. If this is the case, proceed as shown in Figure 10.8.4:.

- Auxiliary earth electrode H is positioned as far from possible from the earthing system.
- ➡ The area between the earth electrode and the auxiliary earth electrode is sampled in equal steps of 5 meters each.
- Measured resistance values are displayed as a table, and then plotted graphically as depicted in Figure 10.8.4: (curve I).

If a line parallel to the abscissa is drawn through inflection point S1, this line divides the resistance curve into two parts. Measured at the ordinate, the bottom part results in sought dissipation resistance of the earth electrode  $R_{A/E}$ , and the top value equals dissipation resistance of the auxiliary earth electrode  $R_{A/H}$ . With a measurement setup of this type, dissipation resistance of the auxiliary earth electrode the auxiliary earth electrode the dissipation resistance of the earth electrode.

In the case of resistance curves without a well defined horizontal area, measurement should be double checked after repositioning the auxiliary earth electrode. This additional resistance curve must be entered to the first diagram with a modified abscissa scale such that the two auxiliary earth electrode locations are superimposed. The initially ascertained dissipation resistance value can be checked with inflection point S2 (see Figure 10.8.4:).

#### Notes Regarding Measurement in Difficult Terrain

In extremely unfavorable terrain (e.g. sandy soil after a lengthy period without rain), auxiliary earth electrode and probe resistance can be reduced to permissible values by watering the ground around the auxiliary earth electrode and the probe with soda water or salt water. If this does not suffice, several earth spikes can be parallel connected to the auxiliary earth electrode.

In mountainous terrain or in the case of very rocky subsoil where earth spikes cannot be driven into the ground, wire grates with a mesh size of 1 cm and a surface area of about 2 square meters can be used. These grates are laid flat onto the ground, are wetted with soda water or salt water and may also be weighted down with sacks full of moist earth.

Curve I (KI)		Cur	ve II (KII)	٦
m	W	m	W	1
5	0.9	10	0.8	
10	1.28	20	0.98	
15	1.62	40	1.60	
20	1.82	60	1.82	
25	1.99	80	2.00	
30	2.12	100	2.05	
40	2.36	120	2.13	
60	2.84	140	2.44	
80	3.68	160	2.80	
100	200	200	100	1.1

C1, S2 = inflection points C1 = curve I C1 = curve II



Figure 10.8.4: Earthing Resistance Measurement for a Large Scope Earthing System

#### 10.9 Earthing Resistance Measurement, Battery Operated – Selective (4-pole) with Current Clamp Sensor and PRO-RE Measuring Adapter as Accessory (only MPRO & MXTRA)

#### General



When measuring earthing resistance in systems with several parallel connected earth electrodes, total resistance of the earthing system is measured.

Two earth spikes (auxiliary earth electrode and probe) are set for this measurement. Measuring current is fed between the earth electrode and the auxiliary earth electrode and voltage drop is measured between the earth electrode and the probe.

The current clamp is positioned around the earth electrode to be measured, and thus only that portion of the measuring current which flows through the earth electrode is measured.

#### Connection



- Position the spikes for the probe and the auxiliary electrode at least 20, respectively 40 meters from the electrode (see figure above).
- Make sure that no excessively high contact resistances occur between the probe and the ground.
- Attach the PRO-RE adapter (Z501S) to the test plug.
- Connect the probes, the auxiliary electrode and the electrode via the 4 mm banana plug sockets at the **PRO-RE adapter**. In doing so, observe labeling on the banana plug sockets.
- Connect the Z3512A current clamp sensor to jacks 15 and 16 at the test instrument.
- Attach the current clamp sensor to the earth electrode.

#### Select Measuring Function



#### Select Operating Mode



The selected operating mode is displayed inversely: white battery icon against black background.

### Set Parameters at Tester

#### **D** Measuring range: 200 $\Omega$

#### 🔊 Note

After switching to selective measurement, the AUTO measuring range is activated automatically if a measuring range of greater than 200  $\Omega$  had been selected.

Connection type: selective

□ Current clamp sensor transformer ratio:

1:1 (1 V/A,) 1:10 (100 mV/A), 1:100 (10 mV/A)

 $\square$  Distance d (for measuring  $\rho_{\text{E}}$ ): irrelevant in this case

#### Set Parameters at Current Clamp Sensor

□ Current clamp sensor measuring range: see table below

#### Selecting a Measuring Range at the Current Clamp Sensor

Tester Z3512A Clamp

Transforma- tion Ratio Parameter	Switch	Measuring Range
1:1 1 V / A	1 A / x 1	1 A
1:10 100 mV / A	10 A / x 10	10 A
1:100 10 mV / A	100 A / x 100	100 A

#### Important Instructions for Use of the Current Clamp Sensor

- Use only the Z3512A current clamp sensor for this measurement.
- Use the clamp in the permanently connected state. The sensor may not be moved during measurement.
- The current clamp sensor may only be used at an adequate distance from **powerful extraneous fields**.
- Make sure that the current clamp sensor's connector cable is laid separate from the probe cables to the greatest possible extent.

#### Start Measurement





#### 10.10 Earthing Resistance Measurement, Battery Powered – Ground Loop Measurement (with current clamp sensor and transformer, plus PRO-RE/2 measuring adapter as accessory) (only MPRO & MXTRA)

#### 2-Clamp Measuring Method



In the case of earthing systems which consist of several earth electrodes (R1 ... Rx) which are connected to each other, earthing resistance of a single electrode (Rx) can be ascertained with the help of 2 current clamps without disconnecting Rx or using spikes.



This measuring method is especially well suited for buildings or systems for which probes and auxiliary earth electrodes cannot be used, or where it's impermissible to disconnect earth electrodes.

Furthermore, this "spike-free" measurement is performed as one of three measurements for lightning protection systems, in order to determine whether or not current can be dissipated.

#### Figure at right:

PRO-RE/2 measuring adapter as accessory for connecting the E-Clip 2 generator current clamp



#### Connection





- ▷ No probes or auxiliary earth electrodes are required.
- ⇒ The earth electrode is not disconnected.
- Attach the PR0-RE/2 adapter (Z502T) to the test plug.
- Connect the E-Clip 2 generator clamp (current clamp transformer) via the 4 mm safety plugs at the PRO-RE/2 adapter.
- Connect the Z3512A current clamp sensor to jacks 15 and 16 at the test instrument.

Attach the 2 clamps to an earth electrode (earth spike) at different heights with a clearance of at least 30 cm.

#### Select Measuring Function



#### Select Operating Mode



The selected operating mode is displayed inversely: white battery icon against black background.

#### Set Parameters at Tester

□ **Measuring range:** in this case always AUTO

#### 🐼 Note

After selecting to 2-clamp measurement, switching to the AUTO range takes place automatically. It is then no longer possible to change the range!

□ Connection type: 2-clamp

- □ Current clamp sensor transformer ratio:
- 1:1 (1 V/A), 1:10 (100 mV/A), 1:100 (10 mV/A)
- $\square$  Distance d (for measuring  $\rho_{\text{E}}$ ): irrelevant in this case

#### Set Parameters at Current Clamp Sensor

□ Current clamp sensor measuring range: see table below

#### Selecting a Measuring Range at the Current Clamp Sensor

Tester	Z3512A Clamp			
Transforma- tion Ratio Parameter	Switch	Measuring Range		
1:1 1 V / A	1 A/x 1	1 A		
1:10 100 mV / A	10 A / x 10	10 A		
1:100 10 mV / A	100 A / x 100	100 A		

#### Important Instructions for Use of the Current Clamp Sensor

- Use only the Z3512A current clamp sensor for this measurement.
- Use the clamp in the permanently connected state. The sensor may not be moved during measurement.
- The current clamp sensor may only be used at an adequate distance from **powerful extraneous fields**.
- Make sure that the connector cables from the two clamps are laid separate from each other to the greatest possible extent.

#### Start Measurement



10.11 Earthing Resistance Measurement, Battery Powered – Measurement of Soil Resistivity  $\rho_{F}$ (only MPRO & MXTRA)





Measurement of Soil Resistivity

The determination of soil resistivity is necessary for the planning of earthing systems. Reliable values need to be ascertained which take even the worst possible conditions into account (see "Geologic Evaluation" on page 43).

Soil resistivity is decisive with regard to the magnitude of an earth electrode's dissipation resistance. Soil resistivity can be measured with the PROFITEST MASTER using the method according to Wenner.

Four earth spikes of greatest possible length are driven into the ground in a straight line at distance d from one another, and are connected to the earth tester (see figure above).

The earth spikes usually have a length of 30 to 50 cm. Longer earth spikes can be used for soil which demonstrates poor conductivity (sandy soil etc.). The depth to which the earth spikes are driven into the ground may not exceed one twentieth of distance d.

#### 🐼 Note

Erroneous measurement may result in the event that piping, cables or other underground metal conduits run parallel to the measuring setup.

Soil resistivity is calculated as follows:

 $\rho_{E} = 2\pi \cdot d \cdot R$ 

Where:

- $\pi = 3.1416$
- d = distance in m between two earth spikes
- R = ascertained resistance value in  $\Omega$  (this value corresponds to R<sub>F</sub> as determined with the 4-wire method)





- ⊳ Position the spikes for the probe and the auxiliary electrode at equal distances (see figure above).
- $\Box$ Make sure that no excessively high contact resistances occur between the probe and the ground.
- $\Box$ Attach the PRO-RE adapter (Z501S) to the test plug.
- Connect the probes, the auxiliary electrode and the electrode  $\Box$ via the 4 mm banana plug sockets at the PRO-RE adapter. In doing so, observe labeling on the banana plug sockets.

#### Select Measuring Function



#### Select Operating Mode



The selected operating mode is displayed inversely: white battery icon against black background.

#### Set Parameters

- **Δ** Measuring range: AUTO, 50 kΩ, 20 kΩ, 2 kΩ, 200 Ω, 20 Ω
- **Connection type:**  $\rho_{F}$  (Rho)
- □ Transformer ratio: irrelevant in this case
- **Distance d for measurement of**  $\rho_{\rm F}$ : adjustable from 0.1 to 999 m

### Start Measurement



#### **Geologic Evaluation**

Except in extreme cases, the ground is measured down to a depth which is roughly equal to probe distance d.

This makes it possible to arrive at conclusions regarding the ground's stratification by varying probe distance. Layers which are highly conductive (water table), into which earth electrodes should be installed, can thus be discovered within a region which is otherwise poorly conducting.

Soil resistivity is subject to considerable fluctuation which may be due to various causes such as porosity, moisture penetration, concentration of dissolved salts in the ground water and climatic fluctuation.

Characteristic values for  $\rho_E$  relative to season (soil temperature and the soil's negative temperature coefficient) can be approximated quite closely by means of a sinusoidal curve.



Soil Resistivity  $\rho E$  Relative to Season Without the Effects of Precipitation (earth electrode depth < 1.5 m)

A number of typical soil resistivity values for various types of ground are summarized in the following table.

Type of Soil	Soil Resistivity $\rho_{E}$ [C	2m]
Marshy ground	8 60	
Arable soil, loamy and clayey soil, moist gravel	20 30	0
Moist sandy soil	200 60	0
Dry sandy soil, dry gravel	200 20	00
Rocky ground	300 80	00
Rock	10 <sup>4</sup> 10	10

Soil Resistivity  $\rho_E$  with Different Types of Soil

#### **Calculating Dissipation Resistance**

Formulas for calculating dissipation resistance for common types of earth electrodes are included in this table. These rules of thumb are entirely adequate for actual practice.

Number	Earth Electrode	Rule of Thumb	Subsidiary Variable
1	Earth strip (star type earth electrode)	$R_{A} = \frac{2 \cdot \rho_{E}}{I}$	_
2	Earth rod (buried earth electrode)	$R_A = \frac{\rho_E}{I}$	_
3	Ring earth electrode	$\mathbf{R}_{\mathbf{A}} = \frac{2 \cdot \mathbf{\rho}_{\mathbf{E}}}{3\mathbf{D}}$	<b>D</b> = $1,13 \cdot \sqrt{2}$
4	Mesh earth electrode	$\mathbf{R}_{\mathbf{A}} = \frac{2 \cdot \mathbf{\rho}_{\mathbf{E}}}{2\mathbf{D}}$	<b>D</b> = $1,13 \cdot \sqrt{2}$
5	Ground plate	$\mathbf{R}_{\mathbf{A}} = \frac{2 \cdot \mathbf{\rho}_{\mathbf{E}}}{4,5 \cdot \mathbf{a}}$	_
6	Hemispherical earth elec- trode	$R_{A} = \frac{\rho_{E}}{\pi \cdot D}$	$\mathbf{D} = 1,57 \cdot \sqrt[3]{\mathbf{J}}$

Formulas for Calculating Dissipation Resistance  $R_{\rm A}$  for Various Earth Electrodes

- $R_A$ = dissipation resistance ( $\Omega$ )
- $\rho_{\text{E}}$ = soil resistivity ( $\Omega$ m)
- I = Iength of the earth electrode (m)
- D = diameter of a ring earth electrode, diameter of the equivalent surface area of a mesh earth electrode or diameter of a hemispherical earth electrode (m)
- F = surface area (sq. meters) of the enclosed surface or a ring or mesh earth electrode
- a = Edge length (m) of a square ground plate; a is replaced with the following for rectangular plates:  $\sqrt{b \times c}$ , where b and c are the two sides of the rectangle.
- J = volume (cubic meters) of an individual foundation footing

#### 11 Measuring Insulation Resistance

# Breakdown current for Ramp Function



t

T

# Limit values for Breakdown Voltage



# Limit Values for Constant Test Voltage



# Test voltage

A test voltage which deviates from nominal voltage, and is usually lower, can be selected for measurements at sensitive components, as well as systems with voltage limiting devices.

# Voltage Type

The "U\_{INS}" rising test voltage function (ramp function) is used to detect weak points in the insulation, as well as to determine response voltage for voltage limiting components. After briefly pressing the ON/START key, test voltage is continuously increased until specified nominal voltage  $\mathsf{U}_{\mathsf{N}}$  is reached.  $\mathbf{U}$  is the voltage which is measured at the test probes during and after testing. This voltage drops to a value of less than 10 V after measurement (see section entitled "Discharging the Device Under Test").

Insulation measurement with rising test voltage is ended:

- As soon as specified maximum test voltage  $U_N$  is reached and the measured value is stable
- or
- As soon as specified maximum test voltage is reached, e.g. after sparkover occurs at breakdown voltage).

Specified maximum test voltage  $U_N$  or any occurring triggering or breakdown voltage is displayed for UINS.

The constant test voltage function offers two options:

After briefly pressing the ON/START key, specified test voltage UN is read out and insulation resistance RINS is measured. As soon as the measured value is stable (settling time may be several seconds in the case of high cable capacitance values), measurement is ended and the last measured values for RINS and UINS are displayed. U is the voltage which is measured at the test probes during and after testing. This voltage drops to a value of less than 10 V after measurement (see section entitled "Discharging the Device Under Test").

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# Note Note

If you use the test plug together with a plug insert, insulation resistance is only measured between the phase conductor terminal designated "L" and protective conductor terminal PE!

#### 🔊 Note

#### **Checking Measurement Cables Before Measurements**

Before performing insulation measurement, the test probes on the measurement cables should be short-circuited in order to assure that the instrument displays a value of less than 1 k $\Omega$ . In this way, incorrect connection can be avoided and broken measurement cables can be detected.

#### Set Parameters



Freely adjustable voltage (see section 5.7)

#### **Polarity Selection**



AUTO parameter (see section 5.8)



Insulation resistance can only be measured at voltage-



Attention!

free objects.

General

2 pole adapter or test

Select Measuring Function

RISO RINS

/!`

11.1

Connection

plug

- or
- As long as you press and hold the ON/START key, test voltage UN is applied and insulation resistance R<sub>INS</sub> is measured. Do not release the key until the measured value has settled in (settling time may be several seconds in the case of high cable capacitance values). Voltage U, which is measured during testing, corresponds to voltage UINS. After releasing the ON/ START key, measurement is ended and the last measured values for R<sub>INS</sub> and UINS are displayed. U drops to a value of less than 10 V after measurement (see section entitled "Discharging the Device Under Test").

#### Pole Selection Report Entry

The poles between which testing takes place can only be entered here for reporting purposes. The entry itself has no influence on the actual polarity of the test probes or pole selection.

#### □ Limits – Setting the Limit Value

The limit value for insulation resistance can be set as desired. If measurement values occur which are below this limit value, the red U<sub>L</sub>/R<sub>L</sub> LED lights up. A selection of limit values ranging from 0.5 to 10 M $\Omega$  is available. The limit value is displayed above the measured value.

#### Start Measurement - Rising Test Voltage (ramp function)

BAT 📉 ILIM. MEM 🛄 1.00mA 500V UINS Uм (750V >250\ н Press briefly: \_imits З 01/11 L1-PE -¤⊡"b> AUTO UINS |∆<sub>N</sub>(I

Quick polarity reversal if parameter is set to AUTO: 01/10 ... 10/10: L1-PE ... L1-L3

#### Note

If "semiautomatic polarity reversal" is selected (see section 5.8), the corresponding icon is displayed instead of the ramp.

# General Notes Regarding Insulation Measurements with Ramp Function

Insulation measurement with ramp function serves the following purposes:

- · Detect weak points in the test object's insulation
- Determine tripping voltage of voltage limiting components and test them for correct functioning These components may include, for example, varistors, overvoltage limiters (e.g. DEHNguard® from Dehn+Söhne) and spark gaps.

The test instrument uses continuously rising test voltage for this measuring function, up to the maximum selected voltage limit. The measuring procedure is started by pressing the START/STOPP key and runs automatically until one of the following events occurs:

- The selected voltage limit is reached
- The selected current limit is reached
- Sparkover occurs (spark gaps)

Differentiation is made amongst the following three procedures for insulation measurement with ramp function:

#### Testing of overvoltage limiters or varistors and determining their tripping voltage:

- Select maximum voltage such that the anticipated breakdown voltage of the device under test is roughly one third of this value (observe manufacturer's data sheet if applicable).
- Select current limit value in accordance with actual requirements or the manufacturer's data sheet (characteristic curve of the device under test).

#### Determining tripping voltage for spark gaps:

- Select maximum voltage such that the anticipated breakdown voltage of the device under test is roughly one third of this value (observe manufacturer's data sheet if applicable).
- Select the current limit value in accordance with actual requirements within a range of 5 to 10 µA (response characteristics are too unstable with larger current limit values, which may result in faulty measurement results).

#### Detecting weak points in the insulation:

- Select maximum voltage such that it does not exceed the test object's permissible insulation voltage; it can be assumed that an insulation fault will occur even with a significantly lower voltage if an accordingly lower maximum voltage value is selected (nevertheless at least greater than anticipated breakdown voltage) – the ramp is less steep as a result (increased measuring accuracy).
- Select the limit current value in accordance with actual requirements within a range of 5 to 10  $\mu A$  (see also settings for spark gaps).

#### Start Measurement – Constant Test Voltage



Quick polarity reversal if parameter is set to AUT0: 01/10 ... 10/10: L1-PE ... L1-L3

#### Note 🐼

The instrument's batteries are rapidly depleted during the insulation resistance measurement. When using the "constant test voltage" function, only press and hold the Start  $\mathbf{\nabla}$  key until the display has become stable (if long-term measurement is required).

#### Special Condition for Insulation Resistance Measurement

#### Attention!

Insulation resistance can only be measured at voltage-free objects.

If measured insulation resistance is less than the selected limit value, the  $U_{\rm L}/R_{\rm L}$  LED lights up.

If an interference voltage of  $\geq 25$  V is present within the system, insulation resistance is not measured. The MAINS/NETZ LED lights up and the "interference voltage" pop-up message appears. All conductors (L1, L2, L3 and N) must be tested against PE!



#### Attention!

Do not touch the instrument's terminal contacts during insulation resistance measurements!

If nothing has been connected to the terminal contacts, or if a resistive load component has been connected for measurement, your body would be exposed to a current of approx. 1 mA at a voltage of 1000 V.

The noticeable shock may lead to injury (e.g. resulting from a startled reaction etc.).

#### **Discharging the Device Under Test**

#### Attention!

If measurement is performed at a capacitive object such as a long cable, it becomes charged with up to approx. 1000 V!

#### Touching such objects is life endangering!

When an insulation resistance measurement has been performed on a capacitive object it is automatically discharged by the instrument after measurement has been completed. Contact to the device under test must be maintained to this end. The falling voltage value can be observed at the U display.

#### Do not disconnect the DUT until less than 10 V is displayed for U!

#### **Evaluation of Measured Values**

Instrument measuring error must be taken into consideration in order to assure that the limit values set forth in DIN VDE regulations are not fallen short of. The required minimum display values for insulation resistance can be determined with the help of Table 3 on page 88. These values take maximum device error into consideration (under nominal conditions of use). Intermediate values can be interpolated.

#### 11.2 Special Case: Earth Leakage Resistance (R<sub>EISO</sub>)

This measurement is performed in order to determine electrostatic discharge capacity for floor coverings in accordance with EN 1081.

#### **Select Measuring Function**



#### Set Parameters





Freely adjustable voltage (see section 5.7)



- ➡ Rub the floor covering at the point at which measurement is to be performed with a dry cloth.
- Place the 1081 floor probe onto the point of measurement and load it with a weight of at least 300 N (30 kg).
- Establish a conductive connection between the measuring electrode and the Test Probe and connect the measuring adapter (2-pole) to an earth contact, e.g. the earthing contact at a mains outlet or a central heating radiator (prerequisite: reliable ground connection).



The limit value for earth leakage resistance from the relevant regulations applies.

# 12 Measuring Low-Value Resistance up to 200 Ohm (protective conductor and equipotential bonding conductor)

According to the regulations, the measurement of low-value resistance at protective conductors, earth conductors or bonding conductors must be performed with (automatic) polarity reversal of the test voltage, or with current flow in one (+ pole to PE) and then the other direction (– pole to PE).

#### Attention!

Low-value resistance must only be measured at voltage-free objects.

#### **Select Measuring Function**



#### Connection

Via 2-pole adapter only!





## Set Parameters



#### □ Roffset on/off

#### – Compensation for Extension Cables with up to 10 $\Omega$

If measurement cables or extension cables are used, their resistance can be deducted automatically from the measurement results. Proceed as follows:

- $\Rightarrow$  Switch **ROFFSET** from OFF to ON. "**ROFFSET** = 0.00  $\Omega$ " appears in the footer.
- Select a polarity option or automatic polarity reversal.
- Short-circuit the end of the measurement extension cable with the second test probe at the instrument.
- Start measurement of offset resistance with I<sub>AN</sub>.

An intermittent acoustic signal sounds first, which is then accompanied by a blinking warning to prevent an offset value which has already been saved from being unintentionally deleted.



Start the offset measurement by pressing the release key again or abort measurement by pressing the key **20N/START** (here = ESC).

#### Note 🖉

If the offset measurement is stopped by an error pop-up (Roffset > 10  $\Omega$  or difference between RLO+ and RLO– greater than 10%), the offset value that has last been measured is retained. Inadvertent deletion of an offset value once established is thus almost ruled out! The respectively smaller value is otherwise stored to memory as an offset value. The maximum offset value is 10.0  $\Omega$ . Negative resistances may result due to the offset value.

#### Measuring ROFFSET



The **Roffset** x.xx  $\Omega$  message now appears in the footer at the display, where x.xx may take a value between 0.00 and 10.0  $\Omega$ . This value is subtracted from the actual measuring results for all subsequent R<sub>LO</sub> measurements, if the **Roffset ON/OFF** key has been set to **ON**.

Roffset must be determined anew in the following cases:

- After switching to a different polarity option
- After switching from ON to OFF and back again

You can deliberately delete the offset value by switching ROFF-SET from OFF to ON.

#### 🐼 Note

Only use this function when performing measurements with extension cables. When different extension cables are used, the above

described procedure must always be repeated.

#### Type / Polarity

The direction in which current flows can be selected here.

#### □ Limits – Setting the Limit Value

The limit value for resistance can be set as desired. If measurement values which exceed this limit occur, the red U<sub>L</sub>/R<sub>L</sub> LED lights up. Limit values can be selected between 0.10  $\Omega$  and 10.0  $\Omega$  (editable). The limit value is displayed above the measured value.

#### Start Measurement



Press and hold for long-term measurement

# Attention!

The test probes should always be in contact with the DUT before pressing the Start  $\mathbf{\nabla}$  key.

If the object is energized, measurement is disabled as soon as it is contacted with the test probes.

If the Start  $\mathbf{\nabla}$  key is pressed first and the test object is contacted with the test probes afterwards, the fuse blows. Which of the two fuses has blown is indicated in the pop-up window with the error message by means of an arrow.

In the case of single-pole measurement, the respective value is saved to the database as RLO.

Polarity Selection	Display	Condition
+ pole to PE	RLO+	None
– pole to PE	<b>R</b> L0-	None
	RLO	lf Δ <b>RL0</b> ≤ 10%
± pole to PE	RLO+ RLO-	If ∆ <b>RL0</b> > 10%

#### **Automatic Polarity Reversal**

After the measuring sequence has been started, the instrument performs measurement with automatic polarity reversal, first with current flow in one direction, and then in the other. In the case of long-term measurement (press and hold START key), polarity is switched once per second.

If the difference between RLO+ and RLO– is greater than 10% with automatic polarity reversal, RLO+ and RLO– values are displayed instead of RLO. The respectively larger value, RLO+ or RLO–, appears at the top and is saved to the database as the RLO value.

#### **Evaluating Measurement Results**

Differing results for measurements in both directions indicate voltage at the DUT (e.g. thermovoltages or unit voltages).

Measurement results can be distorted by parallel connected impedances at load current circuits and by equalizing current, especially in systems which make use of "overcurrent protection devices" (previous neutralization) without an isolated protective conductor. Resistances which change during measurement (e.g. inductance), or a defective contact, can also cause distorted measurements (double display).

In order to assure unambiguous measurement results, causes of error must be located and eliminated.

In order to find the cause of the measuring error, measure resistance in both current flow directions.

The instrument's batteries are exposed to excessive stress during insulation resistance measurement. For measurement with current flow in one direction, only press and hold the **START**  $\checkmark$  key as long as is necessary for the measurement.

## 🐼 Note

Measuring Low-Value Resistance

Measurement cable and 2-pole measuring adapter resistance is compensated for automatically thanks to the four conductor method and thus do not effect measurement results. However, if an extension cable is used its resistance must be measured and deducted from the measurement results.

Resistances which do not demonstrate a stable value until after a "settling in period" should not be measured with automatic polarity reversal, but rather one after the other with positive and negative polarity.

Examples of resistances whose values may change during measurement include:

- Incandescent lamp resistance, whose values change due to warming caused by test current
- Resistances with a great conductive component
- Contact resistance

#### **Evaluation of Measured Values**

See Table 4 on page 88.

#### Calculation of Cable Lengths for Common Copper Conductors

If the HELP key is activated after performing resistance measurement, the cable lengths corresponding to common conductor cross sections are displayed.



RLo: 0.16 Ω					
4	1		+¦1∅		
( <u>iaaaaaaa</u>	<u>~c</u>	U	≊: <u>*</u> : †		
ø	1	ø	1		
[mm²]	Em3	[[mm2]	[m]		
0.14:	1	2.5:	20		
0.25:	2	4.0:	32		
0.50:	4	6.0:	48		
0.75:	6	10.0:	80		
1.00:	8	16.0:	127		
1.50:	12	25.0:	199		

If results vary for the two different current flow directions, cable length is not displayed. In this case, capacitive or inductive components are apparently present which would distort the calculation.

This table only applies to cables made with commercially available copper conductors and cannot be used for other materials (e.g. aluminum)!

#### 12.2 Protective Conductor Resistance Measurement with Ramp Curve – Measurements on PRCDs with Current-monitored Protective Conductor Using PROFITEST PRCD Test Adapter as Accessory

#### Application

In certain PRCD types, the protective conductor current is monitored. Direct application or disconnection of the test current of 200 mA, which is required for protective conductor resistance measurements, results in tripping of the PRCD and, consequently, a cut-off of the protective conductor connection. Protective conductor measurement is no longer possible in this case.

A special ramp curve for the application or disconnection of the test current in combination with the **PROFITEST PRCD** test adapter allows for performing protective conductor resistance measurements without PRCDs being tripped.

#### **Timed Sequence of the Ramp Function**

Due to the physical properties of the PRCD, the **measuring cycles** of this ramp function lie within the range of several seconds.

Moreover, while the polarity of the test current is being reversed, an additional **waiting period** during polarity reversal becomes necessary.

This waiting period has been included in the test sequence in operating mode "automatic polarity reversal" **Prol**--\_\_\_\_.

If you change the polarity direction manually, e.g. from "+pole with ramp"

required waiting period and simultane-



ously shows the respective symbol, see figure on the right.



Visualization of the measuring and waiting phases during protective conductor resistance measurements on PRCDs with the PROFITEST MXTRA

## Tripping of a PRCD due to faulty contact

During measurement, safe contact between the test probes of the 2-pole adapter and the DUT or the sockets of the **PROFITEST PRCD** test adapter is to be ensured. Interruptions may lead to heavy fluctuations in the test current which may cause the PRCD to trip in the worst case.

In this event, the tripping of the PRCD is automatically recognized by the test instrument as well and an error message is generated, see figure on the right. In this case as well, the test instrument automatically takes into account the required waiting period before re-



enabling the PRCD and allowing any new measurements.

#### Connection

Please consult the operating instructions of the **PROFITEST PRCD** adapter, particularly chapter 4.1. There you will also find information on the connection terminals for offset measurements and protective conductor resistance measurements.

#### **Selecting Polarity Parameter**

Select the requested polarity parameter with ramp.



#### **Measuring ROFFSET**

Perform an offset measurement as described on page 47, to assure that the test adapter's connector contacts are not included in the measurement results.

#### 🔊 Note

The offset only remains saved to memory until you change the polarity parameter. If you perform the measurement with manual polarity reversal (+pole or –pole), you have to repeat the offset measurement before each measurement with another polarity.

#### **Measuring Protective Conductor Resistance**

- Check whether the PRCD is activated. If this is not the case, activate it.
- Perform the protective conductor measurement as described above in section 12.1. Start the test sequence by briefly pressing key **ON/START**. By pressing and holding key **ON/START** you can extend the preset duration of the measuring phase.

#### Start measurement



During the magnetization phase (rising curve) and the subsequent measuring phase (constant current) the symbol on the right is shown.



If you abort the measurement during the rise phase, no measuring result can be issued and displayed.

After the measurement, the demagnetization phase (declining curve) and a subsequent waiting period is signalled with the inverse symbol shown on the right. During this period, no new measurements are possible.



Only when the symbol on the right is shown, can the measurement result be read and measurements started with the same or another polarity.



#### 13 Measurement with Accessory Sensors

#### 13.1 **Current Measurement with Current Clamp Sensor**

Bias, leakage and circulating current to 1 A, as well as leakage current to 1000 A can be measured with the help of special current clamp sensors, which are connected to sockets 15 and 16.

#### ∕!∖ Attention!

# Danger: High-Voltage!

Use only current clamp sensors which are specifically offered as accessories by GMC-I Messtechnik GmbH. Other current clamp sensors might not be terminated with an output load at the secondary side. Dangerously high voltage may endanger the user and the device in such cases.

#### Attention! ∕!∖

#### Maximum input voltage at the test instrument!

Do not measure any currents which are greater than specified for the measuring range of the respective clamp.

Input voltage for clamp connector sockets 15 and 16 at the test instrument may not exceed 1 V!

#### ∕!∖ Attention!

Be sure to read and adhere to the operating instructions for current clamp sensors and the safety precautions included therein, especially those regarding the approved measuring category.

# Select Measuring Function



# Selecting a Measuring Range at the Current Clamp Sensor

Tester		Tester			
Transforma- tion Ratio Parameter	Switch WZ12C	Switch Z3512A	Measuring Measuring Range Range WZ12C Z3512A		Measuring Range
1:1 1 V / A	1 mV / mA	x 1000 [mV/ A]	1 mA <b>15 A</b>	0 <b>1 A</b>	5 999 mA
1:10 100 mV / A	_	x 100 [mV/A]		0 <b>10 A</b>	0.05 10 A
1:100 10 mV / A	_	x 10 [mV/A]	_	0 <b>100 A</b>	0.5 100 A
1:1000 1 mV / A	1 mV / A	x 1 [mV/A]	1 A <b>150 A</b>	0 <b>1000 A</b>	5 150 A/ 999 A

Tester	Cla	Tester	
Transforma- tion Ratio Parameter	Switch METRAFLEX P300	Measuring Range METRAFLEX P300	Measuring Range
1:1 1 V / A	3 A (1 V/A)	3 A	5 999 mA
1:10 100 mV / A	30 A (100 mV/A)	30 A	0.05 10 A
1:100 10 mV / A	300 A (10 mV/A)	300 A	0.5 100 A

# Set Parameters

The transformation ratio parameter must be correspondingly set at the test instrument depending upon the respectively selected measuring range at the current clamp sensor.





Specifying limit values results in automatic evaluation at the end of the measurement.

# Connection



# 14 Special Functions – EXTRA Switch Position

Select EXTRA Switch Position

**EXTRA** 

**Overview of Special Functions** 

Softkey	Meaning / Spe- cial Function	Mbase+	MTECH+	Mpro	Mxtra	SECULIFE IP	Sec- tion / Page
<b>en</b> 20	Voltage drop measurement ∆U function	1	1	1	1	1	sec- tion 14.1 page 52
, <b>₽</b> *Zst	Standing sur- face insulation impedance Z <sub>ST</sub> function	1	1	1	1	1	sec- tion 14.2 page 53
E KMF	Meter start-up test kWh function	1	1	1	1		sec- tion 14.3 page 54
ᡰ®⊸⊮	Leakage Cur- rent Measure- ment I <sub>L</sub> function	_	_	_	1	1	sec- tion 14.4 page 55
С	Check insula- tion monitoring device IMD function	_			1	1	sec- tion 14.5 page 56
<b>ਜ਼ਾ</b> 10res	Residual volt- age test Ures function	_	_	_	1	_	sec- tion 14.6 page 58
\$:ta+ ≤	Intelligent ramp ta + I∆ function	_	_	_	1	_	sec- tion 14.7 page 59
RCM <b>#</b>	Residual cur- rent monitor (RCM) RCM function	_	_	_	1	_	sec- tion 14.8 page 60
<u>∎⊸<del>a</del>≂</u> e	Testing the op- erating states of electric vehi- cles at charging stations per IEC 61851		1	_	1		sec- tion 14.9 page 61
PRCD	Report genera- tion of fault simulations on PRCDs with PROFITEST PRCD adapter		_	_	1		sec- tion 14.10 page 62

#### **Selecting Special Functions**

The list of special functions is accessed by pressing the uppermost softkey. Select the desired function with the requested icon.





# 14.1 Voltage Drop Measurement (at $Z_{LN}$ ) – $\Delta U$ Function

# Significance and Display of ${\bigtriangleup}U$ (per DIN VDE 100, part 600)

Voltage drop from the intersection of the distribution network and the consumer system to the point of connection of an electrical power consumer (electrical outlet or device connector terminals) should not exceed 4% of nominal line voltage. Calculating voltage drop (without offset):  $\Delta U = Z_{L-N} \bullet$  nominal current of the fuse

Calculating voltage drop (with offset):  $\Delta U = (Z_{L-N} - Z_{OFFSET}) \bullet nominal current of the fuse$ 

 $\Delta U$  in % = 100 •  $\Delta U / U_{L-N}$ 

See also section 9 regarding measurement procedure and connection.

# **Connection and Test Set-Up**







# **Setting Limit Values**



- TAB Limit value per German technical connection conditions for connection to low-voltage mains between the distribution network and the measuring device
- DIN Limit value per DIN 18015-1:  $\Delta U < 3\%$  between the measuring device and the consuming device
- VDE Limit value per DIN VDE 0100-520:  $\Delta U < 4\%$  between the distribution network and the consuming device (adjustable up to 10% in this case)
- NL Limit value per NIV:  $\Delta U < 5\%$

# Measurement without OFFSET

Proceed as follows:

Switch **OFFSET** from ON to OFF.



# Determine OFFSET (as %)

Proceed as follows:

- Switch **0FFSET** from OFF to ON. "∆**U**0FFSET = 0.00%" is displayed.
- Connect the test probe to the point of common coupling (measuring device / meter).

 $\Rightarrow$  Start measurement of offset with I $\Delta_N$ .

An intermittent acoustic signal sounds first, which is then accompanied by a blinking warning to prevent an offset value which has already been saved from being unintentionally deleted.

Start the offset measurement by pressing the release key again or abort measurement by pressing the key ▼ 0N/START (here = ESC).





 $\Delta \text{UofFSET}$  x.xx % is indicated, where x.xx may take a value between 0.00 and 99.9 %.

An error message appears in a pop-up window in the event that  $Z>10\ \Omega.$ 

## Start Measurement with OFFSET



# 14.2 Measuring the Impedance of Insulating Floors and Walls (standing surface insulation impedance) – Z<sub>ST</sub> Function

#### Start Measurement

#### **Measuring Method**

The instrument measures the impedance between a weighted metal plate and earth. Line voltage available at the measuring site is used as an alternating voltage source. The  $Z_{ST}$  equivalent circuit is considered a parallel circuit.

#### **Connection and Test Set-Up**









**Note:** Use the measuring set-up described in section 11.2 (triangular probe) or the one outlined below:

- Cover the floor or the wall at unfavorable locations, e.g. at joints or abutments, with a damp cloth measuring approx. 270 x 270 mm.
- Place the 1081 Probe on top of the damp cloth and load the probe with a weight of 750 N (75 kg, i.e. one person) for floors, or 250 N (25 kg) for walls, e.g. press against the wall with one hand which is insulated with a glove.
- Establish a conductive connection to the 1081 Probe, and connect it to the probe connector socket at the instrument.
- $\Rightarrow$  Connect the instrument to a mains outlet with the test plug.

## Attention!

<u>/</u>!\

Do **not** touch the metal plate or the damp cloth with your bare hands.

No more than 50% line voltage may be applied to these parts! Current with a value of up to 3.5 mA may flow! The measured value would be distorted as well.



## **Evaluate Measured Value**

The measured value has to be evaluated after measurement has been completed:



Resistance values must be measured at several points in order to provide for adequate evaluation. Measured resistance may not be less than 50 k $\Omega$  at any given point. If the measured value is greater than 30 M $\Omega$ ,  $Z_{ST} > 30.0$  M $\Omega$  always appears at the display panel.

In the event that "NOT OK" is selected, an error is indicated by the **UL/RL LED** which lights up red.

See also Table 5 on page 89 with regard to evaluating measured values.

The measured value cannot be saved to memory and included in the test report until it has been evaluated.

## Save Measured Value



#### 14.3 Testing Meter Start-Up with Earthing Contact Plug – kWh Function (not SECULIFE IP)

Save Measured Value

Energy consumption meters can be tested for correct start-up with this function.





The meter is tested with the help of an internal load resistor and a test current of approximately 250 mA. After pressing the start key, test power is displayed and the meter can be tested for proper start-up within a period of 5 seconds. The "RUN" pictograph is displayed.

TN systems: All 3 phase conductors must be tested against N, one after the other.

In other types of systems, all phase conductors (active conductors) must be tested against one another.

#### 🐼 Note

If minimum power is not reached, the test is either not started or aborted.

## **Evaluate Measured Value**

The measured value has to be evaluated after measurement has been completed:



In the event that "NOT OK" is selected, an error is indicated by the  $\ensuremath{\text{UL/RL LED}}$  which lights up red.

The measured value cannot be saved to memory and included in the test report until it has been evaluated.

67 ₩ [
l
UN 230U fn 50.0Hz +

### **Special Case**

Start-up of energy consumption meters which are connected between L and L or L and N can be tested with this function.



## 🐼 Note

If an earthing contact outlet is not available, you can use the 2-pole adapter. N must be contacted with the PE test probe (L2), and then measurement must be started. If PE is contacted with the PE test probe (L2) during the meter start-up test, approximately 250 mA flow through the protective conductor and any upstream RCD is tripped.

# 14.4 Leakage Current Measurement with PRO-AB Leakage Current Adapter as Accessory $-I_{\rm L}$ Function (PROFITEST MXTRA & SECULIFE IP only)

#### Applications

Measurement of contact voltage in accordance with DIN VDE 0107, part 10, as well as continuous leakage and patient auxiliary current per IEC 62353 (VDE 0750, part 1) / IEC 601-1 / EN 60 601-1:2006 (Medical electrical equipment – General requirements for basic safety), is possible using the PRO-AB PRO-AB leakage current measuring adapter as an accessory with the **PROFITEST MXTRA** test instrument.

As specified in the standards listed above, current values of up to 10 mA may be measured with this measuring adapter. In order to be able to fully cover this measuring range using the measurement input provided on the test instrument (2-pole current clamp input), the measuring instrument is equipped with range switching between transformation ratios of 10:1 and 1:1. In the 10:1 range, voltage dividing takes place at the same ratio.

#### **Connection and Test Set-Up**

In order to perform the leakage current measurement, the adapter's measurement outputs must be plugged into the measurement inputs at the left-hand side of the **PROFITEST MXTRA** (2-pole current clamp input and probe input).

Either of the leakage current measuring adapter's inputs is connected to reference earth (e.g. safe earth electrode / equipotential bonding) via a measurement cable. The metallic housing (accessible part) of the device under test is contacted with a test probe or alligator clip which is connected to the other input by means of a second measurement cable.



## Testing the PRO-AB Adapter

The adapter should be tested before use and at regular intervals (see adapter operating instructions).





# **Measuring Sequence**

Refer to the operating instructions for the PRO-AB leakage current measuring adapter regarding performance of the measurement.



# Attention!

The test plug should be located in the storage slot during leakage current measurement. Under no circumstances may the test plug be connected with any system components, including PE / ground potential (measured values might otherwise be distorted).

The measurement can be started or stopped by pressing the "START" key. Leakage current measurement is a long-term measurement, i.e. it continues until it is stopped by the user. The momentary measured value is display continuously during measurement.

# 🐼 Note

The self-test must be deactivated in the menu (set "TEST ON/OFF" function key to "OFF") in order to perform a measurement.

Always start with the large measuring range (10:1), unless there's no doubt that small measured values can be expected, in which case the small measuring range can be used (1:1). The measuring range must be selected at the measuring adapter, as well as in the menu using the corresponding function key (RANGE). It must be assured that the range settings at the adapter and at the test instrument are always identical, in order to prevent any distortion of measurement results.

Depending on the magnitude of the measured values, the range setting can, or must (in the case of overranging), be manually corrected at the measuring adapter and the test instrument.

Individual limit values can be adjusted after pressing the "Limits" function key. Exceeded limit values are indicated by the red limit value LED at the test instrument.

#### 14.5 Testing of Insulation Monitoring Devices – IMD Function (PROFITEST MXTRA & SECULIFE IP only)

#### Applications

Insulation monitoring devices (IMDs) or earth fault detection systems (EDSs) are used in IT systems in order to monitor adherence to a minimum insulation resistance value, as specified by DIN VDE 0100-410.

They're used in power supplies for which a single-pole earth fault may not result in failure of the power supply, for example in operating rooms or photovoltaic systems.

Insulation monitors can be tested with the help of this special function. After pressing the **ON/START** button, an adjustable insulation resistance is activated between one of the two phases of the IT system to be monitored and ground to this end. This resistance can be changed in the "MAN±" manual sequence mode with the help of the "+" or "–" softkey, or varied automatically from R<sub>max</sub> to R<sub>min</sub> in the "AUTO" operating mode. Testing is ended by once again pressing the **ON/START** key.

Time during which the momentary resistance value prevails since changing the value at the system is displayed. The IMD's display and response characteristics can be subsequently evaluated and documented with the help of the "OK" or "NOT OK" softkey.

IMD

Rmin

UL1L2 --- Ü

Ulipe ---V Ilpe Ulipe ---V

f

RL-PE

ta

οĭο

IMD

Application of an adjustable

resistance between external

Start/Stop: press START

conductor and earth in the IT mains

BAT 🔊

MEM 🛄

3

ľΜĤ

--Hz

🕮 імр

MAN ±

АОТО 🕨

RSTART

50.0kΩ

L1-PE

± 10.0%

#### Connection L - N



## Set Parameters – MAN/AUTO (1)

Switch between manual measuring sequence **MAN** and automatic measuring sequence **AUTO** 

#### Change conductor relationship and limit values (2)

Quick switching between L1-PE and L2-PE (also during measurement) with the  $I_{\Delta N}$  key



## - Changing the initial resistance (3)

You can select the initial resistance here to start each series of measurements for manual measuring sequences. The GOME setting (default settings) sets the initial value to a resistance value of  $50.0 \text{ k}\Omega$ .



Set Limit Values for  $R_{\text{L-PE}}$  as %



Limit values are calculated and displayed as a percentage of the momentarily displayed  ${\rm R}_{\rm L-PE}$  value.

#### Manual Measuring Sequence



The measurement and the stopwatch (see arrow) are started with the "START" key.

The stopwatch is restarted each time the resistance value is changed and whenever the energized phase conductor is switched (L1/L2).

During measurement, the conductor relationship (L1-PE or L2-PE) can be changed with the  $I_{\Delta N}$  key or the resistance value can be adjusted with the + and – keys, without interrupting the measurement. The stopwatch is reset in both cases.



Increasing + or Decreasing – the Resistance Value (The setting values themselves are fixed!)

The bar graph display provides you with quick orientation. The numeric combination which appears below it indicate the momentary step from as many as 65 steps (in this case step 17 of 65).

#### Automatic Measuring Sequence

In the case of the automatic measuring sequence, the sequence runs through all resistance values from the maximum to the minimum value (Rmax (2,51 M $\Omega$ )) to Rmin (20 k $\Omega$ )) in 65 steps, and dwell time for each step is 2 seconds.

#### GMC-I Messtechnik GmbH

#### Evaluation

In order to evaluate the measurement, it must be stopped. This applies to manual as well as automatic measurement. Press the "START" or "ESC" key to this end. The stopwatch is stopped and the evaluation window appears.



Press the "NOT OK", "START" or "ESC" key in order to reject the measurement.

	шир
RL-PE 245.0kΩ <55.0kΩ 5 0.0 kΩ	MAN ± AUTO N
ta 2.10 s	Rstart 50.0kΩ
Rmin 18/55 Rmax ULIPE 234V ILPE 4.64mA UL2PE 0.0V ULILZ 234V f 56	L1-PE ± 10.0%

#### **Retrieving Saved Measured Values**

The measured value cannot be saved to memory and included in the test report until it has been evaluated (see also section 16.4).





With the help of the key shown at the right (MW: measured value / PA: parameter), the setting parameters can be displayed for this measurement.



#### 14.6 Residual Voltage Test – Ures Function (PROFITEST MXTRA only)

#### Applications

The EN 60204 standard specifies that after switching supply power off, residual voltage must drop to a value of 60 V or less within 5 seconds at all accessible, active components of a machine to which a voltage of greater that 60 V is applied during operation.

With the **PROFITEST MXTRA**, testing for the absence of voltage is performed as follows by means of a voltage measurement which involves measuring discharge time tu:

In the case of voltage dips of greater than 5% of momentary line voltage (within 0.7 seconds), the stopwatch is started and momentary undervoltage is displayed as Ures after 5 seconds, and indicated by the red UL/RL LED.

The function is ended after 30 seconds, after which Ures and tu data can be deleted and the function can thus be restarted by pressing the ESC key.

#### Connection



In the event of a drastic and sudden shortfall of the Ures value, the value and the time frame are acquired and displayed in the respective LCD lines. Ures and ty.

## Setting Limit Values



#### Measuring Sequence – Long-Term Measurement



#### Note Note

reasons.

continuous measure-

voltage testing is trig-

If, for example, conductors are exposed when a machine is switched off - e.g. if plug connectors are disengaged which are not protected against direct contact, maximum allowable discharge time is 1 second!

#### 14.7 Intelligent Ramp – ta+I∆ Function (PROFITEST MXTRA only)

#### Start Contact Voltage Measurement

#### 14.7.1 Applications

The advantage of this measuring function in contrast to individual measurement of  $I_{AN}$  and  $t_A$  is the simultaneous measurement of breaking time and breaking current by means of a test current which is increased in steps, during which the RCD is tripped only once.

The intelligent ramp is subdivided into time segments of 300 ms each between the initial current value (35%  $\rm I_{\Delta N})$ and the final current value (130%  $I_{\Delta N}$ ). This results in a gradation for which each step corresponds to a constant test current which is applied for no longer than 300 ms, assuming that tripping does not occur.

 $ta_{I_{\Delta}} > ta_{I_{\Delta N}}$  (100%) ta [ms] Ŧ 300ms Ic [mA] 5Z 35% IΔN IAN: 10,30,100,300,500 & 🗗 [mA]



Start Tripping Test



PE

>0ms

>15.0mA <30.0mA

< 3

fn 50.0Hz

ſī

BAT 💽

MEM 🛄

<50V

<300ms

mΗ

S

Ω

#:ta+l≥

30mA

RCD

TYP A

Limits

The measurement sequence can be broken off prematurely at any time by pressing the ON/START key.

#### **Measurement Results**

#### Set Parameters

HELP .

Connection



Limits t {1/1 } <25V Contact voltage: UL: <50V UL: ta: <300ms UL: <50V ŧ < 25 V, < 50 V, < 65 V UL: (65V ta: >0ms IA:>15.0mA Ľ. I⇔:≺30.0mA







#### 14.8 **Testing Residual Current Monitors** - RCM Function (PROFITEST MXTRA only)

#### General

Residual current monitors (RCMs) monitor residual current in electrical systems and display it continuously. As is also the case with residual current devices, external switching devices can be controlled in order to shut down supply power in the event that a specified residual current value is exceeded.

스l:10mA...10A

Alarm-Level

Con

Prealarm-Level

R=

யா

Alarm off

ŀ

t<sub>on</sub>1,2 :0....10 s

toff :0...100 S

Reload: 0...100

Hysterese

toff.

Alarm on

However, the advantage of an RCM is that the user is informed of fault current within the system before shutdown takes place.

As opposed to individual measurement of  $I_{\Delta N}$  and t<sub>A</sub>, measurement results must be evaluated manually in this case.

If an RCM is used in combination with an external switching device, the combination must be tested as if it were an RCD.

Connection



# Set Parameters for I<sub>F</sub>∠







Non-Tripping Test with 1/2 x  $I_{\Lambda N}$  and 10 s

Measure Contact Voltage



After 10 seconds have passed, no fault current may be signalled. The measurement must be evaluated afterwards. In the event that "NOT OK" is selected (in case of false alarm), an error is indicated by the UL/RL LED which lights up red.

The measured value cannot be saved to memory and included in the test report until it has been evaluated.

## Tripping Test with 1 x $I_{\Lambda N}$ Measurement of Signal Response Time (stopwatch function)

with the Residual Current Generated by the Test Instrument



In order to document the tripping time, the measurement must be stopped manually with the **ON/START** or  $I_{\Delta N}$  key immediately after the fault current has been signalled.

In the event that "NOT OK" is selected, an error is indicated by the UL/RL LED which lights up red.

The measured value cannot be saved to memory and included in the test report until it has been evaluated.

#### 14.9 Testing the Operating States of Electric Vehicles at Charging Stations per IEC 61851 (MTECH+ & MXTRA only)

A charging station is an equipment designed for the charging of electric vehicles per IEC 61851 which essentially consists of a plug connector, a cable protection, a residual current device (RCD), as well as a circuit breaker and a security communication system (PWM). Depending on the place of installation and application, further functional features such as mains connection and meter may be included.

#### Adapter selection (test box)



# Simulation of operating states per IEC 61851 with the MENNEKES test box

(Status A - E)

The MENNEKES test box only serves the purpose of simulating different operating states of an electric vehicle fictitiously connected with a charging station. The settings for the simulated operating states are indicated in the operating instructions for the test box.

The simulated operating states can be stored in the **MTECH**+ or **MXTRA** as visual inspection and documented in the ETC software. The operating state (status) to be tested is selected with the **SECLECT STATUS** key at the **MTECH**+ or **MXTRA** test instrument.

# Status A - Charging conductor only connected with charging point

- CP signal is switched on,
- voltage between PE and CP is 12 V.



# Status ${\rm B}-{\rm Charging}\ {\rm conductor}\ {\rm connected}\ {\rm with}\ {\rm charging}\ {\rm point}\ {\rm and}\ {\rm vehicle}$

- the charging conductor is locked at the charging point and in the vehicle,
- vehicle not yet ready for charging,
- voltage between PE and CP is +9 V / -12 V.



## Status C - Non-gassing vehicle identified

- Readiness for charging on the vehicle/power side is activated,
- Voltage between PE and CP is +6 V / -12 V.



# Status D – Gassing vehicle identified

- Readiness for charging on the vehicle/power side is activated,
- Voltage between PE and CP is +3 V / -12 V.



## Status E – Conductor is damaged

- Short circuit between PE and CP,
- Charging conductor is unlocked at the charging point,
- Voltage between PE and CP is +0 V.



## Semi-automatic changing between operating states

As an alternative to the manual changing between operating states via the parameter menu of the **SECLECT STATUS** softkey at the test instrument, there is another fast and convenient way of changing between the operating states: select status parameter **AUTO**. Each time after replying to and storing a visual inspection, an automatic changeover to the next state takes place, with the keys shown on the display corre-



sponding to **01/05** A/E (01 = A, 02 = B, 03 = C, 04 = D, 05 = E). It is possible to skip the status variants by pressing key  $I_{\Delta N}$  at the test instrument or at the test socket.

#### 14.10 Test Sequences for Report Generation of Fault Simulations on PRCDs with PROFITEST PRCD Adapter (MXTRA only)

The following functions can be performed when the **PROFITEST MXTRA** test instrument is connected with the **PROFITEST PRCD** test adapter:

- Three test sequences are preconfigured:
  - PRCD-S (single phase/3-pole)
  - PRCD-K (single phase/3-pole)
  - PRCD-S (three-phase/5-pole)
- The test instrument guides you through all test steps in a semi-automatic fashion:
  - Single phase PRCDs:
  - PRCD-S: 11 test steps
  - PRCD-K: 4 test steps
  - 3-phase PRCDs:

/!\

Attention!

- PRCD-S: 18 test steps
- Each test step is assessed and evaluated by the user (OK/not OK) for subsequent report generation purposes.
- Measurement of protective conductor resistance of the PRCD by means of function R<sub>LO</sub> at the test instrument. Please note that the protective conductor measurement represents a modified RLO measurement with ramp curve for PRCDs, see section 12.
- Measurement of insulation resistance of the PRCD by means of function R<sub>INS</sub> at the test instrument, see section 11.
- Trip test with nominal fault current by means of function I<sub>F</sub> 
   *a*t the test instrument, see section 7.3.
- Measurement of tripping time by means of function  $I_{\Delta N}$  at the test instrument, see section 7.3.
- Varistor test with PRCD-K: measurement via ISO ramp, see section 11.

for **PROFITEST PRCD** before connecting the

PROFITEST MXTRA with the PRCD adapter.

It is imperative that you read the operating instructions

# 14.10.2 Parameter Settings

#### Meaning of Symbols for the Respective Fault Simulation

Switch Position	Symbols s PROFITES	hown at ſ MXTRA	Meaning of Symbols
PROFIT- EST PRCD	Parameter Setting	Menu Display	
ON 🗧	ON	1~0N	Activate single phase PRCD
ON	ON	3~0N	Activate 3-phase PRCD
۰∦۰	BREAK Lx	-{}-	Disconnection of conductor
Ø	Lx <-> PE Lx <-> N	Q	Conductor exchange between phase conductor and PE or neutral conductor
PE-U <sub>EXT</sub>	Uext -> PE	PE-UEXT	PE to phase
	PROBE	<u>он</u>	Contact key ON at PRCD with probe
ON 🗧	PRCD-Ip	0N 1919	Protective conductor current measurement with current clamp transformer
—	AUT0	AUT0	Semi-automatic changing of fault simulations

#### Parameter PRCD-S single phase – 11 parameters = 11 test steps

Together with the required intermediate steps for PRCD activation (=ON), the parameters for the fault simulations represent die 11 potential test steps:

Interruption (BREAK...), conductor exchange (L1 <-> PE), PE to phase (Uext -> PE), contacting of key ON, protective conductor current measurement (Figure on the right: PRCD-Ip).



## Parameter PRCD-S 3-phase - 18 parameters = 18 test steps



Parameter PRCD-K single phase - 5 parameters = 5 test steps



14.10.1 Selecting the PRCD under Test

14.10.3 Test Sequence PRCD-S (single phase) – 11 Test Steps Selection Examples

Simulation Interruption (Steps 1 to 6)



# Simulation Conductor Exchange (Step 7)

(Step 7)		
<u>60</u>	ВАТ 📉 МЕМ 🛄	PRCD-S
<b>O</b>		√ ₀k? X
<b>0</b> 1~01	1 () L1-PE	SELECT TEST

Simulation PE to Phase (Step 8)

BAT MEM	PRCD-S
	v ≤ ₹
0 1~ON PE-VEXT	SELECT
	(

Contacting Key ON at PRCD with Probe (Step 10)



Measurement of Protective Conductor Current with a Current Clamp Transformer (Step 11)



```
14.10.4 Test Sequence PRCD-S (three-phase) - 18 Test Steps
```



Simulation Conductor Exchange (Steps 11 to 16)



Simulation PE to Phase (Step 17)



Measurement of Protective Conductor Current with Current Clamp Transformer (Step 18)



# Semi-automatic Change of Fault Simulations (Statuses)

As an alternative to changing manually between the fault simulations via the parameter menu of the respective PRCD selection **PRCD-S 1~**, **PRCD-K 1~** or **PRCD-S 3~** at the test instrument, it is possible to switch quickly and conveniently between the fault simulations. Select status parameter **AUT0** for this purpose. After replying to and storing each visual inspection, an automatic

switch-over to the next fault simulation takes place. Individual fault simulations can be skipped by pressing key  $I_{\Delta N}$  at the test instrument or at the test plug.



# 15 Automatic Test Sequences – AUTO Function

If the same order of tests with subsequent report generation is to be performed repeatedly, as is, for example, specified by certain standards, we recommend using test sequences.

With the help of test sequences it is possible to compile automatic test procedures on the basis of the manual individual measurements. A test sequence consists of up to 200 individual test steps which have to be processed one after the other. Basically, a distinction is made between three types of individual steps:

- Note: the test procedure is interrupted by a pop-up note for the test engineer. It is not continued before the test engineer acknowledges the note. Example: Note prior to insulation resistance measurement: "Disconnect the device from the mains!"
- Visual inspection, testing and report: the test procedure is interrupted by a pop-up window of a passed/failed evaluation, comments on and results of the evaluation are saved in the database.
- **Measurement:** Measurement like the individual measurements performed by the test instruments with data storage and parameter configuration.

The test sequences are created at a PC by means of the ETC software and are then transferred to the test instruments.

The measurement parameters are also configured at a PC. However, they can still be modified at the test instrument during the test procedure before the respective measurement is launched. After restarting the test step, the parameter settings defined in ETC are loaded.

#### Note

The parameters are not subjected to a plausibility check by the ETC software. We therefore advise you to test the newly created test sequence at the test instrument before filing it permanently in your database.

Limit values are currently not defined in ETC, but have to be adjusted during the automatic test sequence.

#### Menu for the Processing of Test Sequences

In order to process existing test sequences, to add, for example, further test sequences or to adjust parameter settings, they have to be loaded to the ETC PC software beforehand.

There are two possibilities to do this:

- ETC: Extras → Test sequences → Load test sequences (from file "pruefsequenzenxyz.seq")
- or
- ETC: Device  $\rightarrow$  Test sequences  $\rightarrow$  Receive test sequences (from the connected test instrument **PROFITEST MPRO** or **PROFITEST MXTRA**)

File View Edit Device Report	Extra	s Language Help					
🗅 😅 🔚 📾 🗼 👍 🔂 🕭 🏝	12.22	Import Export	1		_	_	
Databasa	Select profiles		•				
- Database		Selection lists		• stabase			
	Test sequences		,		Edit test sequences		
		Bluetooth COM port Bluetooth device search	•		Load test sequences Admin	nistration of test sequence	
	1	Install US8-Driver		11	Set default test sequences		
	-		_	1	Generate a test sequence		

#### Step-by-step Overview: Generating Test Sequences at the PC

A Prüfsequenzen						
Test seque	ence	Verwendet auswählen	es Prüfgerät !	$\sim$	4	
Device Test sequence	Profitest M Circuit					34
Sequence step Test RINS: nomin Measurement RIN Test RLO: with of Measurement - RL Test Ine voltage Uperformer and Sector of the sector Sector of the sector of the sector Sector of the sector of the sector Sector of the sector of the sector of the sector Sector of the sector of the sector of the sector of the sector Sector of the sector	(6/6) al votage 1000 V set 0	1 Type of Text of Params	sequence step em sequence step reme U-type	ant - U Int - U 9	U-LN	• • 10
		11	Accept changes	Cancel		Close 12
V The sequence step	was edit successfully					

- 1 Generate new test sequence enter denomination
- 2 Change denomination of the selected test sequence
- 3 Duplicate selected test sequence,
- (copy) is added at the end of the duplicated name
- 4 Delete selected test sequence
- Generate and/or add new test step for selected test sequence
   Choose the type of test step from the list and accept or modify the denomination
- 6 Duplicate selected test step
- 7 Delete selected test step
- 8 Change the order of the selected test steps
- 9 Select measuring parameters for the selected type of test step from the list
- 10 Choose the setting for the measuring parameters from the list
- 11 Accept modification for the measuring parameter
- 12 Close test sequence menu

## Saving Test Sequences to the ETC Software at the PC

We recommend saving the test sequences of the default setting, modified as well as newly created test sequences via command "Extras  $\rightarrow$  Test sequences  $\rightarrow$  Save test sequences" to the PC or other storage media under a file name (testsequencesxyz.seq). This helps to prevent data loss as a result of certain administrative operations, see the following remarks.

As a maximum of 10 test sequences can be transferred to the test instrument, it is not possible to save more than 10 test sequences in one file.

Via command "Extras  $\rightarrow$  Test sequences  $\rightarrow$  Load test sequences" the test sequences saved to a file can be reloaded to the ETC software at any time.

For subsequent processing select command "Extras  $\rightarrow$  Test sequences  $\rightarrow$  Edit test sequences".

# Please note that the active test sequences in the ETC software are deleted by the following operations:

- by receiving test sequences from the test instrument (ETC: Device → Test sequences → Receive test sequences)
- by changing the user language (ETC: Language  $\rightarrow$  ...)
- by saving the data from the test instrument
- (ETC: Device  $\rightarrow$  Backup/Restore  $\rightarrow$  Backup)

# Please note that the test sequences loaded to the test instrument are deleted by the following operations in the test instrument:

- by receiving selection lists from the PC (ETC: Device → Selection lists → Transmit selection lists)
- by receiving new test sequences from the PC (ETC: Device → Test sequences → Send test sequences)
- by transmitting the saved data to the test instrument (ETC: Device → Backup/Restore → Restore)
- by resetting to default settings (Switch position SETUP → key GOME SETTING)
- by firmware updates
- by changing the user language (Swith position SETUP → key CULTURE)
- by deleting the entire database in the test instrument

# Transferring Test Sequences from the PC to the Test Instrument

After activating the ETC command "Device  $\rightarrow$  Test sequences  $\rightarrow$  Send test sequences" all test sequences that have been created (maximum of 10) are transferred to the connected test instrument.





During the transfer of the test sequences the above progress bargraph is shown at the PC screen and the righthand image appears on the display of the test instrument.



has been completed, the display switches to the storage menu "database".

After the data transfer

By pressing **ESC** you proceed to the measure-

ment menu display of the current switch position.

# Selecting Switch Position AUTO at the Test Instrument



When the rotary switch is set to AUTO, all existing test sequenes in the instrument are displayed, see figure 15.1.

If there are no test sequences in the instrument, message "NO DATA" appears.

# Selecting and Starting a Test Sequence at the Test Instrument

Figure 15.1



Press the  $\ensuremath{\text{START}}$  key to launch the selected test sequence (here: SEQU.1).

When executing a test step of the measurement type, the display structure known from the individual measurements is shown. Instead of the storage and battery symbol, the current test step number is shown in the header (here: step 01 of 06), see figure 15.2. The next test step is shown after pressing the "Save" key twice.

#### Setting Parameters and Limit Values

Parameters and limit values can also be modified while performing a test sequence or before starting the measurement. This modification only affects the active test procedure and is not saved.

## **Skipping of Test Steps**

There are two possibilities to skip test steps and/or individual measurements:

- Activate test sequence, switch to the right-hand test step column with the cursor, select the x <sup>th</sup> test step and press key START.
- Within a test sequence, the navigation menu is activated by pressing the navigation key Cursor leftright. Switch to the previous or next test step with the cursors which are now displayed separately.



Leave the navigation menu and reactivate the current test step with **ESC**.

## Interrupt or Abort a Test Sequence

An active sequence is aborted with  $\ensuremath{\text{ESC}}$  and subsequent confirmation.

When the last test step is completed, the message "Sequence completed" is shown. After confirming this message, the start menu "List of test sequences" appears on the display.

Figure 15.2



# 16 Database

## 16.1 Creating Distributor Structures, General

A complete distributor structure with data for electrical circuits and RCDs can be created in the **PROFITEST MASTER** test instrument.

This structure makes it possible to assign measurements to the electrical circuits of various distributors, buildings and customers.

There are two possible procedures:

 On location or at the construction site: Create the distributor structure in the test instrument.
 A distributor structure with up to 50,000 structural elements can be created in the test instrument, which is saved to the instrument's flash memory.



- or
- Create and save an image of an existing distributor structure at a PC with the help of ETC report generating software (Electric Testing Center) (see condensed operating instructions for ETC report generating software). The distributor structure is then transferred to the test instrument.

ETC Explorer		1 De	all and								
		1255637	et valer 2000 Poppele Barrow pattern Oddisar 2000 Oddisar 2000 Oddis						• • •		
Organit areas			Papat .	Coursetal	-	_	_		√ Acrest		Deles
A Building	New dept lengths	1e. 001 002	C fei M0000005 M0000007 M0000005	See L L	Type L L	Care 2012 11-01 00:30:50 2012 11-01 00:30:50 2012 11-01 00:30:50 2012 11-01 00:30:50	Ingenter John Smith John Smith John Smith	Volue 1:Tuck 1:Tuck 1:Tuck	Let 1 Unit 1 Unit 1 Unit	2 1 1 1 1	Test device Door 2000 2000
Electrical circut     Electrical equipment     Machine	Randor of Aperto 1 0 Constra	003	M0000009	6.		20121101002010		(1) M	C ROMA	100	238

## Note regarding ETC Report Generating Software

The following steps must be completed before using the software:

• Install USB device drivers:

(required for operation of **PROFITEST MASTER** with a PC) GMC-I Driver Control software can be downloaded from Gossen Metrawatt's website at:

http://www.gossenmetrawatt.com

 $\rightarrow$  Products  $\rightarrow$  Software  $\rightarrow$  Software for Testers  $\rightarrow$  Utilities  $\rightarrow$  Driver Control

- Install ETC report generating software: You can download the current ETC version free of charge from our homepage under section **mygmc** after registration or login:

http://www.gossenmetrawatt.com

- $\rightarrow$  Products  $\rightarrow$  Software  $\rightarrow$  Software for Testers
- $\rightarrow$  Protocol Software without Database  $\rightarrow$  ETC  $\rightarrow$  <u>myGMC</u>  $\rightarrow$  <u>zum Login</u>

# 16.2 Transferring Distributor Structures

The following data transfer operations are possible:

- Transfer a distributor structure from the PC to the test instrument.
- Transfer a distributor structure including measured values from the test instrument to the PC.

The test instrument and the PC must be connected with a USB cable in order to transfer distributor structures and data.

The following image appears at the display during transfer of structures and data.



# 16.3 Creating a Distributor Structure in the Test Instrument

#### Overview of the Meanings of Icons used to Create Structures

lcon		Meaning
Main Level	Sub- Level	
		Memory menu, page 1 of 3
		Cursor UP: scroll up
Ŧ		Cursor DOWN: scroll down
ł	ф Ċ	ENTER: acknowledge selection + → - change to sub-level (open directory) or - → + change to main level (close directory)
Ŗ		Display of complete structure designation (max. 63 characters) or ID number (max. 25 characters) in a zoom window
	⋳ ⋜∣⋳ ⋜	Temporarily switching back and forth between structure designation and ID number. These keys do not interfere with the main configu- ration in the setup menu, see DB MODE on page 11.
	9	Hide structure designation or ID number
» 1/3		Change display to menu selection
		Memory menu, page 2 of 3
		Add a structural element
		Meaning of icons from top to bottom: Customer, building, distributor, RCD, electrical cir- cuit, operating equipment, machine and earth electrode (display of the icons depends on the selected structural element). Selection: UP/DOWN scroll keys and J In order to add a designation to the selected structural element, refer to edit menu in following column.
	EDIT	For additional icons see edit menu below
X		Delete the selected structural element.

lcon		Meaning				
		Show measurement data, if a measurement has				
		been performed for this structural element.				
		Edit the selected structural element.				
ľ						
		Memory menu, page 3 of 3				
<b>(</b> 44)		Search for ID number.				
		> Enter complete ID number.				
<b>(44)</b>		Search for text.				
		> Enter full text (complete word).				
æ		Search for ID number or text.				
	هم	Continue searching.				
	, <b>M</b>					
		Edit menu				
		Cursor LEFT:				
		Select an alphanumeric character				
		Cursor RIGHT:				
		Select an alphanumeric character				
┛		ENTER: accept an individual character				
	$\checkmark$	Acknowledge entry				
	←	Cursor left				
	$\rightarrow$	Cursor right				
		Delete characters				
DEL						
		Switching amongst different types of alphanu-				
60		meric characters:				
	А	VABCDEFGHIJK Upper case letters				
		LMNOPQRSTUVW XYZ⊔≪⇒				
	а	√abcdefghijk <sup>Lower case letters</sup>				
		lmnopqrstuvw				
<u> </u>	0					
	0	√0123456789+ Numbers				
		= ^/ =∶,;_ (/∖/   .!?⊔∻⇒				
	@	Special characters				
		≪wanoodone⊅∴ &#áàéèíìóòúù</th></tr><tr><th></th><th></th><th>ก็ที่≋⊔∻⇒</th></tr></tbody></table>				

Distributor Stru	cture Symbology / Tree Structure
A check mark to t	he right of a structural element means that all measurements
within the respectiv	re hierarchy have been passed.
Smbol x: at least o	ne measurement has not been passed.
No symbol: Measu	rrement has not yet been performed.
Customer Building Distributor RCDs Electr. circuit Equipment Equipment	Image: MEM IIII EAT INSE         Image: Odd tabase         Image: Odd tabase
Same type of ele	ment as in the Windows Explorer:
+: sub-object avai	lable, display by pressing ↓.
-: sub-objects are	displayed, hide by pressing ↓.

## 16.3.1 Creating Structures (example for electrical circuit)

After selection with the **MEM** key, all setting options for the creation of a tree structure are made available on three menu pages (1/3, 2/3 and 3/3). The tree structure consists of structural elements, referred to below as objects.

#### Select the position at which a new object will be added.

TXT MEMIII BAT \$\$\$ [Ūdatabase	Scroll up
日常 Walter AG	Scroll down
다료 administration 다료 first floor 다+ 10001	Acknowledge selection / change level
$\begin{array}{c c} \square \not \varphi \text{ circuit 1} \\ \square \varphi \text{ $1/002} \\ \square Q \text{ $1/002$} \\ \square Q \text{ $1/2$} \end{array}$	Display object or ID number
> >	Next page

Use the  $\uparrow \downarrow$  keys in order to select structural elements. Change to the sub-level with the  $\downarrow$  key. Go to the next page with the >> key

#### Create a new object.



#### Select a new object from a list.



Select the desired object from the list with the  $\uparrow\downarrow$  keys and acknowledge with the  $\lrcorner$  key.

Depending upon the profile selected in the test instrument's SETUP menu (see section 4.6), the number of object types may be limited, and the hierarchy may be laid out differently.

#### Enter a designation.



Enter a designation and then acknowledge it by entering a  $\checkmark$ .

#### 🔊 Note

Acknowledge the standard or adjusted parameters shown below, because the created designation will otherwise not be accepted and saved.

#### **Set Electrical Circuit Parameters**



Select parameter Select parameter setting

→ List of parameter settings ↓ Acknowledge parameter setting Acknowledge parameter selection and return to page 1/3 is the distribution

in the database menu.

For example, nominal current values must be entered here for the selected electrical circuit. Measuring parameters which have been accepted and saved in this way are subsequently accepted by the current measuring menu automatically when the display is switched from the structural view to measurement.

# 🐼 Note

Electrical circuit parameters changed during structure creation are also retained for individual measurements (measurement without saving data).

If you change the electrical circuit parameters defined in the structure of the test instrument, a warning is issued upon saving, see error message on page 81.

# 16.3.2 Searching for Structural Elements

TXT MEM []] BAT ())	•	Scroll up
口 Gatabase 白倉 Walter AG 白角 administration	Ŧ	Scroll down
白柔 first floor 白# <b>ROOT</b>	₽	Acknowledge selection / change level
D∉ circuit 1 ↓ circuit 2	Ŗ	Display object or ID number
	» 1/3	Menu selection $\rightarrow$ page 3/3

The search always starts with **database**, regardless of the currently marked object.

Go to page 3/3 in the database menu.





and entering the desired text (only full matches are found – no wild cards, case sensitive)

0 Database	
TEXT	ļ
中的 A constant of the second s	] [•]
P##RUDI EH≠ circuit 1 LQ[ <b>L12</b>	Continue searching

the first match is displayed.

Further matches can be found by selecting the icon shown at the right.





If no further matches are found, the message shown above is displayed.

## 16.4 Saving Data and Generating Reports

Preparing and Executing a Measurement

Measurements can be performed and stored to memory for each structural element. Proceed as follows, adhering to the prescribed sequence:

Select the desired measurement with the rotary knob.

◦ Start the measurement by pressing the **ON/START** or I∆<sub>N</sub> key. Upon completion of measurement, the "→ Floppy Disk" softkey is displayed.

Similar Briefly press the "Save Value" key.

+	Ļ

The display is switched to the memory menu or the structural view.

- Navigate to the desired memory location, i.e. to the desired structural element / object, for which the measurement data will be saved.
- If you would like to save a comment along with the measurement, press the key shown at the right and enter a designation via the "EDIT" menu as described in section 16.3.1.
- Complete data storage by pressing the "STORE" key.

## Storage of Error Messages (Pop-ups)

If a measurement is completed without a measured value being produced on account of an error, this measurement can be saved to memory along with the pop-up via the "Save Value" key. In the ETC the corresponding text is given out instead of the pop-up smybol. This only applies to a limited selection of pop-ups, see below. In the database of the test instrument, neither the symbol nor the text can be retrieved.



PE

#### Alternative Storage Procedure

1 📟 D

The measured value can be saved to the last selected object in the structural diagram by pressing and holding the "Save Value" key, without switching the display to the memory menu.



 $\Box$ 

#### Note 🖉

 $\Box$ 

If you change the parameters in the measurement view, they are not saved for the structural element. A measurement with changed parameters can nevertheless be saved to the structural element, and any changed parameters are documented in the report for each measurement.

#### **Retrieving Saved Measured Values**

- Switch the display to the distributor structure by pressing the MEM key and select the desired electrical circuit with the scroll keys.
  - Switch to page 2 by pressing the key shown here:



Display the measurement data by pressing the key shown here:

One measurement with date and time, as well as any comment you might have entered, is displayed in each screen. Example: RCD Measurement



## 🐼 Note

A check mark in the header means that the respective measurement has been passed.

An X means that the measurement has not been passed.

Scrolling amongst measurements is possible with the keys shown here:



The measurement can be deleted with the key shown here:

A prompt window asks you to confirm deletion.



With the help of the key shown at the right (MW: measured value / PA: parameter), the setting parameters can be displayed for this measurement.

Scrolling amongst measurements

is possible with the keys shown here:

MW PA

- **#⊡** RCD 1 t IF-UIDN 03.03.2012 14:40 IGN: 30mA JUIDN (50 V ŧ RCD IN: 25A TYP A ΜЫ 0°: 📥 1×ION UL: <500 t⊡⇒ TNUTT 1/2
  - † 🖡

#### Data Evaluation and Report Generation with ETC Software

All data, including the distributor structure, can be transferred to the PC and evaluated with the help of ETC software. Additional information can be entered here subsequently for the individual measurements. After pressing the appropriate key, a report including all measurements within a given distributor structure is generated, or the data are exported to an Excel spreadsheet.

## 🐼 Note

The database is exited when the rotary selector switch is turned. Previously selected parameters in the database are not used for the measurement.

#### 16.4.1 Use of Barcode Scanners and RFID Readers

#### Search for an Already Scanned Barcode

The search can be started from any switch setting and menu.

- Scan the object's barcode.
- The found barcode is displayed inversely.

This value is accepted after pressing the ENTER key.

## 🐼 Note

A previously selected object is not taken into consideration by the search.

#### **Continued Searching in General**

**h** » Regardless of whether or not an object has been found, searching can be continued by pressing this key:

- Object found: Searching is continued underneath the previously selected object.
- No further object found: The entire database is searched at all levels.

## Reading In a Barcode for Editing

If the menu for alphanumeric entry is active, any value scanned by means of a barcode or RFID reader is accepted directly.

#### Using a Barcode Printer (accessory)

A barcode printer allows for the following applications:

- Read-out of ID numbers encrypted as barcodes; for quick and convenient acquisition for periodic testing
- Read-out of repeatedly occurring designations such as test object types encrypted as barcodes in a list, allowing them to be read in as required for comments.

# 17 Operating and Display Elements

# **Test Instrument and Adapter**

#### (1) Control Panel – Display Panel

The following are displayed at the LCD:

- One or two measurement values as three place numeric display with unit of measure and abbreviated measured quantity
- Nominal values for voltage and frequency
- Circuit diagrams
- On-line help
- Messages and instructions

The display and control panel can be swiveled forward or backward with the detented swivel hinge. The instrument can thus be set to the optimum reading angle.

#### (2) Eyelets for the Shoulder Strap

The included shoulder strap can be attached at the right and left hand sides of the instrument. You can hang the instrument from your shoulder and keep both hands free for measurement.

#### (3) Rotary Selector Switch

The following basic functions can be selected with this rotary switch:

SETUP / I\_AN / I\_F / Z\_L-PE / Z\_L-N / R\_E / R\_LO / R\_ISO (R\_INS) / U / SENSOR / EXTRA / AUTO

The various basic functions are selected by turning the function selector switch while the instrument is switched on.

#### (4) Measuring Adapter

#### Attention!

<u>/</u>!

The measuring adapter (2-pole) may only be used together with the test instrument's test plug. Use for other purposes is prohibited!

The plug-on measuring adapter (2-pole) with the two test probes is used for measurements in systems without earthing contact outlets, e.g. at permanent installations, distribution cabinets and all three-phase outlets, as well as for insulation resistance and low-value resistance measurements.

The 2-pole measuring adapter can be expanded to three poles for phase sequence testing with the included measurement cable (test probe).

#### (5) Plug Insert (country-specific)

# Attention!

The plug insert may only be used together with the test instrument's test plug. Use for other purposes is prohibited!

After the plug insert has been attached, the instrument can be directly connected to earthing contact outlets. You need not concern yourself with poling at the plug. The instrument detects the positions of phase conductor L and neutral conductor N and automatically reverses polarity if necessary.

The instrument automatically determines whether or not both protective contacts in the earthing contact outlet are connected to one another, as well as to the system protective conductor, for all types of protective conductor measurements when the plug insert is attached to the test plug.

#### (6) Test Plug

The various country specific plug inserts (e.g. protective contact plug insert for Germany or SEV plug insert for Switzerland) or the measuring adapter (2-pole) are attached to the test plug and secured with a threaded connector.

The controls on the test plug are subject to interference suppression filtering. This may lead to slightly delayed responses as opposed to controls located directly on the instrument.

#### (7) Alligator Clip (plug-on)

#### (8) Test Probes

The test probes comprise the second (permanently attached) and third (plug-on) poles of the measuring adapter. A coil cable connects them to the plug-on portion of the measuring adapter.

#### (9) ON/Start ▼ Key

The measuring sequence for the function selected in the menu is started by pressing this key, either on the test



plug or at the control panel. Exception: If the instrument is switched off, it can only be switched on by pressing the key at the control panel.

This key has the same function as the  $\mathbf{\nabla}$  key on the test plug.

#### (10) $I_{\Delta N}$ / I Key (at the control panel)

The following sequences are triggered by pressing this key, either on the test plug or at the control panel:



- Starts the tripping test after measurement of contact voltage for RCCB testing ( $I_{\Delta N}$ ).
- Measurement of Roffset is started within the  $R_{L0}$  /  $Z_{L-N}$  function.
- Semiautomatic polarity reversal (see section 5.8)

#### (11) Contact "Surfaces

The contact surfaces are located at both sides of the test plug. When the contact plug is grasped in the hand, contact is automatically made with these surfaces. The contact surfaces are electrically isolated from the terminals and from the measuring circuit. When the rotary switch is set to the "U" position, the instrument can be used as a phase tester for protection class II devices! In the event of a potential difference of greater than 25 V between protective conductor terminal PE and the contact surface, PE is displayed (see also section 18, "LED Indications, Mains Connections and Potential Differences", beginning on page 73).

#### (12) Test Plug Holder

The test plug with attached plug insert can be reliably secured to the instrument with the rubberized holder.

#### (13) Fuses

The two type FF 3.15 A / 600 V fuses protect the instrument against overload. Phase conductor L and neutral conductor N are fused individually. If a fuse is defective, and if an attempt is made to perform a measurement which uses the circuit protected by this fuse, a corresponding message appears at the display panel.

# Attention!

Severe damage to the instrument may occur if incorrect fuses are used.

Only original fuses from GMC-I Messtechnik GmbH assure required protection by means of suitable blowing characteristics (order no. 3-578-189-01).

#### 🔊 Note

The voltage ranges remain functional even if fuses have blown.

#### (14) Holders for Test Probes (8)

#### (15/16) Current Clamp Sockets

Only the current clamp transformers offered as accessories may be connected to these sockets.

#### (17) Probe Connector Socket

The probe connector socket is required for the measurement of probe voltage  $U_{S-PE}$ , earth electrode voltage  $U_E$ , earthing resistance  $R_E$  and standing surface insulation resistance.

It can be used for the measurement of contact voltage during RCD testing. The probe is connected with a 4 mm contact protected plug.

The instrument determines whether or not the probe has been properly set and displays results at the display panel.

#### (18) USB Port

The USB port allows for the exchange of data between the test instrument and a PC.

#### (19) RS 232 Port

This connection allows for data entry by means of a barcode scanner or an RFID reader.

#### (20) Charging Socket

This socket may only be used to connect the Z502R charger for recharging batteries in the instrument.

#### (21) Battery Compartment Lid – Replacement Fuses

### Attention!

When the lid is removed, the instrument must be disconnected from the measuring circuit at all poles!

The battery compartment lid covers the Compact Master Battery Pack (Z502H) or a battery holder with the batteries and the replacement fuses.

The battery holder or the Z502H battery pack is designed for use with eight 1.5 V AA batteries in accordance with IEC LR 6 for power supply to the instrument. When inserting batteries, make sure that they are poled in accordance with the symbols.



#### Attention!

Make sure that all of the batteries are inserted with correct polarity. If just one battery is inserted with reversed polarity, it will not be recognized by the instrument and may result in leakage from the batteries.

Two replacement fuses are located beneath the battery compartment lid.

# **Control Panel – LEDs**

#### MAINS/NETZ LED

This LED is only functional when the instrument is switched on. It has no function in voltage ranges  $U_{L-N}$  and  $U_{L-PE}$ . It lights up green, red or orange, or blinks green or red depending upon how the instrument has been connected and the selected function (see also section 18, "LED Indications, Mains Connections and Potential Differences", beginning on page 73). This LED also lights up if line voltage is present during measurement of  $R_{INS}$  and  $R_{LO}$ .

#### UL/RL LED

This LED lights up red if contact voltage is greater than 25 V or 50 V during RCD testing, as well as after safety shut-down occurs. It also lights up if  $R_{\rm INS}$  or  $R_{\rm LO}$  limit values have been exceeded or fallen short of.

#### RCD • FI LED

This LED lights up red if the RCCB is not tripped within 400 ms (1000 ms for type RCD S selective RCDs) during the tripping test with nominal residual current. It also lights up if the RCCB is not tripped before nominal residual current has been reached during measurement with rising residual current.
# 18 LED Indications, Mains Connections and Potential Differences

	Status	Test	Meas. Adapter	Position of the	Function / Meaning
I FD India	rations	piug	Αυαριοι	T unction Switch	
	54110113				Correct connection, measurement enabled
netz/ Mains	Lights up green	Х		Z <sub>L-N</sub> / Z <sub>L-PE</sub> / R <sub>E</sub> ΔU, Z <sub>ST</sub> , kWh, IMD, int. ramp, RCM	
netz/ Mains	Blinks green		x	I <sub>ΔN</sub> / I <sub>F</sub> ⊿ Z <sub>L-N</sub> / Z <sub>L-PE</sub> / R <sub>E</sub> ΔU, Z <sub>ST</sub> , kWh, IMD, int. ramp, RCM	N conductor not connected, measurement enabled
NETZ/ Mains	Lights up orange		Х	I <sub>∆N</sub> / I <sub>F</sub> ⊿ Z <sub>L-N</sub> / Z <sub>L-PE</sub> / R <sub>E</sub>	Line voltage of 65 V to 253 V to PE, 2 different phases active (no N conductor at mains), measurement enabled
netz/ Mains	Blinks red	х	x	I <sub>ΔN</sub> / I <b>F∠</b> Z <sub>L-N</sub> / Z <sub>L-PE</sub> / R <sub>E</sub> ΔU, Z <sub>ST</sub> , kWh, IMD, int. ramp, RCM	1) No line voltage or 2) PE interrupted
NETZ/ Mains	Lights up red		Х	R <sub>INS</sub> / R <sub>LO</sub>	Interference voltage detected, measurement disabled
NETZ/ Mains	Blinks Yel- low		х	I <sub>∆N</sub> / I <sub>F</sub> ⊿ Z <sub>L-N</sub> / Z <sub>L-PE</sub> / R <sub>E</sub>	L and N are connected to the phase conductors.
U <sub>L</sub> /R <sub>L</sub>	Lights up red	х	x	I <sub>an</sub> R <sub>ins</sub> / R <sub>i o</sub>	- Contact voltage $U_{I\Delta N}$ and $U_{I\Delta} > 25$ V respectively > 50 V - Safety shut-down has occurred - Limit value exceeded or fallen short of for $R_{INS} / R_{IO}$ function
FI/RCD	Lights up red	Х	Х	I <sub>ΔN</sub> / I <b>F∠</b> int. ramp	The RCCB was not tripped, or was tripped too late during the tripping test.
Mains Co	onnection	i Test — S	Single-Ph	ase System — LCD Cor	nnection Pictographs
? ? ?	is dis- played			All except for U	No connection detected
	is dis- played			All except for U	Connection OK
PE O L N	is dis- played			All except for U	L and N reversed, neutral conductor charged with phase voltage
PE	ie die			All except for U and RE	No mains connection
	played			RE	Standard display without connection messages
PE O X L N	is dis- played			All except for U	Neutral conductor interrupted
PE X L N	is dis- played			All except for U	Protective conductor PE interrupted, neutral conductor N <b>and/or</b> phase conductor L charged with phase volt- age
PE X L N	is dis- played			All except for U	Phase conductor L interrupted, neutral conductor N charged with phase voltage
	is dis- played			All except for U	Phase conductor L and protective conductor PE reversed
PE • x L N	is dis- played			All except for U	Phase conductor L and protective conductor PE reversed Neutral conductor interrupted (with probe only)
	is dis- played			All except for U	L and N are connected to the phase conductors.

	Status	Test plug	Meas. Adapter	Position of the Function Switch	Function / Meaning
Mains Co	onnection	Test — 3	Phase S	ystem — LCD Connect	ion Pictographs
	is dis- played			U (3-phase measurement)	Clockwise rotation
	is dis- played			U (3-phase measurement)	Counter-clockwise rotation
	is dis- played			U (3-phase measurement)	Short between L1 and L2
	is dis- played			U (3-phase measurement)	Short between L1 and L3
	is dis- played			U (3-phase measurement)	Short between L2 and L3
L2 • • 7 L3	is dis- played			U (3-phase measurement)	Conductor L1 missing
å. ůů	is dis- played			U (3-phase measurement)	Conductor L2 missing
	is dis- played			U (3-phase measurement)	Conductor L3 missing
L2 • • •	is dis- played			U (3-phase measurement)	Conductor L1 to N
	is dis- played			U (3-phase measurement)	Conductor L2 to N
L2 • L1 N	is dis- played			U (3-phase measurement)	Conductor L3 to N
Connecti	on Test –	– Earthing	resistan	ce (battery operation)	
	is dis- played			RE	Standard display without connection messages
UEXT	is dis- played		PRO-RE	RE	Interference voltage at probe S > 3 V Bestricted measuring accuracy
IEXT >>	is dis- played		Messza nge	RE	Interference current/measuring current ratio > 50 at RE(sel), 1000 at RE(2Z) Restricted measuring accuracy at RE(sel): Interference current > 0,85 A or Interference current/measuring current ratio > 100
ве(H) >>	is dis- played		PRO-RE	RE	<ul> <li>no measured value, display RE.Z</li> <li>Probe H not connected or RE.H &gt; 150 kΩ</li> <li>no measurment, display RE</li> <li>RE.H &gt; 50 kΩ or</li> <li>RE.H / RE &gt; 10000</li> </ul>
R£(S) ≫	is dis- played		PRO-RE	RE	✓ wieasured value is displayed, restricted measuring accuracy Probe S not connected or RE.S > 150 kΩ or RE.S x RE.H > 25 MΩ <sup>2</sup> ◇ no measurment, display RE – – RE.S > 50 kΩ or PE 0 ( DE = 000)
RE(E) >>	is dis- played		PRO-RE	RE	<ul> <li>KE.S / KE &gt; 300</li> <li>⇒ Measured value is displayed, restricted measuring accuracy</li> <li>Probe E not connected or RE.E &gt; 150 kΩ, RE.E/RE &gt; 2000</li> <li>⇒ no measurment, display RE</li> <li>RE.E/RE &gt; 300</li> <li>⇒ Measured value is displayed, restricted measuring accuracy</li> </ul>

	Status	Test plug	Meas. Adapter	Position of the Function Switch	Function / Meaning
D			·	·	
Battery I	est	1			
	is dis- played			All	Rechargeable batteries must be recharged, or replaced towards the end of their service life (U < 8 V).
DE toot b	v moono	offinger	oontoot o	t the context ourfaces	on the test plug
	I EDe	UT IIIIYEI	contact a	t the contact surfaces	
LOD	LLD3				
<b>PE</b> is displayed	U <sub>L</sub> /R <sub>L</sub> FI/RCD light up	х	х	U (single-phase measurement)	Potential difference $\geq$ 50 V between finger contact and PE (earth contact) Frequency f $\geq$ 50 Hz
PE is displayed	red UL/RL FI/RCD light up red	X	X	U (single-phase measurement)	If L is correctly contacted and PE is interrupted (Frequency f $\geq$ 50 Hz)
Error Mo	000000				
	ssayes –	- LOD FIC	lographs		
	PE Z	х	x	All measurements with protective conductor	Potential difference $\geq U_L$ between finger contact and PE (earth contact) (Frequency f $\geq$ 50 Hz) Remedy: inspect PE connection Note: only when $\iff$ appears: measurement can nevertheless be started by pressing the start key again.
					1) Voltage too high (U > 253 V) for RCD test with direct current
5TOP	<b>A</b> U>Unax	х	х	Ι <sub>ΔΝ</sub> / Ιε <b>Δ</b> Ζ <sub>L-Ν</sub> / Ζ <sub>L-ΡΕ</sub> / R <sub>Ε</sub>	2) U always U > 550 V with 500 mA 3) U > 440 V for $I_{\Delta N} / I_{F}$ 4) U > 253 V for $I_{\Delta N} / I_{F}$ with 500 mA 5) U > 253 V for measurement with probe
	<b>1</b> _всо 50% І <sub>дн</sub>	х	Х	I <sub>AN</sub>	RCD is tripped too early, or is defective. Remedy: test circuit for bias current
اللہ میں ال		х	Х	Z <sub>L-PE</sub>	RCD is tripped too early, or is defective. Remedy: Test with "DC + positive half-wave".
	t∠≞∝⊳ ∞D?	х	Х	$I_{\Delta N} / I_F$	RCD tripped during contact voltage measurement. Remedy: Check selected nominal test current.
				EXTRA $\rightarrow$ PRCD	PRCD has tripped. Cause: poor contact or defective PRCD
STOP -		x	×	All except for U	Externally accessible fuse is blown. The voltage ranges remain functional even if fuses have blown. <b>Special case, R<sub>L0</sub>:</b> Interference voltage during measurement may result in a blown fuse. Remedy: Replace fuse (replacement fuses in battery compartment). <b>Observe notes regarding fuse replacement in section 20.3!</b>
f~>4 f∼<	25 Hz 15 Hz	x	Х	I <sub>ΔN</sub> / IF <b>Δ</b> Z <sub>L-N</sub> / Z <sub>L-PE</sub> / R <sub>E</sub>	Frequency out of permissible range Remedy: inspect mains connection

Status	Test plug	Meas. Adapter	Position of the Function Switch	Function / Meaning
			All	Excessive temperature inside the test instrument Remedy: wait for test instrument to cool down
	Х	Х	R <sub>INS</sub> / R <sub>LO</sub>	Interference voltage Remedy: device under test must be disconnected from all sources of voltage Interference voltage > 20 V at the probes:
	1	PRO-RE	RE (bat)	H to E or S to E no measurement possible
	Х	PRO-RE	RE (bat)	Probe ES not connected or connected wrong.
	1	PRO-RE/ 2	RE (bat)	Generator current clamp (E-Clip-2) not connected
	Х	Х	All measurements with probe	Interference voltage at the probe
	X	х	R <sub>INS</sub> / R <sub>LO</sub>	Overvoltage or overloading of the measuring voltage generator during measurement of ${\rm R}_{\rm INS}$ or ${\rm R}_{\rm LO}$
▲ Un: 0V?	x	x	$I_{\Delta N} / I_F \square$ $Z_{L-N} / Z_{L-PE}$ $Z_{ST}, R_{ST}, R_E$ Meter start-up	No mains connection Remedy: inspect mains connection
	X	X	All	Defective hardware Remedy: 1) Switch on and off. or 2) Briefly remove the batteries. If error message persists, send instrument to GMC-I Service GmbH.
Δ RL0+ RL0- >10%	x	Х	R <sub>LO</sub>	OFFSET measurement is not sensible. Remedy: Check system. OFFSET measurement of <b>R</b> LO+ and <b>R</b> LO– is still possible.
		Х	R <sub>LO</sub>	$R_{OFFSET} > 10 \Omega$ : OFFSET measurement is not sensible. Remedy: Check system.
 Z>18Ω		x	EXTRA $\rightarrow \Delta U$	$Z > 10 \Omega$ : OFFSET measurement is not sensible. Remedy: Check system.
ΔUOFFSET ≥ ΔU		X	EXTRA $\rightarrow \Delta U$	$\Delta U_{OFFSET} > \Delta U$ : Offset value is larger than the measured value at the consuming system. OFFSET measurement is not sensible. Remedy: Check system.
₽[ <u></u> ? *©©0	X	x	R <sub>INS</sub> / R <sub>LO</sub> / R <sub>E(bat)</sub>	Contact problem or blown fuse Remedy: Check test plug or measuring adapter for correct seating in the test plug, or replace the fuse.

Status	Test plug	Meas. Adapter	Position of the Function Switch	Function / Meaning									
		X	R <sub>E</sub>	The polarity of th	e 2-pole a	dapter mus	t be revers	ed.					
	X		I∆N / IF∠	N and PE are sw	apped.								
	X	x	I <sub>∆N</sub> / I <b>f⊿</b> Z <sub>L-N</sub> / Z <sub>L-PE</sub> / R <sub>E</sub>	<ol> <li>Mains conner Remedy: Insp or</li> <li>Display in the underlying pr keys at the te Cause: voltag Result: meas</li> <li>Note: only if pressing the star</li> </ol>	<ul> <li>Mains connection error Remedy: Inspect mains connection.</li> <li>Display in the connection pictograph: PE interruunderlying protective conductor bar interrupted keys at the test plug Cause: voltage measuring path interrupted Result: measurement is disabled</li> <li>Note: only if A appears: Measurement can never pressing the start key again</li> </ul>								
	X		I <sub>∆N</sub> / I <sub>F</sub> ⊿	Display at the co Overlying protect at the test plug Cause: current mo Result: no measu	nnection p ive conduc easuring pat ured value	ictograph: ctor bar inte <b>h</b> interrupte display	errupted wit	th reference	e to the keys				
			R <sub>e</sub> I∆n ∕ I <sub>f</sub> ⊿	Probe is not dete Remedy: inspect	ected, prob probe cor	e not conn inection	ected						
			R <sub>E</sub>	Clamp is not det – Clamp is not co – Current throug – Transformation Remedy: Check Check if neces	ected: onnected c n clamp is ratio set in clamp con the batterio ssary.	or too small (p correctly nection and es in the M	oartial earth d transform ETRAFLEX	resistance ation ratio. P300 and	too high) or replace				
▲ ➡ 199mV/A			R <sub>E</sub>	If you have chang message appear clamp sensor as	ged the tra s promptin well.	nsformation g you to cł	n ratio at th nange the s	e test instru etting at th	ument, a e current				
			R <sub>E</sub>	Voltage too high The transformation not correspond t Remedy: Check	at clamp ir on ratio par o the trans transforma	nput or sigr rameter sel formation r tion ratio o	nal distorted ected at the ratio at the o r setup.	d e test instru current clar	iment might np sensor.				
			All	Battery voltage is Reliable measure Storage of measure Remedy: Rechar the end of their s	e less than ement is no ured values geable bat ervice life.	or equal to longer pos to memor teries must	8 V. ssible. y is disable be recharg	ed. ed, or repla	aced towards				
				Resistance in N-	PE path is	too hígh.							
					10 mA	30 mA	I <sub>∆N</sub> /I <sub>F</sub> 100 mA	300 mA	500 mA				
	<u>*</u>		I <sub>∆N</sub> / IF∠	${\rm R}_{\rm MAX}$ for ${\rm I}_{\Delta \rm N}$ ${\rm R}_{\rm MAX}$ for ${\rm I}_{\rm F}$	510 Ω 410 Ω	170 Ω 140 Ω	50 Ω 40 Ω	15 Ω 12 Ω	9 Ω 7 Ω				
				Consequence: R is aborted.	equired tes	st current c	annot be g	enerated, n	neasurement				
				Upon exceeding	the specifi	ed contact	voltage $U_L$	:					
			Z <sub>L-PE</sub> , R <sub>E</sub>	Z <sub>L-PE</sub> and R <sub>E</sub> : rec only R <sub>E</sub> alternativ Request to reduc	quest to sw ely: ce the mea	vitch to the suring rand	15 mA way	ve current)					
			<u> </u>				, , , , , , , , , , , , , , , , , , , ,						

Status	Test plug	Meas. Adapter	Position of the Function Switch	Function / Meaning
Entry Plausibility	Check – P	arameter	s Combination Checkin	ng — LCD Pictographs
Parameter out of Range				Parameter out of range
1. IAN: 500mA + 2. 5×IAN			I <sub>∆N</sub> / I <sub>F</sub> ∠	5 x 500 mA is not possible
L TYP B2B+ TYP EU + G2R (VSK) BRCD-S PRCD-S PRCD-K			I <sub>ΔN</sub> / I <sub>F</sub> ∠	Type B, B+ and EV/MI not possible with G/R, SRCD and PRCD
1. 180°:↓↓ ↓ G/R (VSK) SRCD 2. PRCD-S PRCD-K			Ι <sub>ΔΝ</sub>	180° not possible for G/R, SRCD, PRCD
L. NEG			I <sub>∆N</sub> / I <b>F∠</b>	DC not possible with G/R, SRCD, PRCD
LTYP AC.F TYP BY.EU + NEG X POS X NEG 1_T POS			I <sub>ΔN</sub> / I <sub>F</sub> ∠	Half-wave or DC not possible with type AC, F, B+ and EV/MI
L. TYP A TYP F + 2. NEG:			$ _{\Delta N} /  _{F} \square$ EXTRA $\rightarrow$ RCM	DC not possible with type A
1. <u>π+Π ΙΔΝ</u> + 2. <u>NEG: </u>			l <sub>ΔN</sub>	1/2 test current not possible with DC
			I <sub>AN</sub>	$2 \times / 5 \times IdN$ with full-wave only
			R <sub>E</sub>	Not without probe in IT network!
®®:√ ™ains∼:χ			R <sub>E</sub>	Battery powered measurement not possible, e.g. with 4-pole adapter connected to the test plug, or for 2-clamp measurement of measurement of soil resistivity
mains∼:√ ∞:χ			R <sub>E</sub>	Mains powered measurement not possible, e.g. with 2/3-pole adapter connected to the test plug
1. DC + 1 + AUTO 1.05Ω (40mA) 2.15Ω (40mA) 1.05Ω (04A) 1.05Ω (04A) 1.05Ω (04A) 1.05Ω (04A)			I <sub>ΔN</sub> / I <sub>F</sub> ∠	DC+ with 10 $\Omega$ only
			R <sub>E</sub>	No DC bias magnetization in the IT network

Status	Test plug	Meas. Adapter	Position of the Function Switch	Function / Meaning
1.15mA +			R <sub>E</sub>	15 mA only possible in the 1 k $\Omega$ and 100 $\Omega$ range!
1.15mA  ~~ + 2.5EL3-P #1			R <sub>E</sub>	15 mA only as loop measurement with or without probe
1. RCM			EXTRA $\rightarrow$ RCM	With RCM: TYPE AC, F , B, B+ and EV/MI not possible
1. IT + NEG: A POS: A POS: C POS: C			Ι <sub>ΔΝ</sub> / Ι <b>ε</b>	No measurement with half-wave or DC in the IT network
1. Parameter 1 + 2. Parameter 2			All	The parameters you have selected do not make sense in combination with previously configured parameters. The selected parameter settings will not be saved. Remedy: Enter other parameter settings.
1. IT + 2.2-P: ⊂⇒⊙			R <sub>E</sub>	2 pole measurement via earthing contact plug (not possible in IT systems)
1. RCD +: to+IA + 2. RCD - 8 2. G/R (VSK)			EXTRA $\rightarrow$ ta+l $\Delta$	The intelligent ramp is not possible with RCD types RCD-S and G/R.

Status	Test plug	Meas. Adapter	Position of the Function Switch	Function / Meaning
Messages — L	CD Pictogra	phs — Te	st sequences	
Sequenc	e		AUTO	The test sequence includes a measurement which cannot be processed by the connected test instrument. The respective test step must be skipped. Example: The test sequence includes a RCM measurement which has been transferred to PROFITEST MTECH.
Sequenc finishe	= 2 1		AUTO	The test sequence has been successfully completed.
▲ NO DATE			AUTO	There are no test sequences available. Cause: They may have been deleted by the following operations: Chang- ing of language, profile, DB mode or by resetting the test instrument to default values.
Frror Message	s — I CD Pic	touranhs	— PBO-AB Leakage C	urrent Adapter
		lographo	The AB Loundye o	
			$EXTRA \to I_L$	Measuring range exceeded Change into the bigger measuring range (test instrument and leakage current measuring adapter).
	Ψ }		$EXTRA \to I_L$	Test measurement: The test has been passed sucessfully. The leakage current measuring adapter is now ready for use.
	Ψ }		$EXTRA \to I_L$	Test measurement: The test has failed. The leakage current measuring adapter is defective. Please consult our repair service.
			$EXTRA \to I_L$	Test measurement: Check the fuse in the leakage current measuring adapter.

Status	Test	Meas.	Position of the	Function / Meaning
Database and Ent	piug rv Operati	Adapter	CD Pictographe	
Dalabase and En	το ομεται		od Ficiographis	Saving a measured value with differing electrical circuit parameter
The measuring para meters differ from the object data Do you wish to adap			$\begin{array}{c}  _{\Delta N} /  _{F} \swarrow \\ Z_{L-N} / Z_{L-PE} \end{array}$ EXTRA $\rightarrow t_{A}+l_{\Delta}$ EXTRA $\rightarrow$ RCM	The electrical circuit parameter you have set at the test instrument <b>does</b> <b>not</b> correspond to the parameter saved in the structure under object data. <b>Example:</b> The residual operating current defined in the database is 10 mA, whereas you have performed measurements with 100 mA. If you wish to perform all future measurements with 100 mA, the value must be modi- fied in the database by acknowledging it with $\checkmark$ . The measured value will be documented and the new parameter will be accepted.
the database?				If you wish to leave the parameter in the database unchanged, press key . Measured value and modified parameter will only be documented.
<b>XT</b> = ? Abc123 !			All	Please enter a designation (alphanumeric).
			All	Operation with a Barcode Scanner Error message appears when the "EDIT" entry field is opened and battery voltage is less than 8 V. Output voltage is generally switched off during barcode scanner operation if U is less than 8 V in order to assure that remaining battery capacity is adequate for entering designations for devices under test and saving the measurement. Remedy: Rechargeable batteries must be recharged, or replaced towards the end of their service life.
			All	Operation with a Barcode Scanner Current flowing through the RS 232 port is too high. Remedy: <b>The connected device is not suitable for this port.</b>
A CODE ?			All	Operation with a Barcode Scanner Barcode not recognized, incorrect syntax
Database			All	Data cannot be entered at this location within the structure. Remedy: Observe profile for preselected PC software (see SETUP menu).
Database			All	Measured value cannot be saved at this location within the structure. Remedy: Make sure that you have selected the right profile for you PC evaluation program in the SETUP menu (see section 4.6).
				Memory is full.
MEM <b>***</b>			All	Remedy: Save your measurement data to a PC and then clear memory at test instrument by deleting the database or by importing an empty database.
Delete?			All	Delete measurement or database. This prompt window asks you to confirm deletion.
				Data loss after changing language or profile, or after restoring default settings.
Delete all data? YES NO	+		SETUP	Back up your measurement data to a PC before pressing the respective key. This prompt window asks you to confirm deletion.
<b>!!</b> File > MEM !!         → [MEM []]]]         □ []]         □ []]         □ []]			All	This error message appears when the database, i. e. the structure cre- ated in the ETC software, is too large for the device memory. The database in the device memory is empty after database transfer has been interrupted. Remedy: Reduce the database in ETC or send the database without measured vales (key <b>Send structure</b> ) if measured values should already be available.

# Characteristic Values MBASE+ & MTECH+

					Con				nections						
Func-	Measured	Display Range	Reso-	Input Impedance/	Measuring Range	Nominal Values	Measuring	Intrinsic	Plug	2-Polo	3-Polo			ClampS	
tion	Quantity		lution	Test Current	<b>J</b>		Uncertainty	Uncertainty	Insert <sup>1</sup>	Adapter	Adapter	Probe	WZ12C	Z3512A	MFLEX
<u> </u>	ll ar	0 99.9 V	0.1 V				+(2% rda.+5d)	+(1% rda.+5d)							F300
	U <sub>N-PE</sub>	100 600 V	1 V		0.3 600 V <sup>1)</sup>		±(2% rdg.+1d)	±(1% rdg.+1d)							
	f	15.0 99.9 Hz 100 999 Hz	0.1 Hz 1 Hz	-	DC 15,4 420 Hz	$U_{\rm N} = 120/230/$	±(0.2% rdg.+1d)	±(0.1% rdg.+1d)		•	•				
U	U <sub>3~</sub>	0 99.9 V 100 600 V	0.1 V 1 V	5 MΩ	0.3 600 V	400/500 V	±(3% rdg.+5d) ±(3% rdg.+1d)	±(2% rdg.+5d) ±(2% rdg.+1d)			•				
	U <sub>PROBE</sub>	0 99.9 V 100 600 V	0.1 V 1 V	-	1.0 600 V	60/200/400 Hz	±(2% rdg.+5d) ±(2% rdg.+1d)	$\pm(1\% \text{ rdg.}+5\text{d})$ $\pm(1\% \text{ rdg.}+1\text{d})$				•	-		
	U <sub>L-N</sub>	0 99.9 V 100 600 V	0.1 V 1 V		1.0 600 V <sup>1</sup>		±(3% rdg.+5d) ±(3% rdg.+1d)	±(2% rdg.+5d) ±(2% rdg.+1d)	•		•				
	U <sub>IAN</sub>	0 70.0 V	0.1 V	0.3 · I <sub>ΔN</sub>	5 70 V		+10% rdg.+1d	+1% rdg1d +9% rdg.+1d							
		10 Ω 999 Ω	1Ω	$I_{AN} = 10 \text{ mA} \cdot 1.05$					-						
		1.00 kΩ 6.51 kΩ	0.01 kΩ	<u>-</u> ДN , ,											
		3 Ω 999 Ω 1 kΩ 2.17 kΩ	0.01 kΩ	$I_{\Delta N} = 30 \text{ mA} \cdot 1,05$	calculated value	$U_N =$									
	RF	1Ω 651 Ω	1Ω	I <sub>AN</sub> =100 mA · 1,05	from	120 V 230 V									
	-	0.3 Ω 99.9 Ω	0.1 Ω	L = 200 mA - 1.05	$U_{I\Delta N}$ / $I_{\Delta N}$	400 V <sup>2</sup>									
		100 Ω 217 Ω	1Ω	IAN-300 IIIA * 1,03		£ 50/00 UE									
L		$0.2 \Omega \dots 9.9 \Omega$	0.1 Ω 1 Ω	I <sub>ΔN</sub> =500 mA · 1,05		$I_{N} = 50/60 Hz$									
I '∆N	$l_{E}(l_{AN} = 6 \text{ mA})$	1.8 7.8 mA	132	1.8 7.8 mA	1.8 7.8 mA	$U_{L} = 25/50 V$			•	•		ontio			
IF -	$I_F (I_{AN} = 10 \text{ mA})$	3.0 13.0 mA	0,1 mA	3.0 13.0 mA	3.0 13.0 mA	L.n. =						nal			
-	$I_F (I_{\Delta N} = 30 \text{ mA})$	9.0 39.0 mA	-	9.0 39.0 mA	9.0 39.0 mA	6 mA	$\pm (50)$ rdg $\pm 1d$	+/2 50/ rda + 2d)							
	$I_F (I_{\Delta N} = 100 \text{ mA})$	30 130 mA	1 mA	30 130 mA	30 130 mA	10 mA	±(5% lug.+ lu)	±(3.5% lug.+2u)							
	$I_F (I_{\Delta N} = 300 \text{ mA})$	90 390 mA	1 mA	90 390 mA	90 390 mA	100 mA									
	$I_{\rm F} (I_{\Delta \rm N} = 500 \text{ mA})$	150 650 mA	1 mA	150 650 mA	150 650 mA	300 mA 500 mA <sup>2</sup>			_						
-	$U_{L\Delta}/U_L = 25 V$	0 25.0 V	0.1 V	wie I $_{\Delta}$	0 25.0 V		+10% rdg.+1d	+1% rdg1d							
	$0_{I\Delta} / 0_L = 50 V$	0 50.0 V	1 ms	6 500 mA	0 1000 ms			13/0109.110	-						
	$t_A (t_{AN} \cdot 1)$ $t_A (t_{AN} \cdot 2)$	0 1000 ms	1 1113	2 · 6 2 · 500 mA	0 1000 ms		±4 ms	±3 ms							
	$t_A (I_{AN} \cdot 5)$	0 40 ms	1 ms	5 · 6 5 · 300 mA	0 40 ms										
	$Z_{L-PE}( )$	0 999 mΩ 1.00 9.99 Ω	1 mΩ		0.15 0.49 Ω 0.50 0.99 Ω 1.00 9.99 Ω	$\begin{array}{l} U_{N} = 120/230 \text{ V} \\ 400/500 \text{ V}^{1} \\ f_{N} = 16^{2}/_{3}^{8}/50/60\text{Hz} \end{array}$	$\pm(10\% \text{ rdg.}+ 30\text{d})$ $\pm(10\% \text{ rdg.}+ 30\text{d})$ $\pm(5\% \text{ rdg.}+ 3\text{d})$	$\pm$ (5% rdg.+30d) $\pm$ (4% rdg.+30d) $\pm$ (3% rdg.+3d)							
	Z <sub>L-PE</sub> + DC	0 999 mΩ 1.00 9.99 Ω 10.0 29.9 Ω	0.01 Ω 0.1 Ω	1.3 3.7 A AC 0.5/1.25 A DC	0.25 0.99 Ω 1.00 9.99 Ω	$U_{\rm N} = 120/230 \text{ V}$ $f_{\rm N} = 50/60 \text{ Hz}$	±(18% rdg.+30d) ±(10% rdg.+3d)	±(6% rdg.+50d) ±(4% rdg.+3d)	-						
7	lu (7. pr. 🔺	0 9.9 A	0,1 A		120 (108 132) V				-						
L-PE	'K (ZL-PE	10 999 A	1 A		230 (196 253) V		calculated val	ue from Z <sub>L-PE</sub>	•	•					
Z <sub>L-N</sub>	$Z_{L-PE} \longrightarrow + DC)$	10.0 50.0 kA	100 A		500 (450 550) V					Z <sub>L-PE</sub>					
		$0.5 \dots 9.99 \Omega$	$0.01\Omega$			only display range	)								
	Z <sub>L-PE</sub> (15 mA)	10.0 99.9 Ω	0.1 Ω		10 100 Ω		±(10% rdg.+10D)	±(2% rdg.+2D)							
		100 999 C2	1 mA	15 mA AC		$U_N = 120/230 V$ $f_N = 16^2/28/50/$	±(8% lug.+2D)	±(1% lug.+1D)	-						
	I <sub>K</sub> (15 mA)	0.00 9.99 A	0.01 A	10 111 110	on U <sub>N</sub> and Z <sub>I -PF</sub> :	60 Hz	calculated value fr	om Z <sub>L-PE</sub> (15 mA):							
		10.0 99.9 A	0.1 A		$I_{\rm K} = U_{\rm N} / 101000 \Omega$		IK = 0N/2L-	PE (13 IIIA)							
	Br (with probe)	$0 \dots 999 \ \text{m} \Omega$	$1~\text{m}\Omega$	1.3 3.7 A AC	$0.15 \Omega \dots 0.49 \Omega$		$\pm(10\% \text{ rdg.}+30\text{d})$ $\pm(10\% \text{ rdg.}+30\text{d})$	$\pm (5\% \text{ rdg.} + 30d)$ $\pm (4\% \text{ rdg.} + 30d)$							
	The (min probo)	$1.00 \dots 9.99 \Omega$	0,01 Ω	1.3 3.7 A AC	1.0 Ω9.99 Ω	$U_{\rm N} = 120/230 \rm V$	±(5% rdg.+3d)	$\pm(3\% \text{ rdg.}+3d)$							
	[R <sub>E</sub> (without probe)	100 999 Ω	1Ω	400 mA AC	10 Ω99.9 Ω	$f_N = 50/60 \text{ Hz}$	$\pm(10\% \text{ rdg.}+3d)$	$\pm(3\% \text{ rdg.}+3d)$							
R <sub>E</sub>	values as Z <sub>L-PE</sub> J	1 kΩ 9.99 kΩ	0.01 kΩ	40 ma ac 4 ma ac	1 kΩ9.99 kΩ		$\pm(10\% \text{ rdg.}+3d)$ $\pm(10\% \text{ rdg.}+3d)$	$\pm(3\% \text{ rdg.}+30)$ $\pm(3\% \text{ rdg.}+30)$	$\bullet$	•		•			
R <sub>E</sub>	R <sub>E</sub> DC+	0 999 mΩ 1.00 9.99 Ω 10.0 29.9 Ω	1 mΩ 0.01 Ω 0.1 Ω	1.3 3.7 A AC 0.5/1.25 A DC	0.25 0.99 Ω 1.00 9.99 Ω	$U_{N} = 120/230 \text{ V}$ $f_{N} = 50/60 \text{ Hz}$	±(18% rdg.+ 30d) ±(10% rdg. + 3d)	±(6% rdg.+50D) ±(4% rdg.+3D)	-						
	U <sub>F</sub>	0 253 V	1 V	_	calculated value				1						
	Re Re	0 999 0	1 mΩ			SEE R-	+(20% rdn ± 20 d)	+(15% rod ± 20 d							
R <sub>E</sub> Sel	''E	0	1Ω	1.3 3.7 A AC	0.25 300 Ω <sup>5)</sup>	1000 TE	±120 /0 10(9.⊤ 20 0)	-(10 /0 igu.⊤ 20 u)	-						•
	R <sub>E</sub> DC+	0 999 Ω	1 mΩ 1 Ω	0.3/1.25 A DU	404.00	$u_{\rm N} = 120/230 \text{ V}$ $f_{\rm N} = 50/60 \text{ Hz}$	±(22% rdg.+20 d)	±(15% rdg.+ 20 d)							
TRA	Z <sub>ST</sub>	0 30 MΩ	1 kΩ	2.3 mA at 230 V	10 κΩ 199 κΩ 200 kΩ 30 MΩ	$\boldsymbol{U}_0 = \boldsymbol{U}_{L\text{-}N}$	±(20% rdg.+2d) ±(10% rdg.+2d)	$\pm$ (10% rdg.+3d) $\pm$ (5% rdg.+3d)		•	•	•			

											Co	nnectio	ns		
Func-	Measured	Display Range	Reso-	Test Current	Measuring Range	Nominal Values	Measuring	Intrinsic	Ρίμα	2-Pole	3-Pole		Clar	npS	
uon	Quantity		iution				Uncertainty	Uncertainty	Insert <sup>1</sup>	Adapter	Adapter	WZ12C	Z3512A	MFLEX P300	CP1100
		1 999 kΩ 1.00 9.99 MΩ 10.0 49.9 MΩ	1 kΩ 10 kΩ 100 kΩ			$U_N = 50 V$ $I_N = 1 mA$									
		1 999 kΩ 1.00 9.99 MΩ 10.0 99.9 MΩ	1 kΩ 10 kΩ 100 kΩ	I <sub>K</sub> = 1.5 mA		$\begin{array}{l} U_{N}=100 \text{ V} \\ I_{N}=1 \text{ mA} \end{array}$	kΩ range ±(5% rdg.+10d) MΩ range ±(5% rdg.+1d)	$k\Omega$ range +(3% rdg.+10d)							
R <sub>INS</sub>	R <sub>INS</sub> . R <sub>E INS</sub>	1 999 kΩ 1.00 9.99 MΩ 10.0 99.9 MΩ 100 200 MΩ	1 kΩ 10 kΩ 100 kΩ 1 MΩ		50 kΩ 500 MΩ	$U_{N} = 250 \text{ V}$ $I_{N} = 1 \text{ mA}$		MΩ range ±(3% rdg.+1d)	•	•					
		1 999 kΩ 1.00 9.99 MΩ 10.0 99.9 MΩ 100 500 MΩ	1 kΩ 10 kΩ 100 kΩ 1 MΩ			U <sub>N</sub> = 500 V/ 1000 V I <sub>N</sub> = 1 mA									
	U	10 999 V– 1.00 1.19 kV	1 V 10 V		10 1.19 kV		±(3% rdg.+1d)	±(1.5% rdg.+1d)							
R <sub>LO</sub>	R <sub>LO</sub>	0.01 Ω 9.99 Ω 10.0 Ω 99.9 Ω	10 mΩ 100 mΩ	$I_m \ge 200 \text{ mA}$ $I_m < 200 \text{ mA}$	0.1 Ω 5.99 Ω 6.0 Ω 100 Ω	$U_0 = 4.5 V$	±(4% rdg.+2d)	±(2% rdg.+2d)		•					
				Transforma- tion ratio <sup>3</sup>			5	5							
		0.0 99.9 mA	0.1 mA	1 V/A 1 mV/A	5 15 A 5 150 A		±(13% rdg.+5d)	±(5% rdg.+4d)							
		100 999 mA 1.00 9.99 A 10 0 15 0 A	1 mA 0.01 A 0 1 A			fu = 50/60 Hz	±(13% rdg.+1d)	±(5% rdg.+1d)				l 15A			
		1.00 9.99 A	0.01 A			IN - 00/00 Hz	±(11% rda.+4d)	±(4% rdg.+3d)							
		10.0 99.9 A	0.1 A				$\pm (11\% rdg \pm 1d)$	+(1% rdg + 1d)				II 150A			
		100 150 A	1 A				±(11%10g.+10)	±(4 % lug. + lu)							
		0.0 99.9 mA	0.1 mA		5 1000 mA		±(7% rdg.+2 d)	±(5% rdg.+2 d)					1 A		
		100 999 mA	1 mA	100 \//A	0.05 10.4	-	$\pm (7\% \text{ rdg.}+1 \text{ d})$	$\pm (5\% \text{ rdg.}+1 \text{ d})$					10.4		
		0.00 9.99 A	0.01 A	TUU MV/A	0.05 10 A	f <sub>N</sub> =	$\pm (3.4\% \text{ rdg.} + 2 \text{ d})$ $\pm (2.1\% \text{ rdg.} + 2 \text{ d})$	$\pm (3\% \text{ rdg.} + 2 \text{ d})$					TUA		
OFN		10.00 9.99 A	0.01 A	10 mV/A	0.5 100 A	16.7/50/60/	$\pm$ (3.1% rdg.+2 d) +(3.1% rdg.+1 d)	$\pm (3\% \text{ rdg.} + 2 \text{ d})$ $\pm (3\% \text{ rdg.} + 1 \text{ d})$					100 A		
SEN-		0.00 9.99 A	0.1 A			200/400 Hz	$\pm (3.1\% \text{ rdg.} \pm 1 \text{ d})$ $\pm (3.1\% \text{ rdg.} \pm 1 \text{ d})$	$\pm (3\% \text{ rdg.} + 1 \text{ d})$ $\pm (3\% \text{ rdg.} + 1 \text{ d})$							
	I <sub>L/Amp</sub>	10.0 99.9 A	0.1 A	1 mV/A	5 1000 A		$\pm(3.1\% \text{ rdg.}+2 \text{ d})$	$\pm(3\% rdg.+2 d)$					1000A		
6		100 999 A	1 A	-			$\pm(3.1\% \text{ rdg.}+1 \text{ d})$	$\pm(3\% \text{ rdg.}+1 \text{ d})$							
·		0.0 99.9 mA	0.1 mA				±(27% rdg.+100 d)	±(3% rdg.+100 d)						0.03	
		100 999 mA	1 mA	1 V/A	30 1000 mA		±(27% rdg.+11 d)	±(3% rdg.+11 d)						3	
			0.01 A				±(27% rdg.+12 d)	±(3% rdg.+12 d)						0.3	
		0.00 9.99 A	0.01 A	100 mV/A	0.3 10 A	$t_{\rm N} = 50/60 \text{ Hz}$	±(27% rdg.+11 d)	±(3% rdg.+11 d)						30	
		0.00 9.99 A	0.01 A	10.144		-	±(27% rdg.+100 d)	±(3% rdg.+100 d)						3	
		10.0 99.9 A	0.1 A	IU MV/A	3 100 A		±(27% rdg.+11 d)	±(3% rdg.+11 d)						300	
		0.00 9.99 A	0.01 A	10 \//A	0.5 100.4		±(5% rdg.+12 d)	±(3% rdg.+12 d)							100A
		10.0 99.9 A	0.1 A	TU MV/A	0.5 100 A	f <sub>N</sub> =	±(5% rdg.+2 d)	±(3% rdg.+2 d)	]						~
		0.00 9.99 A	0.01 A			DC/16.7/50/60/	±(5% rdg.+50 d)	±(3% rdg.+50 d)							10004
		10.0 99.9 A	0.1 A	1 mV/A	5 1000 A	200 Hz	±(5% rdg.+7 d)	±(3% rdg.+7 d)							~
		100 999 A	1 A				±(5% rdg.+2 d)	±(3% rdg.+2 d)							

<sup>1</sup> U > 253 V, with 2 or 3-pole adapter only <sup>2</sup> 1./2·LAN > 300 mA and 5·LAN > 500 mA and If > 300 mA only up to U<sub>N</sub> ≤ 230 V! LAN 5·300 mA only with U<sub>N</sub> = 230 V <sup>3</sup> The transformation ratio selected at the clamp (1 ... 1000 mV/A) must be set in the "Type" menu with the rotary switch in the "SENSOR" position.

4 at R<sub>Eselekti</sub>/R<sub>Egesant</sub> < 100 5 the indicated measuring and intrinsic uncertainties already include the uncertainties

of the respective current clamp. Measuring range of the signal input at the test instrument U<sub>E</sub>: 0 ... 1.0 V<sub>eff</sub> (0 ... 1.4 Vpeak) AC/DC Input impedance of signal input at the test instrument: 800 kΩ for f<sub>N</sub> < 45 Hz => U<sub>N</sub> < 253 V

Key: D = digits, rdg. = measured value (reading)

# Characteristic Values MPRO, MXTRA & SECULIFE IP

											Con	nection	15		
Func- tion	Measured Quantity	Display Range	Reso- lution	Input Impedance / Test Current	Measuring Range	Nominal Values	Measuring Uncertainty	Intrinsic Uncertainty	Plug Insert <sup>1</sup>	2-Pole Adapter	3-Pole Adapter	Probe	WZ12C	Clamp Z3512A	MFLEX P300
	U <sub>L-PE</sub>	0 99.9 V	0.1 V		0.3 600 V <sup>1</sup>		±(2% rdg.+5d)	±(1% rdg.+5d)							
	UN-PE	100 600 V	1 V 0 1 Hz	-		U <sub>N</sub> =	±(2% rdg. + 1 d)	±(1% rdg. + 1 d)		$\bullet$	•				
	f	100 999 Hz	1 Hz		DC 15.4 420 Hz	230 V	±(0.2% rdg. + 1 d)	±(0.1% rdg. + 1 d)							
U	U <sub>3~</sub>	0 99.9 V 100 600 V	0.1 V 1 V	5 MΩ	0.3 600 V	400 V 500 V	$\pm$ (3% rdg.+5d) $\pm$ (3% rdg. + 1 d)	$\pm$ (2% rdg.+5d) $\pm$ (2% rdg. + 1 d)	-		•		-		
	UProbe	0 99.9 V 100 600 V	0.1 V 1 V		1.0 600 V	$f_N = 16^2 / _3 / 50 /$	$\pm$ (2% rdg.+5d) +(2% rdg. + 1 d)	$\pm(1\% \text{ rdg.}+5\text{d})$ +(1% rdg.+1d)				•			
	U <sub>L-N</sub>	0 99.9 V	0.1 V	-	1.0 600 V <sup>1</sup>	60/200/400 Hz	$\pm (3\% \text{ rdg.} + 5d)$ $\pm (2\% \text{ rdg.} + 1 d)$	$\pm (2\% \text{ rdg.} + 5d)$ $\pm (2\% \text{ rdg.} + 1d)$	•	_	•		-		
	UIAN	0 70.0 V	0.1 V	0.3 · I_AN	5 70 V		+10% rdg. + 1 d	+1% rdg1d							
	- 1/2114	10 0 999 0	1.0	ΔΝ		U <sub>N</sub> = 120 V		+9% rdg. + 1 d	-						
		1.00 kΩ 6.51 kΩ	0.01 kΩ	$I_{\Delta N} = 10 \text{ mA} \cdot 1.05$		230 V									
		$3 \Omega \dots 999 \Omega$	1Ω	$I_{\Delta N} = 30 \text{ mA} \cdot 1.05$		400 V									
	R⊧	1Ω651Ω	1Ω	I₄N=100 mA · 1.05	Calculated value	f <sub>N</sub> = 50/60 Hz									
		0.3 Ω 99.9 Ω	0.1 Ω	Lu-300 mA 1 05	$R_E = U_{I\Delta N} / I_{\Delta N}$	11. – 25/50 V									
		100 Ω 217 Ω	1Ω	IAN-300 IIIA 1.03	_	0[ = 20/00 V									
IAN		$10 \Omega 130 \Omega$	$1 \Omega$	$I_{\Delta N}$ =500 mA $\cdot$ 1.05		I <sub>ΔN</sub> = 6 mA									
	$I_F (I_{\Delta N} = 6 \text{ mA})$	1.8 7.8 mA		1.8 7.8 mA	1.8 7.8 mA	10 mA			•	•		Option			
<sup>1</sup> F	$I_{\rm F} (I_{\Delta \rm N} = 10 \text{ mA})$	3.0 13.0 mA	0,1 mA	3.0 13.0 mA	3.0 13.0 mA	30 mA 100 mA						option			
	$I_F (I_{\Delta N} = 30 \text{ mA})$	9.0 39.0 MA	1 mA	9.0 39.0 MA	9.0 39.0 mA	300 mA	+(5% rda + 1 d)	±(3.5% rdg. + 2							
	$I_{\rm F} (I_{\rm AN} = 300 \text{ mA})$	90 390 mA	1 mA	90 390 mA	90 390 mA	500 mA <sup>2</sup>	±(0 /0 /0g. 1 / 0)	d)							
	$I_F (I_{\Delta N} = 500 \text{ mA})$	150 650 mA	1 mA	150 650 mA	150 650 mA										
	$U_{L\Delta} / U_L = 25 V$	0 25.0 V	0.1 V	Same as IA	0 25.0 V	$U_{N} \le 230 V$	+10% rdg. + 1 d	+1% rdg1d							
	$U_{I\Delta} / U_L = 50 V$	0 50.0 V	1 mc	6 500 mA	0 50.0 V			+9% rag.+ 1a	-						
	$t_A (t_{\Delta N} \cdot 1)$ $t_A (t_{\Delta N} \cdot 2)$	0 1000 ms	1 ms	2 · 6 2 · 500 mA	0 1000 ms	U <sub>N</sub> ≤ 230 V	±4 ms	±3 ms							
	$t_A (I_{\Delta N} \cdot 5)$	0 40 ms	1 ms	5 · 6 5 · 300 mA	0 40 ms	IN IN									
	$Z_{L-PE}( \frown)$ $Z_{L-N}$	0 999 mΩ 1.00 9.99 Ω	1 mΩ	3.7 4.7 A AC	$\begin{array}{c} 0.10 \dots 0.49 \ \Omega \\ 0.50 \dots 0.99 \ \Omega \\ 1 \ 00  9 \ 99 \ \Omega \end{array}$	$U_{\rm N} = 120/230 \text{ V}$ $400/500 \text{ V}^{1}$ $f_{\rm N} = 16^{2}/_{2}^{8}/50/60 \text{ Hz}$	$\pm$ (10% rdg.+20d) $\pm$ (10% rdg.+20d) $\pm$ (5% rdg +3d)	$\pm$ (5% rdg.+20d) $\pm$ (4% rdg.+20d) $\pm$ (3% rdg +3d)							
	Z <sub>L-PE</sub> + DC	0 999 mΩ 1.00 9.99 Ω	0.01 Ω 0.1 Ω	3.7 4.7 A AC 0.5/1.25 A DC	0.25 0.99 Ω 1.00 9.99 Ω	$U_{\rm N} = 120/230 \text{ V}$ $f_{\rm N} = 50/60 \text{ Hz}$	±(18% rdg.+30d) ±(10% rdg.+3d)	±(6% rdg.+50d) ±(4% rdg.+3d)	-						
7		0 9.9 A	0,1 A		120 (108 132) V										
L-PE	IK (∠L-PE —,	10 999 A	1 A		230 (196 253) V		Value calcula	ted from Z <sub>L-PE</sub>	•	•					
Z <sub>L-N</sub>	$Z_{L-PE} \longrightarrow + DC$	1.00 9.99 kA 10.0 50.0 kA	10 A 100 A		400 (340 440) V 500 (450 550) V					Z <sub>L-PE</sub>					
	Z <sub>L-PE</sub> (15 mA)	0.5 99.9 Ω 100 999 Ω	0.1 Ω 1 Ω	_	10 100 Ω 100 1000 Ω	Un = 120/230 V	±(10% rdg.+10d) ±(8% rdg. + 2 d)	$\pm (2\% \text{ rdg.} + 2 \text{ d}) \\ \pm (1\% \text{ rdg.} + 1 \text{ d})$	_						
	I <sub>K</sub> (15 mA)	0.10 9.99 A 10.0 99.9 A 100 999 A <sup>14)</sup>	0.01 A 0.1 A 1 A	15 mA AC	100 mA 12 A (U <sub>N</sub> = 120 V) 200 mA 25 A	$f_N = \frac{16^2}{_3^8/50/}$ 60 Hz	Value calc $I_{\rm K} = U_{\rm N}/Z_{\rm L}$	ulated from <sub>-PE</sub> (15 mA)							
<u> </u>					$(U_N = 230 \text{ V})$		+(10% rda +20d)	+(5% rdg +20d)							
	R <sub>E.sl</sub> (without	0999 mΩ 100 999 Ω	$1 \text{ m}\Omega$	3.7 4.7 A AC	$0.50 \ \Omega \dots 0.99 \ \Omega$	I lu same as I l	$\pm(10\% \text{ rdg.}+20\text{d})$	$\pm$ (4% rdg.+20d)							
	probe)	10.0 99.9 Ω	0.1 Ω	400 mA AC	$1.0 \Omega 9.99 \Omega$	function <sup>1</sup>	$\pm$ (5% rdg.+3d) +(10% rdg $\pm$ 3d)	$\pm(3\% \text{ rdg.}+3d)$ $\pm(3\% \text{ rdg.}+3d)$							
	R <sub>E</sub> (with probe)	100 999 Ω 1 kΩ 9 99 kΩ	1Ω 0.01 kΩ	40 mA AC 4 mΔ ΔC	100 Ω999 Ω	f <sub>N</sub> = 50/60 Hz	$\pm(10\% \text{ rdg.+3d})$	$\pm$ (3% rdg.+3d)							
	R <sub>E (15 mA)</sub>	0.5 99.9 Ω	0.1 Ω	15 mA AC	1 kΩ 9.99 kΩ 10 Ω99.9 Ω	U <sub>N</sub> = 120/230 V	$\pm(10\% \text{ rdg.}+3d)$ $\pm(10\% \text{ rdg.}+10d)$	$\pm$ (3% rdg.+3d) $\pm$ (2% rdg. + 2 d)							
ι <sup>κ</sup> ε	(without/with probe)	100 999 Ω	1Ω	TO THA AU	100 Ω999 Ω	f <sub>N</sub> = 50/60 Hz	±(8% rdg. + 2 d)	±(1% rdg. + 1 d)	•	•		•			
	probe) $-$ + DC	0999 mΩ 1.00 9.99 Ω	1 mΩ 0 01 Ω	3.7 4.7 A AC	0.25 0.99 Ω	U <sub>N</sub> = 120/230 V	±(18% rdg.+30d)	±(6% rdg.+50d)							
	$R_{E.sl}$ (with probe) + DC	10.0 29.9 Ω	0.1 Ω	0.5/1.25 A DC	1.00 9.99 Ω	f <sub>N</sub> = 50/60 Hz	±(10% rdg.+3d)	±(4% rdg.+3d)							
	U <sub>E</sub>	0 253 V	1 V	3.7 4.7 A AC	$R_{E} = 0.10 \dots 9.99 \ \Omega$	$U_{\rm N} = 120/230 \text{ V}$ $f_{\rm N} = 50/60 \text{ Hz}$	Calculated U <sub>E</sub>	$= U_{N} \cdot R_{E}/R_{E.sl}$	-						
	R <sub>E.sel</sub>	0999 mΩ	1 mΩ	2.1 A AC		II 120/230 V								_	
D	(only with probo)	10.0 99.9 Ω	0.01 Ω	400 mA AC	$0.25 \dots 300 \Omega^4$	$f_N = 50/60 \text{ Hz}$	±(20% rdg.+20 d)	±(15% rdg.+20 d)						•	
Sel	(only with probe)	100 999 Ω	1Ω	40 mA AC					-						
Clamp	R <sub>E.sel</sub>	0999 mΩ 100 999 Ω	1 mΩ 0.01 Ω	37 47AAC	0.25 300 0	II. = 120/230 V									-
	+ DC (only with probe)	10.0 99.9 Ω	0.1 Ω	0.5/1.25 A DC	$R_{E.tot} < 10 \Omega^4$	$f_N = 50/60 \text{ Hz}$	±(22% rdg.+20 d)	±(15% rdg.+20 d)							
<u> </u>		100 999 Ω	1Ω		1010 10010		L (000/ ed- 00 "	1 (100/ 2- 0 )							<u> </u>
EXTRA	Z <sub>ST</sub>	0 to 30 MΩ	1 kΩ	2.3 mA at 230 V	10 κΩ 199 κΩ 200 kΩ 30 MΩ	$U_0 = U_{L-N}$	$\pm (20\% \text{ rug.} + 2 \text{ d})$ $\pm (10\% \text{ rdg.} + 2 \text{ d})$	$\pm (10\% \text{ rdg.}+3 \text{ d})$ $\pm (5\% \text{ rdg.}+3 \text{ d})$	•	•	•	•			
		20 648.50	110	IT line units	20 kΩ 199 kΩ	IT system nomi- nal voltages	±7%	±5%							
EXTRA	IMD test	20 040 κ <b>ω</b> 2.51 ΜΩ	0.01 MΩ	U.it = 90 550 V	200 kΩ 648 kΩ 2.51 MΩ	$f_N = 50/60 \text{ Hz}$	±12% ±3%	±10% ±2%	•		•				

											Con	nectio	ns		
Func- tion	Measured Quantity	Display Range	Reso- lution	Test Current	Measuring Range	Nominal Values	Measuring Uncertainty	Intrinsic Uncertainty	Plug Insert <sup>1</sup>	2-Pole Adapter	3-Pole Adapter	WZ12C	Cla Z3512A	mp MFLEX	CP1100
		1 999 kΩ 1.00 9.99 MΩ 10.0 49.9 MΩ	1 kΩ 10 kΩ 100 kΩ			$U_N = 50 V$ $I_N = 1 mA$								F300	
		1 999 kΩ 1.00 9.99 MΩ 10.0 99.9 MΩ	1 kΩ 10 kΩ 100 kΩ	-		$\begin{array}{c} U_N = 100 \text{ V} \\ I_N = 1 \text{ mA} \end{array}$	$k\Omega$ range +(5% rdg +10D)	$k\Omega$ range $\pm(3\%$ rdg $\pm10d)$							
R <sub>INS</sub>	$\mathbf{R}_{\mathbf{INS}}$ , $\mathbf{R}_{E ISO}$	1 999 kΩ 1.00 9.99 MΩ 10.0 99.9 MΩ 100 200 MΩ	1 kΩ 10 kΩ 100 kΩ 1 MΩ	I <sub>K</sub> = 1.5 mA	50 kΩ 500 MΩ	$U_N = 250 \text{ V}$ $I_N = 1 \text{ mA}$	$\frac{1}{2}(5\% \text{ rag}.+100)$ $M\Omega \text{ range}$ $\pm(5\% \text{ rdg}.+1 \text{ d})$	$\begin{array}{llllllllllllllllllllllllllllllllllll$	•	•					
		1 999 kΩ 1.00 9.99 MΩ 10.0 99.9 MΩ 100 500 MΩ	1 kΩ 10 kΩ 100 kΩ 1 MΩ			$\begin{array}{c} U_{N} = 500 \ V \\ U_{N} = 1000 \ V \\ I_{N} = 1 \ mA \end{array}$									
	U	10 999 V– 1.00 1.19 kV	1 V 10 V		10 1.19 kV		±(3% rdg. + 1 d)	±(1.5% rdg. + 1 d)							
R <sub>LO</sub>	R <sub>LO</sub>	0.01 Ω 9.99 Ω 10.0 Ω 199.9 Ω	10 mΩ 100 mΩ	l <sub>m</sub> ≥ 200 mA I <sub>m</sub> < 200 mA	0.1 Ω 5.99 Ω 6.0 Ω 100 Ω	$U_0 = 4.5 V$	±(4% rdg. + 2 d)	$\pm$ (2% rdg. + 2 d)		•					
				Transforma- tion ratio <sup>3</sup>			5	5							
		0.0 99.9 mA 100 999 mA 1.00 9.99 A 10.0 15.0 A	0.1 mA 1 mA 0.01 A 0 1 A	1 V/A	5 15 A	$f_N = 50/60 \text{ Hz}$	$\pm$ (13% rdg.+5d) $\pm$ (13% rdg.+1d)	±(5% rdg.+4d) ±(5% rdg.+1d)	-			I 15A			
		1.00 9.99 A 10.0 99.9 A 100 150 A	0.01 A 0.1 A 1 A	1 mV/A	5 150 A	IN COROCILL	±(11% rdg.+4d) ±(11% rdg.+1d)	±(4% rdg.+3d) ±(4% rdg.+1d)	1d)         I 15A           3d)         II 150A           1d)         II 150A						
		0.0 99.9 mA 100 999 mA	0.1 mA 1 mA	1 V/A	5 1000 mA		$\pm (7\% \text{ rdg.}+2 \text{ d})$ $\pm (7\% \text{ rdg.}+1 \text{ d})$	±(5% rdg.+2 d) ±(5% rdg.+1 d)					1 A		
OLV I		0.00 9.99 A 0.00 9.99 A	0.01 A 0.01 A	100 mV/A 10 mV/A	0.05 10 A 0.5 100 A	f <sub>N</sub> = 16.7/50/60/200/	$\pm (3.4\% \text{ rdg.}+2 \text{ d})$ $\pm (3.1\% \text{ rdg.}+2 \text{ d})$ $\pm (2.1\% \text{ rdg.}+1 \text{ d})$	$\pm$ (3% rdg.+2 d) $\pm$ (3% rdg.+2 d) $\pm$ (2% rdg.+1 d)	-				10 A 100 A		
SOR 6	I <sub>L/Amp</sub>	0.00 99.9 A 0.00 9.99 A 10.0 99.9 A 100 999 A	0.1 A 0.01 A 0.1 A 1 A	1 mV/A	5 1000 A	400 Hz	$\begin{array}{c} \pm (3.1\% \text{ rdg.+1 d}) \\ \pm (3.1\% \text{ rdg.+1 d}) \\ \pm (3.1\% \text{ rdg.+2 d}) \\ \pm (3.1\% \text{ rdg.+1 d}) \end{array}$	$\begin{array}{r} \pm (3\% \text{ rdg.+1 d}) \\ \pm (3\% \text{ rdg.+1 d}) \\ \pm (3\% \text{ rdg.+2 d}) \\ \pm (3\% \text{ rdg.+1 d}) \end{array}$					1000A		
		0.0 99.9 mA 100 999 mA	0.1 mA	1 V/A	30 1000 mA		$\pm (27\% \text{ rdg.} + 100 \text{ d})$ $\pm (27\% \text{ rdg.} + 11 \text{ d})$	$\pm(3\% \text{ rdg.}+100 \text{ d})$ $\pm(3\% \text{ rdg.}+11 \text{ d})$	Plug 1       2-Pole Adapter       3-Pole Adapter       WZ12C       Z3512A         Marce 1       Adapter       Adapter       WZ12C       Z3512A         Marce 1       Marce 1       Marce 1       Marce 1       Marce 1         Marce 1       Marce 1       Marce 1       Marce 1       Marce 1         Marce 1       Marce 1       Marce 1       Marce 1       Marce 1         Marce 1       Marce 1       Marce 1       Marce 1       Marce 1         Marce 1       Marce 1       Marce 1       Marce 1       Marce 1         Marce 1       Marce 1       Marce 1       Marce 1       Marce 1         Marce 1       Marce 1       Marce 1       Marce 1       Marce 1         Marce 1       Marce 1       Marce 1       Marce 1       Marce 1         Marce 1       Marce 1       Marce 1       Marce 1       Marce 1         Marce 1       Marce 1       Marce 1       Marce 1       Marce 1       Marce 1         Marce 1       Marce 1       Marce 1       Marce 1       Marce 1       Marce 1       Marce 1         Marce 1       Marce 1       Marce 1       Marce 1       Marce 1       Marce 1       Marce 1         Marce 1	0.03 3	-				
		0.00 9.99 A	0.01 A 0.01 A	100 mV/A	0.3 10 A	f <sub>N</sub> = 50/60 Hz	$\pm (27\% \text{ rdg.} + 12 \text{ d})$ $\pm (27\% \text{ rdg.} + 11 \text{ d})$	$\pm(3\% \text{ rdg.}+12 \text{ d})$ $\pm(3\% \text{ rdg.}+11 \text{ d})$		0.3 30	-				
		0.00 9.99 A 10.0 99.9 A	0.01 A 0.1 A	10 mV/A	3 100 A	-	$\pm(27\% \text{ rdg.}+100 \text{ d})$ $\pm(27\% \text{ rdg.}+11 \text{ d})$	$\pm(3\% \text{ rdg.}+100 \text{ d})$ $\pm(3\% \text{ rdg.}+11 \text{ d})$	-					3 300	-
		0.00 9.99 A 10.0 99.9 A	0.01 A 0.1 A	10 mV/A	0.5 100 A	f <sub>N</sub> =	±(5% rdg.+12 d) ±(5% rdg.+2 d)	±(3% rdg.+12 d) ±(3% rdg.+2 d)	-						100A ~
		0.00 9.99 A 10.0 99.9 A 100 999 A	0.01 A 0.1 A 1 A	1 mV/A	5 1000 A	DC/16.7/50/60/ 200 Hz	±(5% rdg.+50 d) ±(5% rdg.+7 d) ±(5% rdg.+2 d)	±(3% rdg.+50 d) ±(3% rdg.+7 d) ±(3% rdg.+2 d)	-						1000A ~

 $\begin{array}{l} 1 \quad U > 230 \ V \ \text{with 2 or 3-pole adapter only} \\ 2 \quad 1 \cdot / 2 \cdot |\Delta N > 300 \ \text{mA and 5} \cdot |\Delta N > 500 \ \text{mA and If} > 300 \ \text{mA only up to } U_N \leq 230 \ \text{V!} \\ 3 \quad \text{The transformation ratio selected at the clamp (1 ... 1000 \ \text{mV/A}) must be set in the} \\ \text{"Type" menu with the rotary switch in the "SENSOR" position.} \end{array}$ 

<sup>4</sup> Where  $R_{Eselective}/R_{Etotal} < 100$ 

ertainties alr of the respective current clamp. 6

Measuring range of the signal input at the test instrument U<sub>E</sub>: 0 ... 1.0 V<sub>eff</sub> (0 ... 1.4 Vpeak) AC/DC Input impedance of signal input at the test instrument: 800 kΩ 7

 $^{8}$  for  $f_{N} < 45$  Hz =>  $U_{N} < 253$  V

#### Special Function MPRO, MXTRA

Funo	Maggurad		Deee	Test Current/		Macouring	Intrincio		Connections		
runc-	Quantity	Display Range	Reso-	Signal	Measuring Range	Uncortainty	Uncortainty	Adapter fo	r Test Plug	Current	Clamps
	Quantity		IULION	Frequency <sup>5</sup>	ncy <sup>5</sup> Uncertainty Uncertainty		Uncertainty	PRO-RE	PRO-RE/2	Z3512A	Z591B
	BE 3-pole	$0.00 \dots 9.99 \Omega$	0.01 Ω	16 mA/128 Hz	1.00 Ω 19.9 Ω	±(10% v.M.+10D)	±(3% v.M.+5D)				
	112, 0 polo	$10.0 99.9 \Omega$	0.1 Ω	1.6 mA/128 Hz	$5.0 \ \Omega \dots 199 \ \Omega$	+1Ω	$+ 0,5 \Omega$	6			
		$100 999 \Omega$	1Ω	0.16 mA/128 Hz	50 Ω 1.99 kΩ			0			
	RE, 4-pole	1.00 9.99 kΩ	0.01 kΩ	0.16 mA/128 Hz	$0.50$ k $\Omega \dots 19.9$ k $\Omega$	±(10% rdg.+10d)	±(3% rdg.+5d)				
		10.0 50.0 kΩ	0.1 kΩ	0.16 mA/128 Hz	$0.50$ k $\Omega \dots 49.9$ k $\Omega$						
		$0.00 \dots 9.99 \Omega$	0.01 Ω	16 mA/128 Hz							
	DE 4 polo	$10.0 99.9 \Omega$	0.1 Ω	16 mA/128 Hz							
	nE, 4-pole	$100 \dots 999 \Omega$	1Ω	1.6 mA/128 Hz	$1.00 \ \Omega \dots 9.99 \ \Omega$	±(15% rdg.+10d)	±(10% rdg.+10d)	6	9		
	Selective	1.00 9.99 kΩ	0.01 kΩ	0.16 mA/128 Hz	10.0 Ω 200 Ω	±(20% rdg.+10d)	±(15% rdg.+10d)				
	with clamp meter	10.0 19.9 k $\Omega$ <sup>15</sup>	0.1 kΩ	0.16 mA/128 Hz		10					
		10.0 49.9 k $\Omega$ $^{16}$	0.1 kΩ	0.16mA/128 Hz							
RE BAT				16 mA/128 Hz	100 Ωm 9.99 kΩm <sup>12</sup>						
	0.1	0.0 9.9 Ωm	0.1 Ωm	1.6 mA/128 Hz	500 $\Omega$ m 9.99 k $\Omega$ m $^{12}$						
	Soll resistivity	$100 \dots 999 \Omega$ m	1Ωm	0.16 mA/128 Hz	5.00 k $\Omega$ m 9.99 k $\Omega$ m <sup>13</sup>	$\pm (20\% rag. + 100)$	$\pm(12\% rag.+100)$	6			
	(p)	1.00 9.99 kΩm	0.01 kΩm	0.16 mA/128 Hz	5.00 kΩm 9.99 kΩm <sup>13</sup>						
				0.16mA/128 Hz	$5.00 \text{ k}\Omega \text{m} \dots 9.99 \text{ k}\Omega \text{m}^{-13}$						
	Probe distance d (p)	0.1 999 m									
	- (*)	0.00 9.99 Ω	0.01 Ω								
		$10.0 99.9 \Omega$	0.1 Ω		0.10 9.99 Ω	+(10% rda.+5d)	+(5% rda.+5d)		7	٥	8
	RE, 2 clamps	100 999 Ω	1Ω	30 V / 128 Hz	$10.0 \dots 99.9 \Omega$	+(20% rdg.+5d)	+(12% rda.+5d)		,	U	5
		1.00 1.99 kΩ	0.01 kΩ			(	(3	6 9 6 9 6			

5 Signal frequency without interference signal

6 PRO-RE (Z501S) adapter cable for test plug, for connecting earth probes (E-Set 3/4) 7

PRO-RE/2 (Z502T) adapter cable for test plug, for connecting the generator clamp

(E-CLIP2) 8

Generator clamp: E-CLIP2 (Z591B) Clamp meter: Z3512A (Z225A) 9

 $^{10}$  Where RE.sel/RE < 10 or clamp current > 500  $\mu$ A

 $^{11}$  Where RE.H/RE  $\leq$  100 and RE.E/RE  $\leq$  100

<sup>12</sup> Where d = 20 m

 $^{13}$  Where d = 2 m  $^{13}$  Where d = 2 m  $^{14}$  Where Z<sub>L-PE</sub> < 0.5  $\Omega$ , I<sub>k</sub> > U<sub>N</sub>/0.5  $\Omega$  is indicated  $^{15}$  Only where RANGE = 20 k $\Omega$   $^{16}$  Only where RANGE = 50 k $\Omega$  or AUTO

Key: D = digits, rdg. = measured value (reading)

# Characteristic Values PROFITEST MASTER & SECULIFE IP

 $230 V \pm 0.1\%$ 

 $50 \text{ Hz} \pm 0.1\%$ 

 $\cos \phi = 1$ 

12 V ± 0.5 V + 23 °C ± 2 K

40% ... 60%

Purely ohmic

to ground potential

 $\leq 10 \Omega$ 

45 Hz ... 65 Hz

Sine (deviation between effective

For testing potential difference

and rectified value  $\leq 0.1\%$ )

# **Reference Conditions**

Line voltage Line frequency Meas. quantity frequency Measured qty. waveform

Line impedance angle Probe resistance Supply power Ambient temperature Relative humidity Finger contact

Standing surface insulation

# Nominal Ranges of Use

Voltage U<sub>N</sub>

Frequency  $f_{\mathbf{N}}$ 

Overall voltage range U<sub>Y</sub> Overall frequency range Waveform Temperature range Supply voltage Line impedance angle Probe resistance 120 V (108 ... 132 V) 230 V (196 ... 253 V) 400 V (340 ... 440 V) 16 <sup>2</sup>/<sub>3</sub> Hz (15.4 ... 18 Hz) 50 Hz (49.5 ... 50.5 Hz) (59.4 ... 60.6 Hz) 60 Hz 200 Hz (190 ... 210 Hz) 400 Hz (380 ... 420 Hz) 65....550 V 15.4 ... 420 Hz Sine 0 °C ... + 40 °C 8 ... 12 V Corresponds to  $\cos \varphi = 1 \dots 0.95$ 

# **Power Supply**

Rechargeable batteries 8 each AA 1.5 V, we recommend eneloop type AA HR6, 2000 mAh (article no. Z502H) Number of measurements (standard setup with illumination) 1 measurement - 25 s pause: - For RINS approx. 1100 measurements – For R<sub>LO</sub> Automatic polarity reversal / 1  $\Omega$ (1 measuring cycle) - 25 s pause: approx. 1000 measurements Symbolic display of battery voltage Battery test BAT Battery saver circuit Display illumination can be switched off. The test instrument is switched off automatically after the last key operation. The user can select the desired on-time. If supply voltage is too low, the instru-Safety shutdown ment is switched off, or cannot be switched on. Recharging socket Installed rechargeable batteries can be recharged directly by connecting a charger to the recharging socket: charger for Z502R Approx. 2 hours \* Charging time

 $< 50 \text{ k}\Omega$ 

\* Maximum charging time with fully depleted rechargeable batteries. A timer in the charger limits charging time to no more than 4 hours.

# **Overload Capacity**

 $\begin{array}{l} \mathsf{R}_{\text{INS}} \\ \mathsf{U}_{\text{L-PE}}, \, \mathsf{U}_{\text{L-N}} \\ \mathsf{RCD}, \, \mathsf{R}_{\text{E}}, \, \mathsf{R}_{\text{F}} \\ \mathsf{Z}_{\text{L-PE}}, \, \mathsf{Z}_{\text{L-N}} \end{array}$ 

RIO

1200 V continuous
600 V continuous
440 V continuous
550 V (Limits the number of measurements and pause duration. If overload occurs, the instrument is switched off by means of a thermostatic switch.)
Electronic protection prevents switching on if interference voltage is present.
FF 3.15 A 10 s,
Fuses blow at > 5 A –

# **Electrical Safety**

Fine-wire fuse protection

Protection class	II per IEC 61010-1/EN 61010-1/ VDE 0411-1
Nominal voltage	230/400 V (300/500 V)
Test voltage	3.7 kV 50 Hz
Measuring category	CAT III 500 V or CAT IV 300 V
Pollution degree	2
Fusing, L and N terminals	1 cartridge fuse-link ea. FF 3.15/500G 6.3 x 32 mm

# **Electromagnetic Compatibility (EMC)**

#### Product Standard EN 61326-1:2006

Interference emission		Class
EN 55022		A
Interference immunity	Test Value	Feature
EN 61000-4-2	Contact/atmos. – 4 kV/8 kV	
EN 61000-4-3	10 V/m	
EN 61000-4-4	Mains conn. – 2 kV	
EN 61000-4-5	Mains conn. – 1 kV	
EN 61000-4-6	Mains conn. – 3 V	
EN 61000-4-11	0.5 period / 100%	

# **Ambient Conditions**

Accuracy	0 to + 40 °C
Operation	−5 + 50 °C
Storage	-20 + 60 °C (without batteries)
Relative humidity	Max. 75%, no condensation allowed
Elevation	Max. 2000 m

# **Mechanical Design**

Display	Multiple display with dot matrix 128 x 128 pixels		
Dimensions	W x L x D: 260 x 330 x 90 mm		
Weight	approx. 2.7 kg with batteries		
Protection	Housing: IP 40, test probe: IP 40 per EN 60529/DIN VDE 0470, part 1		

Excerpt from Table on the Meaning of IP Codes

IP XY	Protection Against Foreign	IP XY	Protection Against
(1 <sup>st</sup> digit X)	Object Entry	(2 <sup>nd</sup> digit Y)	Penetration by Water
4	$\geq$ 1.0 mm dia.	0	Not protected

# **Data Interfaces**

Туре	USB slave for PC connection
Туре	RS 232 for barcode and RFID scanners
Туре	Bluetooth <sup>®</sup> for connection to a PC
	(MTECH+, MXTRA & SECULIFE IP only)

#### 20 Maintenance

#### **Firmware Revision and Calibration Information** 20.1

See section 4.6.

#### 20.2 Rechargeable Battery Operation, and Charging

Check to make sure that no leakage has occurred at the rechargeable batteries at short, regular intervals, or after the instrument has been in storage for a lengthy period of time.

#### Note Note

Prior to lengthy periods of rest (e.g. holiday), we recommend removing the rechargeable batteries. This helps to prevent excessive depletion or leakage of batteries, which, under unfavourable circumstances, may cause damage to the instrument.

If battery voltage has fallen below the allowable BAT  $\infty$ lower limit, the pictograph shown at the right appears. "Low Batt!!!" is also displayed along with a battery icon. The instrument does not function if the batteries have been depleted excessively, and no display appears.

# ∕!∖

Attention!

Use only the charger Z502R to charge the Kompakt Akku-Pack Master (Z502H) which has already been inserted into the test instrument.

#### Make sure that the following conditions have been fulfilled before connecting the charger to the charging socket:

- Kompakt Akku-Pack Master (Z502H) has been installed, no commercially available battery packs, no individual rechargeable batteries, no standard batteries
- The test instrument has been disconnected from the measuring circuit at all poles
- The instrument must remain off during charging.

#### If the batteries or the battery pack (Z502H) have not been used or recharged for a lengthy period of time (> one month), thus resulting in excessive depletion:

Observe the charging sequence (indicated by LEDs at the charger) and initiate a second charging sequence if necessary (disconnect the charger from the mains and from the test instrument to this end, and then reconnect it). Please note that the system clock stops in this case and must be set to the correct time after the instrument has been restarted.

## 20.2.1 Charging Procedure with Charger for Z502R

Insert the correct mains plug for your country into the charger.

#### /!\ Attention!

Make sure that Kompakt Akku Pack Master (Z502H) has been inserted, no battery holder.

#### For charging in the tester, only use Kompakt Akku Pack Master (Z502H), which is either included in the standard equipment or available as an accessory, with heat-sealed battery cells.

Connect the charger to the test instrument with the jack plug, and then to the 230 V mains with the interchangeable plug. (The charger is suitable for mains operation only!)

# Attention!

∕!∖

Do not switch the test instrument on during charging. Monitoring of the charging process by the microprocessor might otherwise be disturbed, in which case the charging times specified in the technical data can no longer be assured.

- Please refer to the operating instructions included with the charger regarding the meanings of LED displays during the charging process.
- Do not disconnect the charger from the test instrument until the green LED (charged/ready) lights up.

# 20.3 Fuses

If a fuse has blown due to overload, a corresponding message error appears at the display panel. The instrument's voltage measuring ranges are nevertheless still functional.

## **Replacing the Fuse**

#### ∕!∖ Attention!

Disconnect the device from the measuring circuit at all poles before opening the fuse compartment lid!

- $\Box$ Loosen the slotted screws at the fuse compartment lid next to the mains power cable with a screwdriver. The fuses are now accessible.
- Replacement fuses can be accessed after opening the battery  $\Box$ compartment lid.

#### ∕!∖ Attention!

Severe damage to the instrument may occur if incorrect fuses are used.

Only original fuses from GMC-I Messtechnik GmbH may be used (order no. 3-578-285-01 / SIBA 7012540.3.15 SI-EINSATZ FF 3.15/500 6.3X32).

Only original fuses assure required protection by means of suitable blowing characteristics. Short-circuiting of fuse terminals or the repair of fuses is prohibited, and is life endangering!

The instrument may be damaged if fuses with incorrect ampere ratings, breaking capacities or blowing characteristics are used!

- Remove the defective fuse and insert a new one.  $\Box$
- $\Box$ Insert the fuse compartment lid after the fuse has been replaced and secure it by turning clockwise.

## 20.4 Housing

No special maintenance is required for the housing. Keep outside surfaces clean. Use a slightly dampened cloth for cleaning. In particular for the protective rubber surfaces, we recommend a moist, lint-free microfiber cloth. Avoid the use of cleansers, abrasives or solvents.

## **Return and Environmentally Sound Disposal**

The instrument is a category 9 product (monitoring and control instrument) in accordance with ElektroG (German electrical and electronic device law). This device is subject to the RoHS directive. Furthermore, we make reference to the fact that the current status in this regard can be accessed on the Internet at

www.gossenmetrawatt.com by entering the search term WEEE.

In accordance with WEEE 2012/19EU and ElektroG, we identify our electrical and electronic devices with the symbol in accordance with DIN EN 50419 which is shown at the right. Devices identified with this symbol may not be disposed of with the trash. Please contact our service department regarding the return of old devices (see address in section 22).

If the (rechargeable) batteries used in your instrument are depleted, they must be disposed of properly in accordance with valid national regulations.

Batteries may contain pollutants and heavy metals such as lead (Pb), cadmium (Cd) and mercury (Hg).

The symbol to the right indicates that batteries must not be disposed of with the trash, and must be brought to a designated collection point.



# 21 Appendix

# 21.1 Tables for the determination of maximum or minimum display values under consideration of maximum measuring uncertainty:

# Table 1

Z <sub>L-PE.</sub> (ful	l wave) / Z <sub>L-N</sub> (Ω)	Z <sub>L-PE.</sub> (+/- half-wave) (Ω)			
Limit Value	Max. Dis- play Value	Limit Value	Max. Dis- play Value		
0.10	0.07	0.10	0.05		
0.15	0.11	0.15	0.10		
0.20	0.16	0.20	0.14		
0.25	0.20	0.25	0.18		
0.30	0.25	0.30	0.22		
0.35	0.30	0.35	0.27		
0.40	0.34	0.40	0.31		
0.45	0.39	0.45	0.35		
0.50	0.43	0.50	0.39		
0.60	0.51	0.60	0.48		
0.70	0.60	0.70	0.56		
0.80	0.70	0.80	0.65		
0.90	0.79	0.90	0.73		
1.00	0.88	1.00	0.82		
1.50	1.40	1.50	1.33		
2.00	1.87	2.00	1.79		
2.50	2.35	2.50	2.24		
3.00	2.82	3.00	2.70		
3.50	3.30	3.50	3.15		
4.00	3.78	4.00	3.60		
4.50	4.25	4.50	4.06		
5.00	4.73	5.00	4.51		
6.00	5.68	6.00	5.42		
7.00	6.63	7.00	6.33		
8.00	7.59	8.00	7.24		
9.00	8.54	9.00	8.15		
9.99	9.48	9.99	9.05		

#### Table 3

	R <sub>INS</sub>	MΩ	
Limit Value	Min. Dis- play Value	Limit Value	Min. Dis- play Value
0.10	0.12	10.0	10.7
0.15	0.17	15.0	15.9
0.20	0.23	20.0	21.2
0.25	0.28	25.0	26.5
0.30	0.33	30.0	31.7
0.35	0.38	35.0	37.0
0.40	0.44	40.0	42.3
0.45	0.49	45.0	47.5
0.50	0.54	50.0	52.8
0.55	0.59	60.0	63.3
0.60	0.65	70.0	73.8
0.70	0.75	80.0	84.4
0.80	0.86	90.0	94.9
0.90	0.96	100	106
1.00	1.07	150	158
1.50	1.59	200	211
2.00	2.12	250	264
2.50	2.65	300	316
3.00	3.17		
3.50	3.70		
4.00	4.23		
4.50	4.75		
5.00	5.28		
6.00	6.33		
7.00	7.38		
8.00	8.44		
9.00	9.49		

## Table 2

	R <sub>E</sub> / R <sub>ELoop</sub> (Ω)								
Limit Value	Max. Dis- play Value	Limit Value	Max. Dis- play Value	Limit Value	Max. Dis- play Value				
0.10	0.07	10.0	9.49	1.00 k	906				
0.15	0.11	15.0	13.6	1.50 k	1.36 k				
0.20	0.16	20.0	18.1	2.00 k	1.81 k				
0.25	0.20	25.0	22.7	2.50 k	2.27 k				
0.30	0.25	30.0	27.2	3.00 k	2.72 k				
0.35	0.30	35.0	31.7	3.50 k	3.17 k				
0.40	0.34	40.0	36.3	4.00 k	3.63 k				
0.45	0.39	45.0	40.8	4.50 k	4.08 k				
0.50	0.43	50.0	45.4	5.00 k	4.54 k				
0.60	0.51	60.0	54.5	6.00 k	5.45 k				
0.70	0.60	70.0	63.6	7.00 k	6.36 k				
0.80	0.70	80.0	72.7	8.00 k	7.27 k				
0.90	0.79	90.0	81.7	9.00 k	8.17 k				
1.00	0.88	100	90.8	9.99 k	9.08 k				
1.50	1.40	150	133						
2.00	1.87	200	179						
2.50	2.35	250	224						
3.00	2.82	300	270						
3.50	3.30	350	315						
4.00	3.78	400	360						
4.50	4.25	450	406						
5.00	4.73	500	451						
6.00	5.68	600	542						
7.00	6.63	700	633						
8.00	7.59	800	724						
9.00	8.54	900	815						

# Table 4

R <sub>L0</sub> Ω							
Limit Value	Max. Dis- play Value	Limit Value	Max. Dis- play Value				
0.10	0.07	10.0	9.59				
0.15	0.12	15.0	14.4				
0.20	0.17	20.0	19.2				
0.25	0.22	25.0	24.0				
0.30	0.26	30.0	28.8				
0.35	0.31	35.0	33.6				
0.40	0.36	40.0	38.4				
0.45	0.41	45.0	43.2				
0.50	0.46	50.0	48.0				
0.60	0.55	60.0	57.6				
0.70	0.65	70.0	67.2				
0.80	0.75	80.0	76.9				
0.90	0.84	90.0	86.5				
1.00	0.94	99.9	96.0				
1.50	1.42						
2.00	1.90						
2.50	2.38						
3.00	2.86						
3.50	3.34						
4.00	3.82						
4.50	4.30						
5.00	4.78						
6.00	5.75						
7.00	6.71						
8.00	7.67						
9.00	8.63						

#### Table 5

Z <sub>ST</sub> kΩ					
Limit Value	Min. Dis- play Value				
10	14				
15	19				
20	25				
25	30				
30	36				
35	42				
40	47				
45	53				
50	58				
56	65				
60	69				
70	80				
80	92				
90	103				
100	114				
150	169				
200	253				
250	315				
300	378				
350	440				
400	503				
450	565				
500	628				
600	753				
700	878				
800	>999				

## Table 6

Short-Circuit Current Minimum Display Values for the determination of nominal current for various fuses and breakers for systems with nominal voltage of  $U_N = 230 \text{ V}$ 

Nominal Current I <sub>N</sub>	per DI	Low Resist N VDE 0636	tance Fuses series of stan	lards	With Circuit Breaker and Line Switch							
[A]		Characterist	ic gL, gG, gM		Characte (form	Characteristic B/E Characteristic C (formerly L) (formerly G, U)		eristic C ly G, U)	Characteristic D		Characteristic K	
	Breaking Cu	ırrent I <sub>A</sub> 5 s	Breaking Cur	rent I <sub>A</sub> 0.4 s	Breaking 5 x I <sub>N</sub> (< 0	Current I <sub>A</sub> .2 s/0.4 s)	Breaking 10 x I <sub>N</sub> (< 0	Current I <sub>A</sub> ).2 s/0.4 s)	Breaking 20 x I <sub>N</sub> (< 0	Current I <sub>A</sub> ).2 s/0.4 s)	Breaking 12 x I <sub>N</sub> (	Current I <sub>A</sub> (< 0.1 s)
	Limit Value [A]	Min. Display [A]	Limit Value [A]	Min. Display [A]	Limit Value [A]	Min. Display [A]	Limit Value [A]	Min. Display [A]	Limit Value [A]	Min. Display [A]	Limit Value [A]	Min. Display [A]
2	9.2	10	16	17	10	11	20	21	40	42	24	25
3	14.1	15	24	25	15	16	30	32	60	64	36	38
4	19	20	32	34	20	21	40	42	80	85	48	51
6	27	28	47	50	30	32	60	64	120	128	72	76
8	37	39	65	69	40	42	80	85	160	172	96	102
10	47	50	82	87	50	53	100	106	200	216	120	128
13	56	59	98	104	65	69	130	139	260	297	156	167
16	65	69	107	114	80	85	160	172	320	369	192	207
20	85	90	145	155	100	106	200	216	400	467	240	273
25	110	117	180	194	125	134	250	285	500	578	300	345
32	150	161	265	303	160	172	320	369	640	750	384	447
35	173	186	295	339	175	188	350	405	700	825	420	492
40	190	205	310	357	200	216	400	467	800	953	480	553
50	260	297	460	529	250	285	500	578	1000	1.22 k	600	700
63	320	369	550	639	315	363	630	737	1260	1.58 k	756	896
80	440	517									960	1.16 k
100	580	675									1200	1.49 k
125	750	889									1440	1.84 k
160	930	1.12 k									1920	2.59 k

# Example

Display value 90.4 A  $\rightarrow$  next smaller value for circuit breaker characteristic B from table: 85 A  $\rightarrow$  protective device nominal current (I<sub>N</sub>) max. 16 A

#### 21.2 At which values should/must an RCD actually be tripped? Requirements for Residual Current Devices (RCDs)

#### **General Requirements**

- Tripping must occur no later than upon occurrence of rated residual current (nominal differential current  $I_{\Delta N}).$  and
- Maximum time to trip may not be exceeded.

Additional requirements due to influences on the tripping current range and the point in time of tripping which have to be taken into consideration:

- Residual current type or waveform: This results in a reliable tripping current range.
- Mains type and line voltage: This results in maximum tripping time.
- RCD variant (standard or selective): This results in maximum tripping time.

## Definitions of Requirements in the Standards

**VDE 0100, part 600**, which is included in all German standards collections for **electricians**, applies to measurements in electrical systems. It plainly states: "The effectiveness of the protective measure is substantiated when shut-down occurs no later than upon occurrence of rated differential current  $I_{\Delta N}$ ."

# As a requirement for the **measuring instrument manufacturer**, **DIN EN 61557-6 (VDE 0413, part 6)** unmistakably specifies:

"The measuring instrument must be capable of substantiating the fact that the residual current which trips the residual current device (RCD) is less than or equal to rated residual current."

## Comment

For all electricians, this means that during scheduled protective measures testing after system modifications or additions to the system, as well as after repairs or during the E-check conducted after measurement of contact voltage, the trip test must be conducted no later than upon reaching a value of, depending upon the RCD, 10, 30, 100, 300 or 500 mA

How does the electrician react in the event that these values are exceeded? The RCD is replaced!

If it was relatively new, a complaint is submitted to the manufacturer. And in his laboratory he determines: The RCD complies with the manufacturer's standard and is OK.

A look at the VDE 0664-10/-20/-100/-200 manufacturer's standard shows us why:

Type of Residual Current	Residual Current Waveform	Allowable Tripping Current Range
Sinusoidal alternating current	$\sim$	0.5 1 I <sub>ΔN</sub>
Pulsating direct current (positive or negative half-waves)	$\mathfrak{K}$	0.35 1.4 I <sub>ΔN</sub>
Phase angle controlled half-wave currents Phase angle of 90° el Phase angle of 135° el		0.25 1.4 Ι <sub>ΔΝ</sub> 0.11 1.4 Ι <sub>ΔΝ</sub>
Pulsating direct current superimposed with 6 mA smooth, direct residual current	$\mathbf{\nabla}$	Max. 1.4 I <sub>ΔN</sub> + 6 mA
Smooth direct current		0.5 2 I <sub>ΔN</sub>

Because the current waveform plays a significant role, the current waveform used by the test instrument is also important.

Set residual current type or waveform at the test instrument:



It's important to be able to select and take advantage of the corresponding settings at one's own test instrument.

The situation is similar for breaking times. The new **VDE 0100 part 410**, should also be included in the standards collection. Depending upon mains type and line voltage, it specifies breaking times ranging from 0.1 to 5 seconds.

System 50 V < $U_0 \le 120$ V		120 V < U_0 $\le$ 230 V		230 V < ${\rm U_0}{\leq}400$ V		$U_0 > 400 V$		
System	AC	DC	AC	DC	AC	DC	AC	DC
TN	0.8 s		0.4 s	5 s	0.2 s	0.4 s	0.1 s	0.1 s
Π	0.3 s		0.2 s	0.4 s	0.07 s	0.2 s	0.04 s	0.1 s

RCDs usually interrupt more quickly, but in some cases they can take a bit longer. Once again, the ball is in the manufacturer's court.

The following table is also included in VDE 0664:

Variant	Residual Current Type	Breaking Time at					
	Alternating residual current	1 x I <sub>AN</sub>	2 x I <sub>AN</sub>	5 x I <sub>AN</sub>	500 A		
	Pulsating direct residual current	1.4 х I <sub>дN</sub>	2 x 1.4 x I <sub>ΔN</sub>	5 x 1.4 x Ι <sub>ΔΝ</sub>	500 A		
	Smooth, direct residual current	2 x I <sub>AN</sub>	2 x 2 x I <sub>ΔN</sub>	5 x 2 x Ι <sub>ΔΝ</sub>	500 A		
Standard (undelayed) or briefly delayed		300 ms	Max. 0.15 s	Max. 0.04 s	Max. 0.04 s		
Selective		0.13 0.5 s	0.06 0.2 s	0.05 0.15 s	0.04 0.15 s		

Two limit values are highly conspicuous:

Standard	Max. 0.3 s
Selective	Max. 0.5 s

All of the limit values are already included in good test instruments, or it's possible to enter them directly and they're displayed as well!

Select or set limit values at the test instrument:





Tests for electrical systems include "visual inspection", "testing" and "measurement", and thus may only be conducted by experts with appropriate work experience.

In the final analysis, the values from VDE 0664 are technically binding.

#### 21.3 Testing Electrical Machines per DIN EN 60204 – Applications, Limit Values

The **PROFITEST 204+** test instrument has been developed for the testing of electrical machines and controllers. After a revision to the standard in 2007, measurement of loop impedance is now additionally required. Measurement of loop impedance, as well as other measurements required for the testing of electrical machines, can be performed with test instruments from the **PROFITEST MASTER** series.

#### Comparison of Tests Specified by the Standards

Tests per DIN EN 60204, part 1 (machines)	Tests per DIN EN 61557 (systems)	Meas. Func- tion
Uninterrupted connection of a protective conductor	Part 4: resistance of: – Ground conductor – Protective conductor – Bonding conductor	RLO
Loop impedance	Part 3: loop impedance	ZL-PE
Insulation resistance	Part 2: insulation resistance	RINS
Voltage test (test for absence of voltage)	—	—
Voltage measurement (protec- tion against residual voltage)	Part 10: Combined measuring equipment (amongst others for volt- age measurement) for testing, mea- suring or monitoring of protective measures	U
Function test		_

## Uninterrupted Connection of a Protective Conductor

Uninterrupted connection of a protective conductor system is tested here be using an alternating current of 0.2 to 10 A with a line frequency of 50 Hz (= low-resistance measurement). Testing must be conducted between the PE terminal and various points within the protective conductor system.

#### Loop Impedance Measurement

Loop impedance  $Z_{L\text{-PE}}$  is measured and short-circuit current  $I_K$  is ascertained in order to determine if the breaking requirements for protective devices have been fulfilled (see section 8).

#### **Insulation Resistance Measurement**

All of the active conductors in the primary circuit are short-circuited at the machine (L and N, or L1, L2, L3 and N) and measured against PE (protective conductor). Controllers or machine components which are not laid out for these voltages (500 V DC) can be disconnected from the measuring circuit for the duration of the measurement. The measured value may not be any less than 1 MOhm. The test can be subdivided into separate segments.

## Voltage Tests (with PROFITEST 204HP/HV only)

The electrical equipment of the machine under test must withstand a test voltage of twice its own rated voltage value or 1000 V~ (whichever is largest) applied between the conductors of all circuits and the protective conductor system for a period of at least 1 second. The test voltage must have a frequency of 50 Hz, and must be generated by a transformer with a minimum power rating of 500 VA.

## Voltage Measurement

The EN 60204 standard specifies that after switching supply power off, residual voltage must drop to a value of 60 V or less within 5 seconds at all accessible, active components of a machine to which a voltage of greater that 60 V is applied during operation.

## **Function Test**

The machine is operated with nominal voltage and tested for correct functioning, in particular with regard to safety functions.

#### **Special Tests**

- Pulse control mode for troubleshooting (with PROFITEST 204HP/HV only)
- Protective conductor test with 10 A test current (with PROFITEST 204+ only)

#### Limit Values per DIN EN 60204, Part 1

Measurement	Parameter	Cross- Section	Standard Value
	Test Duration		10 s
Protective conduc- tor measurement	Limit value for protective conductor resistance based on phase conductor cross-section and charac- teristics of the overvoltage protection device (calcu- lated value)	1.5 mm <sup>2</sup> 2.5 mm <sup>2</sup> 4.0 mm <sup>2</sup> 6.0 mm <sup>2</sup> 10 mm <sup>2</sup> 25 mm <sup>2</sup> L (16 mm <sup>2</sup> PE) 35 mm <sup>2</sup> L (16 mm <sup>2</sup> PE) 50 mm <sup>2</sup> L (25 mm <sup>2</sup> PE) 70 mm <sup>2</sup> L (35 mm <sup>2</sup> PE) 95 mm <sup>2</sup> L (50 mm <sup>2</sup> PE) 120 mm <sup>2</sup> L (70 mm <sup>2</sup> PE)	500 mΩ 500 mΩ 500 mΩ 400 mΩ 200 mΩ 200 mΩ 100 mΩ 100 mΩ 100 mΩ 050 mΩ
Insulation resistance	Nominal voltage		500 V DC
measurement	Resistance limit value		$\geq 1 \ \text{M}\Omega$
Leakage current measurement	Leakage current		2.0 mA
Voltage measure- ment	Discharge time		5 s
	Test duration		1 s
Voltage test	Test voltage		$\geq$ 1 kV or 2 U <sub>N</sub>

#### Overvoltage Protection Device Characteristics for Limit Value Selection for Protective Conductor Testing

Breaking Time, Characteristics	Available for Cross-Section
Fuse breaking time: 5 s	All cross-sections
Fuse breaking time: 0.4 s	1.5 through 16 sq. mm
Circuit breaker, characteristic B la = 5 x ln – breaking time: $0.1s$	1.5 through 16 sq. mm
Circuit breaker, characteristic C la = $10x \ln - breaking time: 0.1s$	1.5 through 16 sq. mm
Adjustable circuit breaker la = 8 x ln - break time: $0.1s$	All cross-sections

#### 21.4 Periodic Testing per DGUV provision 3 (previously BGV A3) - Limit Values for **Electrical Systems and Operating Equipment**

## Limit Values per DIN VDE 0701-0702

Maximum Allowable Limit Values for Protective Conductor Resistance for Connector Cables with Lengths of up to 5 m

Test Standard	Test Current	Open-Circuit Voltage	R <sub>SL</sub> Housing – Mains Plug
VDE 0701-0702:2008	> 200 mA <del></del>	4 V < U <sub>L</sub> < 24 V	$\begin{array}{c} 0.3 \ \Omega \ ^{1} \\ + \ 0.1 \ \Omega \ ^{2} \\ \text{for each} \\ \text{additional 7.5 m} \end{array}$

This value may not exceed 1 Ω for permanently connected data processing systems (DIN VDE 0701-0702).
 <sup>2</sup> Total protective conductor resistance of max. 1 Ω

#### Minimum Allowable Limit Values for Insulation Resistance

Test	Test	RINS					
Standard	Voltage	PC I	PC II	PC III	Heating		
VDE 0701- 0702:2008	500 V	1 MΩ	2 MΩ	$0.25~\text{M}\Omega$	0.3 MΩ *		

With activated heating elements (if heating power > 3.5 kW and RINS < 0.3 M\Omega: leakage current measurement is required)

#### Maximum Allowable Limit Values for Leakage Current in mA

			<u> </u>			
Test Standard	I <sub>PE</sub>	I <sub>C</sub>	I <sub>DI</sub>			
VDE 0701-0702:200	8 SC I: 3.5 1 mA/kW *	0.5	SC I: 3.5 1 mA/ kW * SC II: 0.5			
* For devices with h	eating power of greater	than	3.5 kW	•		
Note 1: Devices which are not equipped with accessible parts that are connected to the protective conductor, and which comply with re- quirements for housing leakage current and, if applicable, patient leakage current, e.g. computer equipment with shielded power pack						
Note 2: Pe Note 3: Po	rmanently connected or rtable x-ray devices with the second se	levice: th min	s with pro eral insula	ntective conductor ation		

#### Key

1

\*

- Ι<sub>Β</sub> Housing leakage current (probe or contact current)
- IDI Residual current
- IsL Protective conductor current

Maximum Allowable Limit Values for Equivalent Leakage Current in mΑ

Test Standard	I <sub>EL</sub>	
VDE 0701-0702:2008	SC I: 3.5 1 mA/kW <sup>1</sup> SC II: 0.5	

For devices with heating power ≥ 3.5 kW

# 21.5 List of Abbreviations and their Meanings

# RCCBs (residual current devices / RCDs)

- $I_{\Delta}$  Tripping current
- $I_{\Delta N}$  Nominal residual current
- IF\_ Rising test current (residual current)
- PRCD Portable residual current device PRCD-S: with protective conductor detection and monitoring PRCD-K: with undervoltage trigger and protective conductor monitoring
- RCD-S Selective RCCB
- R<sub>E</sub> Calculated earthing or earth electrode loop resistance
- SRCD Socket residual current device (permanently installed)
- t<sub>a</sub> Time to trip / breaking time
- $U_{I\Delta}$  Contact voltage at moment of tripping
- UIAN Contact voltage
- relative to nominal residual current  $\mathsf{I}_{\Delta \mathbf{N}}$
- UL Contact voltage limit value

## **Overcurrent Protective Devices**

- I<sub>K</sub> Calculated short-circuit current (at nominal voltage)
- Z<sub>L-N</sub> Line impedance
- Z<sub>L-PE</sub> Loop impedance

## Earthing

- $R_B$  Operational earth resistance
- R<sub>E</sub> Measured earthing resistance
- R<sub>ELoop</sub> Earth electrode loop resistance

## Low-Value Resistance at

## Protective, Earthing and Bonding Conductors

- $R_{LO+}$  Bonding conductor resistance (+ pole to PE)
- R<sub>LO-</sub> Bonding conductor resistance (– pole to PE)

## Insulation

- $R_{E(ISO)}$  Earth leakage resistance (DIN 51953)
- R<sub>INS</sub> Insulation resistance
- R<sub>ST</sub> Standing surface insulation resistance
- Z<sub>ST</sub> Standing surface insulation impedance

#### Current

- I<sub>A</sub> Breaking current
- I<sub>L</sub> Leakage current (measured with current clamp transformer)
- I<sub>M</sub> Measuring current
- I<sub>N</sub> Nominal current
- I<sub>P</sub> Test current

#### Voltage

- f Line voltage frequency
- f<sub>N</sub> Nominal voltage rated frequency
- $\Delta U$  Voltage drop as %
- U Voltage measured at the test probes during and after insulation measurement R<sub>INS</sub>
- U<sub>Batt</sub> Battery voltage
- U<sub>E</sub> Earth electrode voltage
- $U_{\text{INS}}$   $\ \ \,$  For measurement of  $R_{\text{INS}}$ : test voltage, for ramp function: triggering or breakdown voltage
- U<sub>L-L</sub> Voltage between two phase conductors
- $U_{L\text{-}N}$   $\,$  Voltage between L and N  $\,$
- $U_{L-PE}$  Voltage between L and PE
- U<sub>N</sub> Nominal line voltage
- U<sub>3~</sub> Highest measured voltage during determination of phase sequence
- ${\rm U}_{\rm S-PE}~$  Voltage between probe and PE
- U<sub>Y</sub> Conductor voltage to earth

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PRCD

Μ

Ν

0 On-Time

Ρ

Memory

# 21.7 Bibliography

Statutory Source Documents				
German occupational safety legislation (BetrSichV) Regulations issued by the accident insurance carriers				
Title	Information Rule / Regulation	Publisher	lssue / Order No.	
Betriebs Sicherheits Verordnung (BetrSichV)	BetrSichV			
Elektrische Anlagen und Betriebsmittel	DGUV provision 3 (up to now BGV A3)	DGUV (up to now HVBG)	2005	

#### **VDE Standards** German standard Date of Publisher Title Issue DIN VDE 2007-06 Beuth-Verlag Protection against electric 0100-410 shock GmbH Erection of low-voltage DIN VDE Beuth-Verlag 2011-06 0100-530 installations GmbH Part 530: Selection and erection of electrical equipment - Switchgear and controlgear DIN VDE Erection of low-voltage 2008-06 Beuth-Verlag 0100-600 installations GmbH Part 6: Tests Devices for testing, measur-Series of standards 2006-08 Beuth-Verlag ing or monitoring protective DIN EN 61557 GmbH measures DIN VDE Operation of electrical 2009-10 Beuth-Verlag 0105-100 installations, part 100: GmbH General requirements VDE 0122-1 Electric vehicle conductive 2013-04 Beuth-Verlag DIN EN 61851-1 charging system - Part 1: GmbH General requirements (IEC 69/219/CD:2012)

#### 21.7.1 Internet Addresses for Additional Information

Internet Address	
www.dguv.de	GUV information, rules and regulations from Deutsche Gesetzliche Unfallversicherung e.V.
www.beuth.de	VDE regulations, DIN standards, VDI directives from Beuth-Verlag GmbH
www.bgetf.de	BG information, rules and regulations from gewerbli- che Berufsgenossenschaften e.g. BG ETEM (trade as- sociation for energy, textiles, electrical, Medienerzeug- nisse)

# 22 Repair and Replacement Parts Service Calibration Center\* and Rental Instrument Service

If required please contact:

#### GMC-I Service GmbH Service-Center Thomas-Mann-Strasse 16-20 90471 Nürnberg, Germany Phone: +49 911 817718-0 Fax: +49 911 817718-253 E-mail service@gossenmetrawatt.com www.gmci-service.com

This address is only valid in Germany. Please contact our representatives or subsidiaries for service in other countries.

\* DAkkS Calibration Laboratory for Electrical Quantities D-K-15080-01-01 accredited per DIN EN ISO/IEC 17025:2005

Accredited quantities: direct voltage, direct current value, direct current resistance, alternating voltage, alternating current value, AC active power, AC apparent power, DC power, capacitance, frequency and temperature

#### **Competent Partner**

GMC-I Messtechnik GmbH is certified in accordance with DIN EN ISO 9001:2008.

Our DAkkS calibration laboratory is accredited by the Deutsche Akkreditierungsstelle GmbH (German accreditation body) under registration number D-K-15080-01-01 in accordance with DIN EN ISO/IEC 17025:2005.

We offer a complete range of expertise in the field of metrology: from test reports and proprietary calibration certificates right on up to DAkkS calibration certificates.

Our spectrum of offerings is rounded out with free test equipment management.

An **on-site DAkkS calibration station** is an integral part of our service department. If errors are discovered during calibration, our specialized personnel are capable of completing repairs using original replacement parts.

As a full service calibration laboratory, we can calibrate instruments from other manufacturers as well.

# 23 Recalibration

The measuring tasks performed with your instrument, and the stressing it's subjected to, influence aging of its components and may result in deviation from the specified levels of accuracy.

In the case of strict measuring accuracy requirements, as well as in the event of use at construction sites with frequent stress due to transport and considerable temperature fluctuation, we recommend a relatively short calibration interval of once per year. If your instrument is used primarily in the laboratory and indoors without considerable climatic or mechanical stressing, a calibration interval of once every 2 to 3 years is sufficient as a rule.

During recalibration at an accredited calibration laboratory (DIN EN ISO/IEC 17025), deviations from traceable standards demonstrated by your measuring instrument are documented. Ascertained deviations are used to correct displayed values during later use of the instrument.

We would be happy to perform DAkkS or factory calibration for you at our calibration laboratory. Further information is available at our website:

www.gossenmetrawatt.com ( $\rightarrow$  Company  $\rightarrow$  DAkkS Calibration Center or  $\rightarrow$  FAQs  $\rightarrow$  Questions and Answers Regarding Calibration).

Recalibration of your instrument at regular intervals is essential for the fulfillment of requirements according to quality management systems per DIN EN ISO 9001.

Examination of the specification, as well as adjustment, are not included in calibration. However, in the case of our own products, any required adjustment is performed and adherence to the specification is confirmed.

# 24 Product Support

If required please contact:

GMC-I Messtechnik GmbH

Product Sup	port Hotline
Phone:	+49-911 8602-0
Fax:	+49 911 8602-709
E-mail:	support@gossenmetrawatt.com

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GMC-I Messtechnik GmbH Südwestpark 15 90449 Nürnberg • Germany Phone: +49 911 8602-111 Fax: +49 911 8602-777 e-mail: info@gossenmetrawatt.com www.gossenmetrawatt.com